

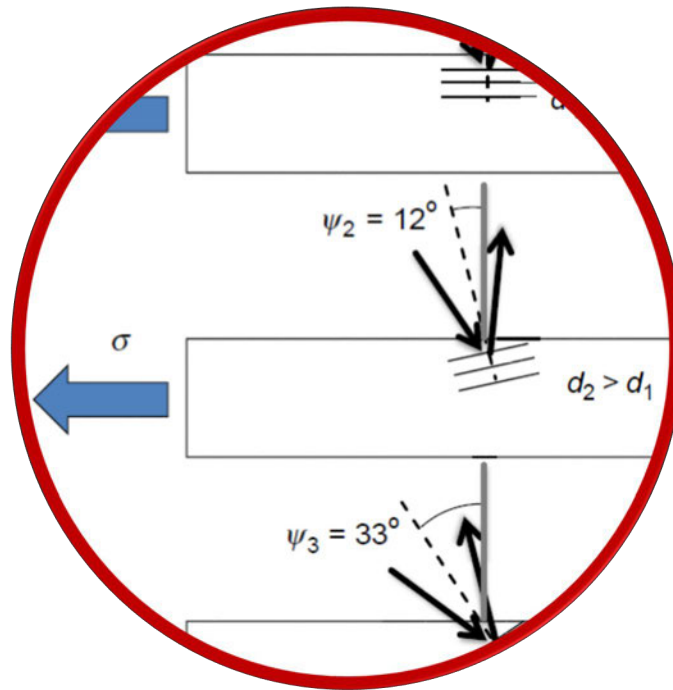
# Disclaimer

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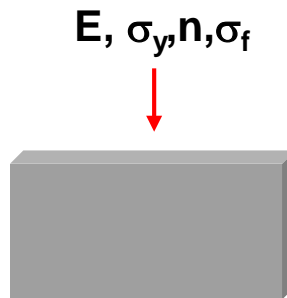
## Ch. 5: Size effects





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# Length scale effects in metal plasticity



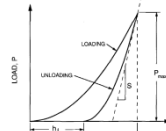
*„You don't have to be  
small to be strong - just thin“*

# seminal work in small scale mechanics

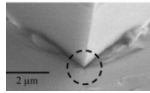
Hall 1951, Petch 1953



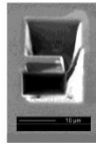
Pharr, J. Mater. Res. 1992



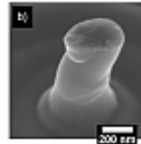
Rabe, Thin Solid Films, 2003



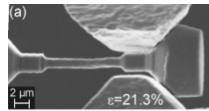
Maio, J. Mater. Res, 2005



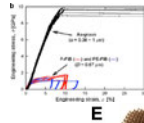
Oestlund, Adv. Func., Mater, 2006



Kiener, Acta Mat, 2008



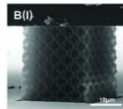
Pharr, Acta Mat 2008



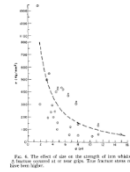
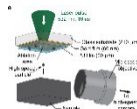
Schaedler, Science, 2011



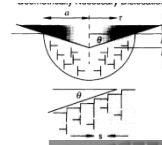
Meza, Science, 2014



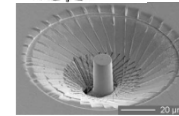
Gangaraj. Nature Com, 2018



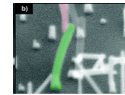
Brenner, J. Appl. Phys. 1956



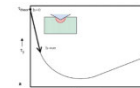
Nix, Met Trans A, 1989



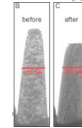
Uchic, Science 2004



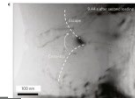
Hoffmann, Nanoletters, 2005



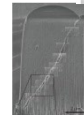
Lilleoden, Acta Mat, 2006



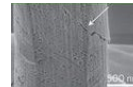
Minor, Nature Materials, 2008



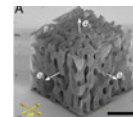
Oh, Nature Materials, 2009



Schwiedrzik, Nature Materials 2014



Tertuliano, Nature Materials, 2015



Portela, PNAS, 2020

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MINIATURE SAMPLE  
NANO TESTING



# seminal work in small scale mechanics

Hall 1951, Petch 1953



Pharr, J. Mater. Res. 1992

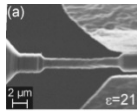
Rabe, Thin Solid Films, 2003



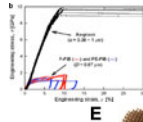
Maio, J. Mater. Res, 2005



Oestlund, Adv. Func., Mater, 2006



Kiener, Acta Mat, 2008

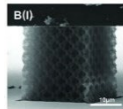


Pharr, Acta Mat 2008

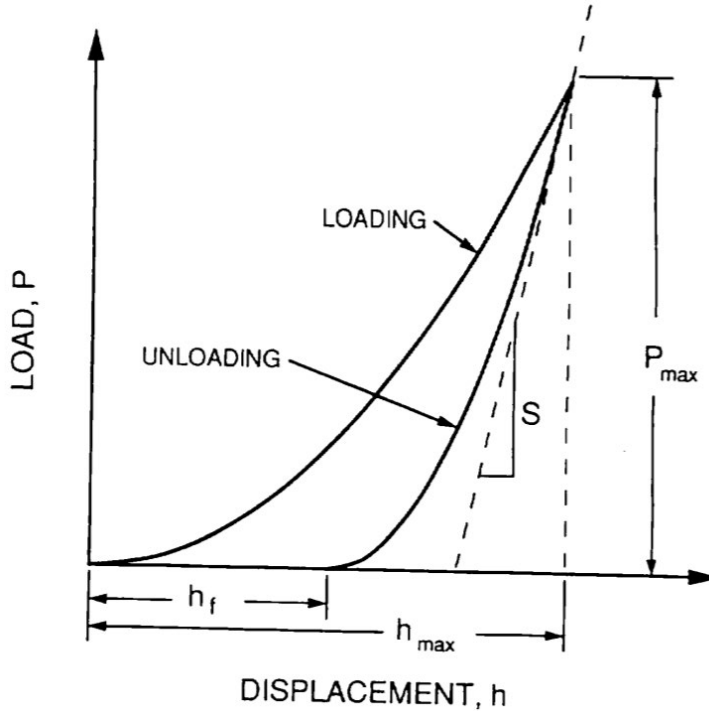
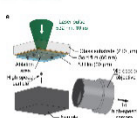
Schaedler, Science, 2011



Meza, Science, 2014



Gangaraj. Nature Com, 2018



ipl. Phys. 1956

Trans A, 1989

Science 2004

Letters, 2005

Acta Mat, 2006

Materials, 2008

Oh, Nature Materials, 2009

Schwiedrzik, Nature Materials 2014

Tertuliano, Nature Materials, 2015

Portela, PNAS, 2020

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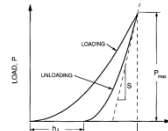


# seminal work in small scale mechanics

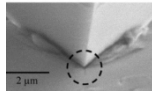
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Oestlund, Adv. Func

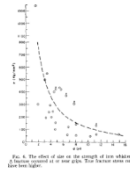
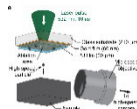
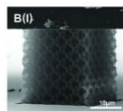
Kiener, Acta Mat, 2

Pharr, Acta Mat 20

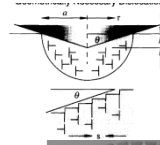
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Meza, Science, 2014

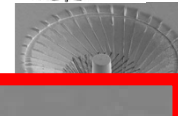
Gangaraj. Nature Com, 2018



Brenner, J. Appl. Phys. 1956



Nix, Met Trans A, 1989



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den , Acta Mat, 2006

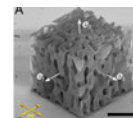
ature Materials, 2008

ature Materials, 2009

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Portela, PNAS, 2020



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IN-SITU  
MICRO- SAMPLE

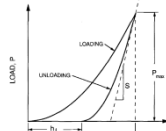


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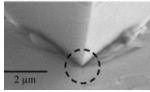
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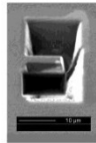
Pharr, J. Mater. Res. 1992



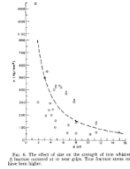
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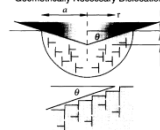
Maio, J. Mater. Res, 2005



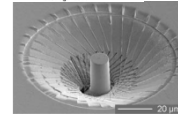
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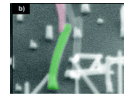
Brenner, J. Appl. Phys. 1956



Nix, Met Trans A, 1989

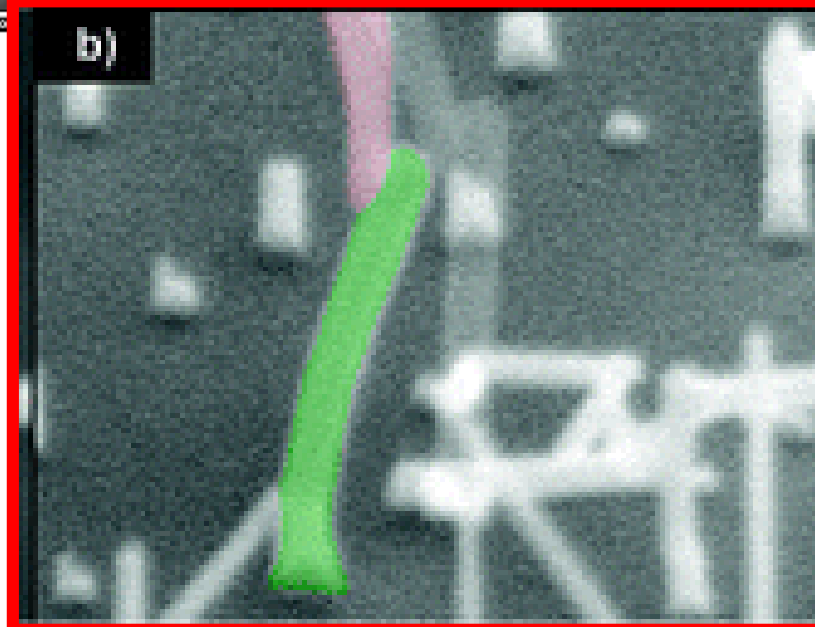
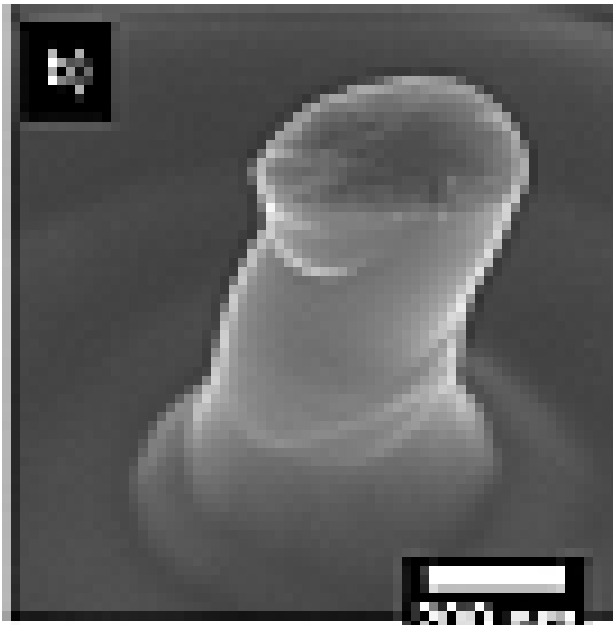


Uchic, Science 2004



Hoffmann, Nanoletters, 2005

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MICRO- SAMPLE  
THEORETICAL  
STRENGTH &  
BRITTLE IS DUCTILE

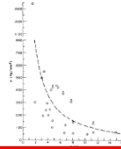


# seminal work in small scale mechanics

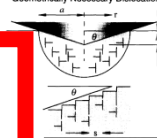
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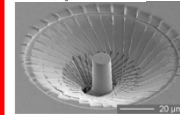
Pharr, J. Mater. Res. 1992



Brenner, J. Appl. Phys. 1956



Nix, Met Trans A, 1989



Uchic, Science 2004



Hoffmann, Nanoletters, 2005



Lilleoden, Acta Mat, 2006



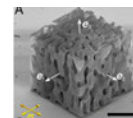
Minor, Nature Materials, 2008



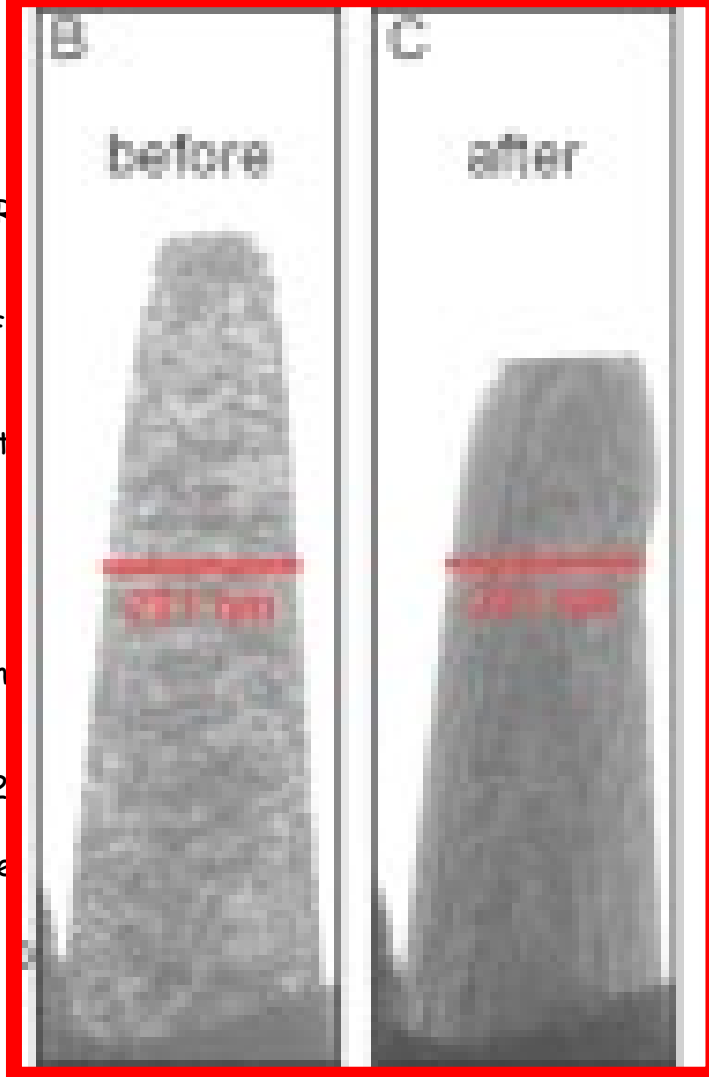
Oh, Nature Materials, 2009

Swierczak, Nature Materials 2014

Portuliano, Nature Materials, 2015



Portela, PNAS, 2020



BULK  
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MICRO- SAMPLE  
THEORETICAL  
STRENGTH &  
BRITTLE IS DUCTILE  
NUCLEATION VS  
STARVATION



Rabe, Thin Solid

Maio, J. Mater. Res.

Oestlund, Adv. F

Kiener, Acta Mat

Pharr, Acta Mat

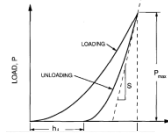
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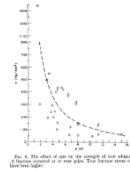
Gangaraj, Nature

# seminal work in small scale mechanics

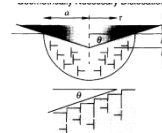
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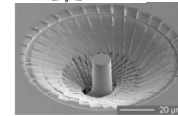
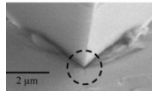


Brenner, J. Appl. Phys. 1956



Nix, Met Trans A, 1989

Rabe, Thin Solid Films, 2003



Uchic, Science 2004

Maio, J. Mater. Res, 2005



Oestlund, Adv. Func., 2005

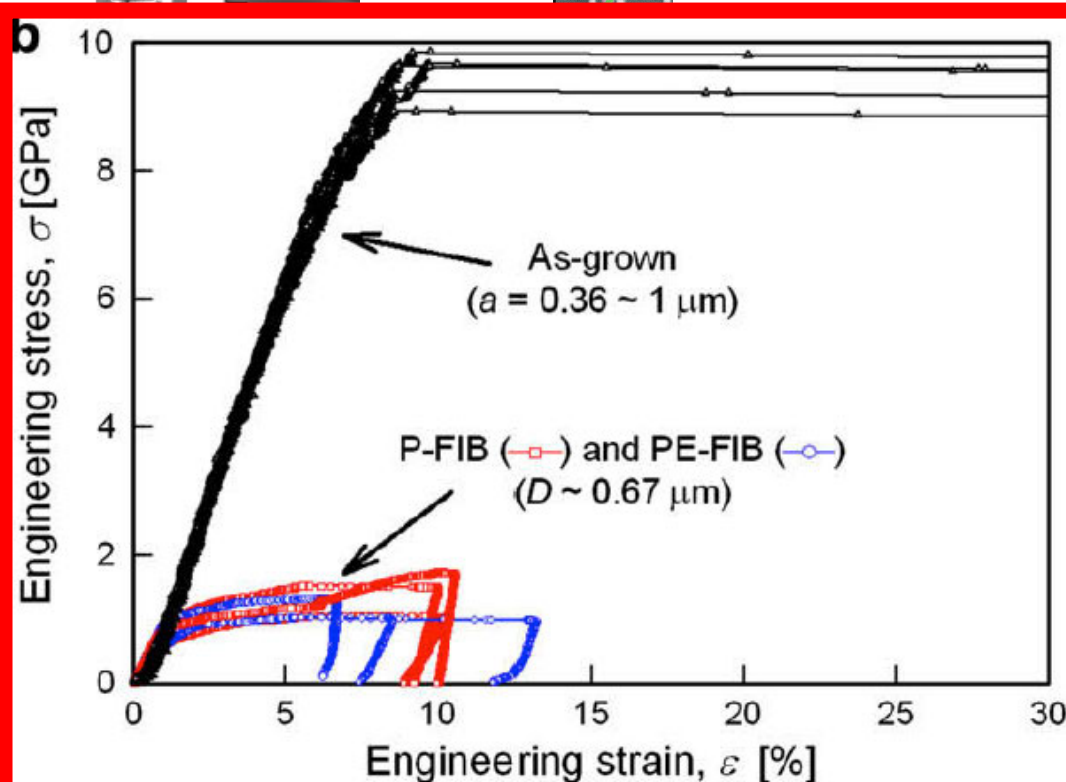
Kiener, Acta Mat, 2005

Pharr, Acta Mat 2008

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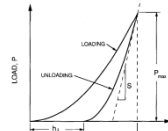
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NUCLEATION VS  
STARVATION  
FIB DAMAGE

# seminal work in small scale mechanics

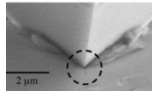
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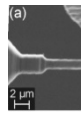
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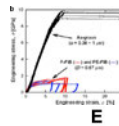
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Oestlund, Adv. Func., Mater, 2005

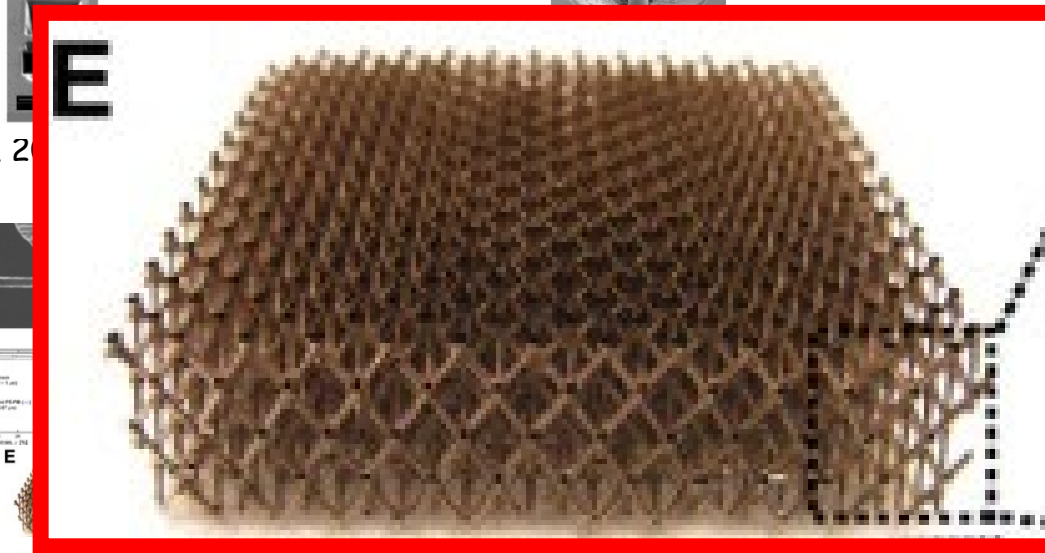


Kiener, Acta Mat, 2008

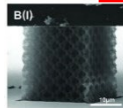


Pharr, Acta Mat 2008

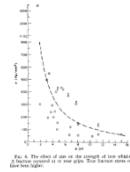
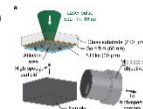
Schaedler, Science, 2011



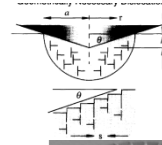
Meza, Science, 2014



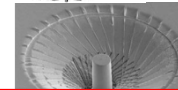
Gangaraj. Nature Com, 2018



Brenner, J. Appl. Phys. 1956



Nix, Met Trans A, 1989



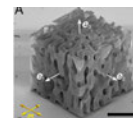
Uchic, Science 2004

BULK  
MINIATURE SAMPLE  
NANO TESTING  
IN-SITU  
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THEORETICAL  
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BRITTLE IS DUCTILE  
NUCLEATION VS  
STARVATION  
FIB DAMAGE  
3D ARCHITECTURE

Schwedl zrk, Nature Materials 2014

Tertuliano, Nature Materials, 2015

Portela, PNAS, 2020





# seminal work in small scale mechanics

Hall 1951, Petch 1953



Pharr, J. A.

Rabe, Th.

Maio, J. M.

Oestlund, J.

Kiener, A.

Pharr, A.

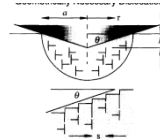
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Meza, S.

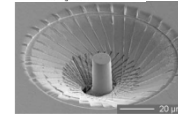
Gangaraj, V.



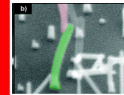
Brenner, J. Appl. Phys. 1956



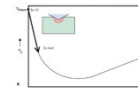
Nix, Met Trans A, 1989



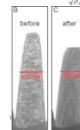
Uchic, Science 2004



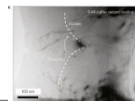
Hoffmann, Nanoletters, 2005



Lilleoden, Acta Mat, 2006



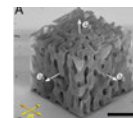
Minor, Nature Materials, 2008



Oh, Nature Materials, 2009

Schwiedrzik, Nature Materials 2014

Tertuliano, Nature Materials, 2015



Portela, PNAS, 2020

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3D ARCHITECTURE  
NATURAL  
MATERIALS

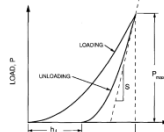


# seminal work in small scale mechanics

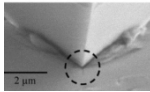
Hall 1951, Petch 1953



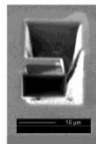
Pharr, J. Mater. Res. 1992



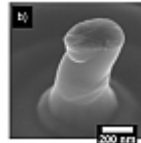
Rabe, Thin Solid Films, 2003



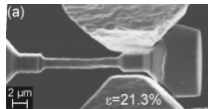
Maio, J. Mater. Res, 2005



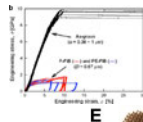
Oestlund, Adv. Func., Mater, 2006



Kiener, Acta Mat, 2008



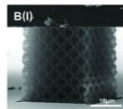
Pharr, Acta Mat 2008



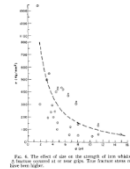
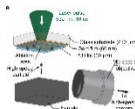
Schaedler, Science, 2011



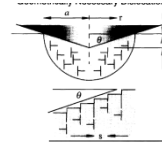
Meza, Science, 2014



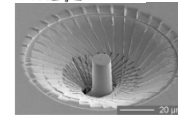
Gangaraj. Nature Com, 2018



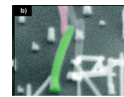
Brenner, J. Appl. Phys. 1956



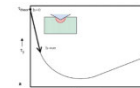
Nix, Met Trans A, 1989



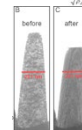
Uchic, Science 2004



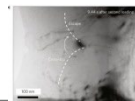
Hoffmann, Nanoletters, 2005



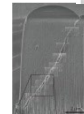
Lilleoden, Acta Mat, 2006



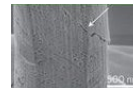
Minor, Nature Materials, 2008



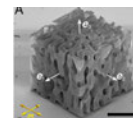
Oh, Nature Materials, 2009



Schwiedrzik, Nature Materials 2014



Tertuliano, Nature Materials, 2015



Portela, PNAS, 2020

BULK  
MINIATURE SAMPLE

NANO TESTING

IN-SITU

MICRO- SAMPLE

THEORETICAL  
STRENGTH &  
BRITTLE IS DUCTILE

NUCLEATION VS  
STARVATION

FIB DAMAGE

3D ARCHITECTURE

NATURAL  
MATERIALS

**@EXTREMES**

**DIFFRACTION**

**MODEL &  
METAMATERIALS**

# Size effects in materials

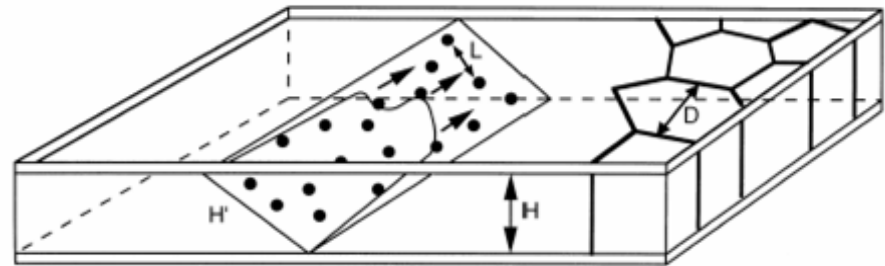
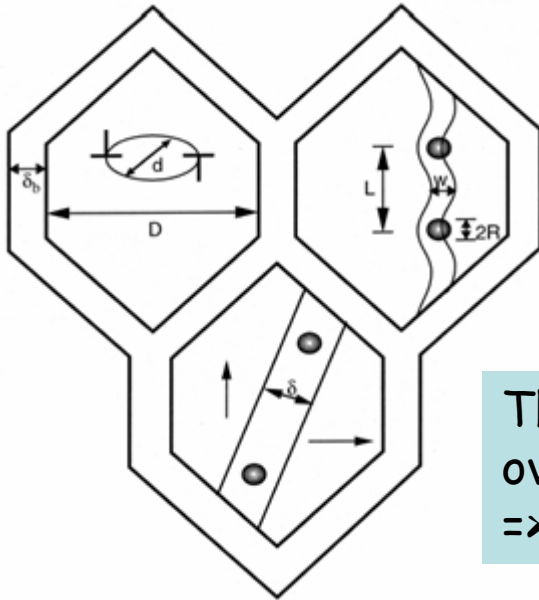
dimension of the physical phenomena involved  $\Rightarrow$  intrinsic length  
micro-structural dimension  $\Rightarrow$  size parameter

## Size Parameters:

Grain size  $D$ , Grain boundary width  $\delta_b$ , Obstacle spacing  $L$ , Obstacle radius  $R$ , Film thickness  $H$

## Characteristic lengths:

Equilibrium parameter of dislocation loop  $d$ , Spacing between partial dislocations  $w$ ,  
Width of magnetic domain wall  $d$

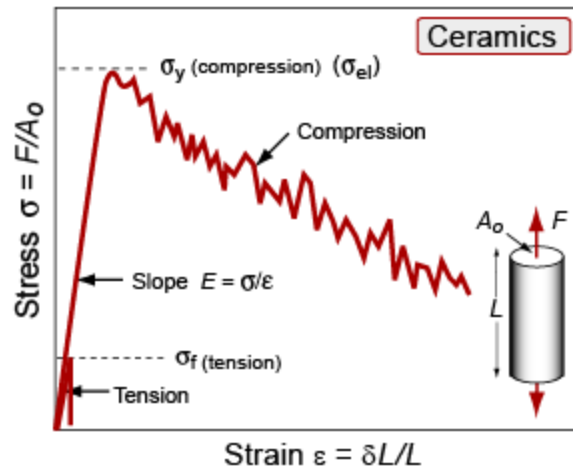
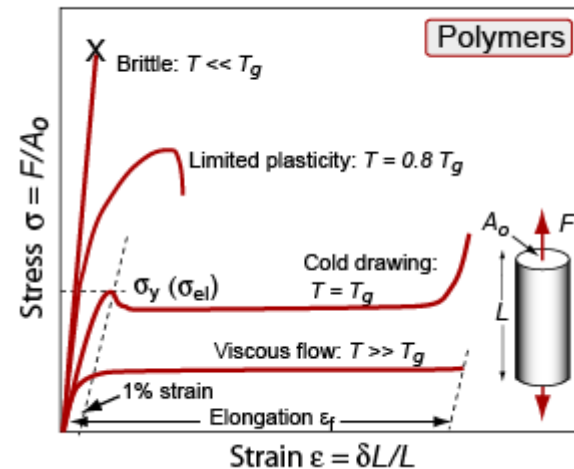
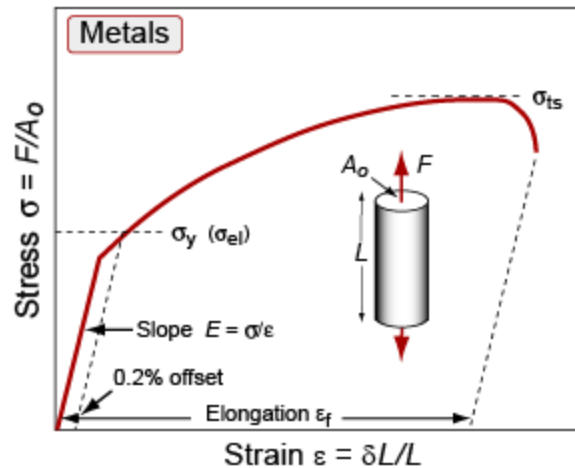


The range where characteristic lengths and size parameters overlap is of interest  
 $\Rightarrow$  conventional laws may break down

E. Arzt, Acta mater. 46(16), pp. 5611-5626, 1998

# Material properties: static strength

## Yield strength, elastic limit and ultimate strength



### Definition of yield strength:

metals: 0.2% offset yield strength

polymers: 1% offset

polymer composites: 0.5% offset

ceramics and glasses: compressive strength

# Origin of strength - yield strength limits

Range:

Theoretical strength:  $E/10$

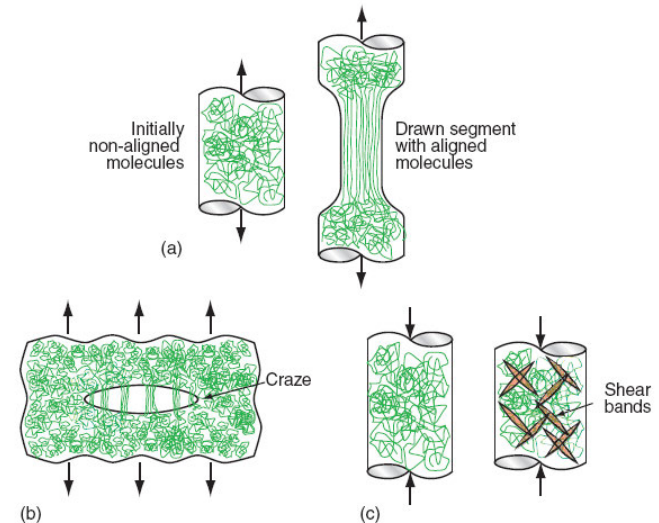
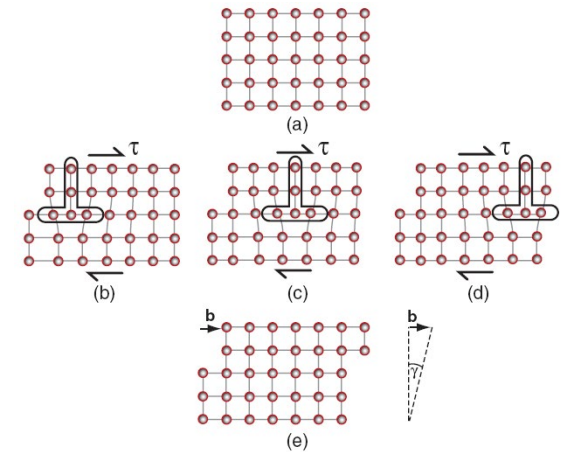
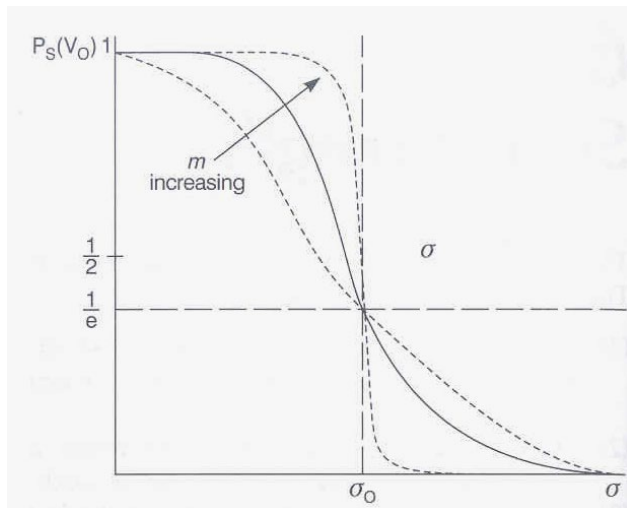
In applications: 0.01 MPa (foams) to 10GPa (diamond)

Mechanisms:

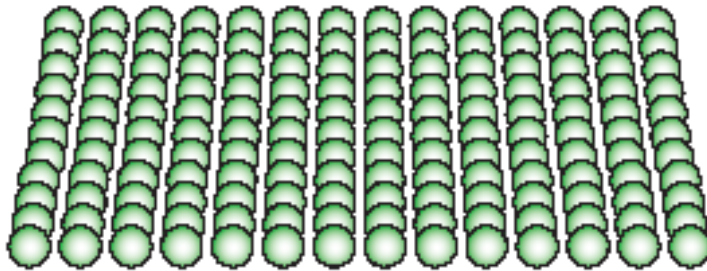
glide of dislocations in metals, slip of polymer chains, ...  
depends on temperature

Variability in strength:

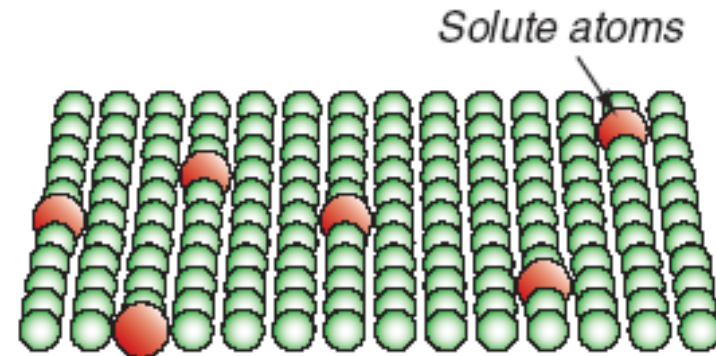
Weibull statistics  $P(V)=\exp(-\sigma/\sigma_0)^m)$



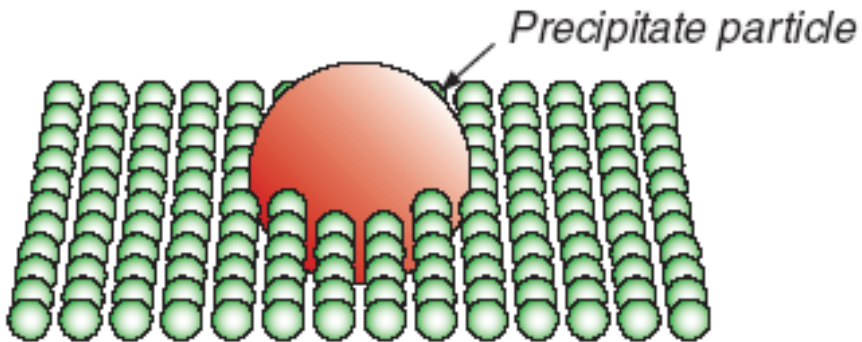
# Strength: Mechanisms in crystals



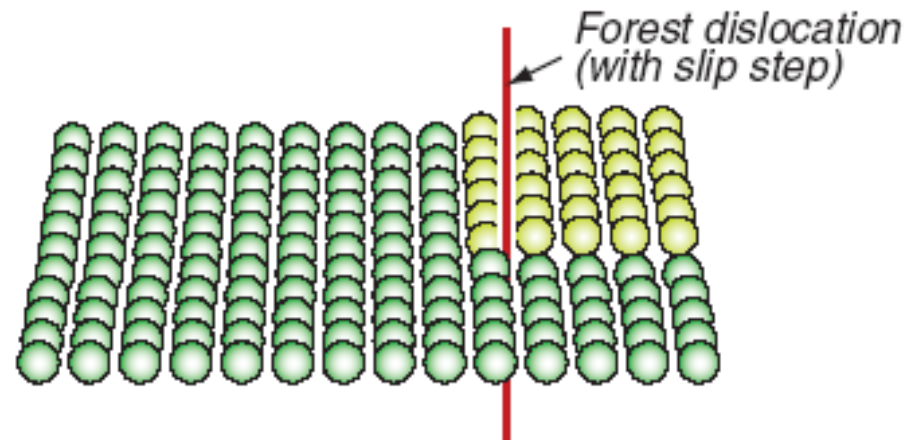
(a) Perfect lattice, resistance  $f_i$



(b) Solution hardening, resistance  $f_{ss}$



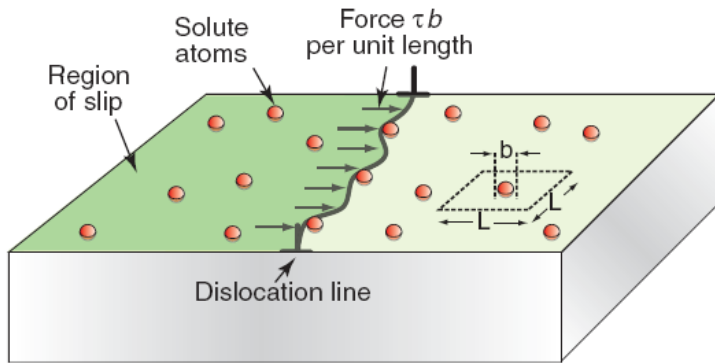
(c) Precipitate hardening, resistance  $f_{ppt}$



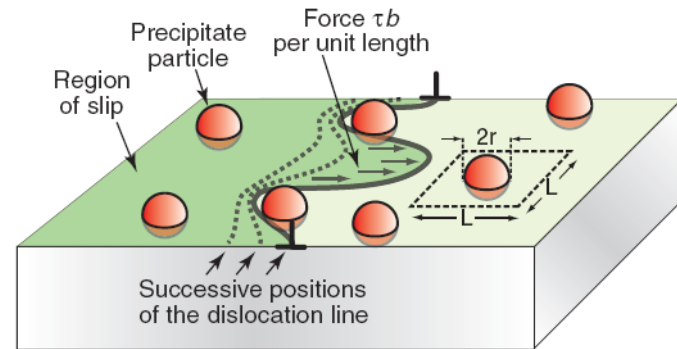
(d) Work hardening, resistance  $f_{wh}$



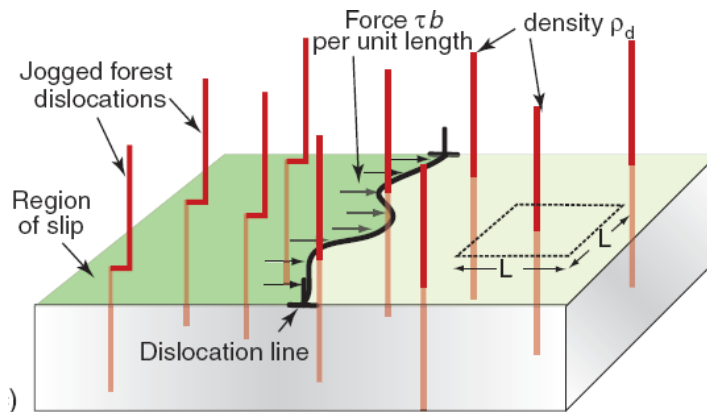
# Strengthening by mechanisms



$$\tau_{ss} = \alpha E c^{1/2}$$

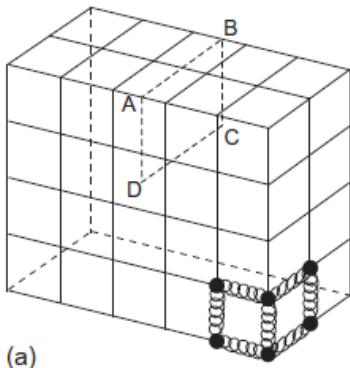


$$\tau_{ppt} = \frac{Eb}{L}$$

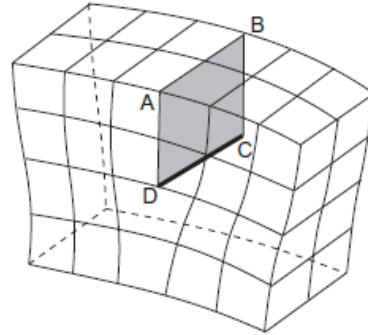


$$\tau_{wh} \approx \frac{Eb}{2} \sqrt{\rho_d}$$

# Dislocations

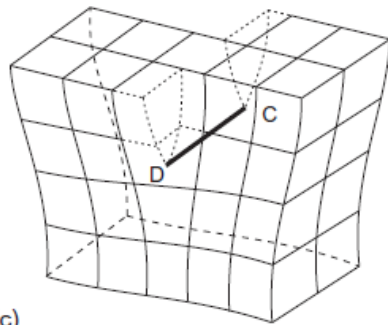


(a)

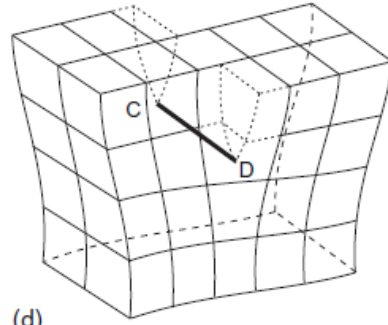


(b)

edge dislocation



(c)



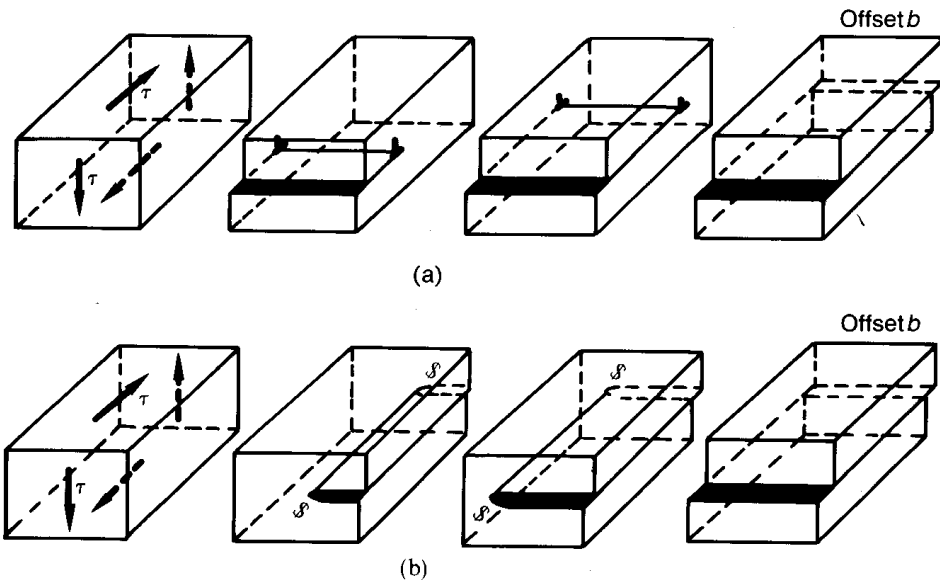
(d)

screw dislocation



# Dislocation glide

- The effect of dislocation motion in a crystal: passage causes one half of the crystal to be displaced relative to the other. This is a *shear displacement*, giving rise to a *shear strain*.

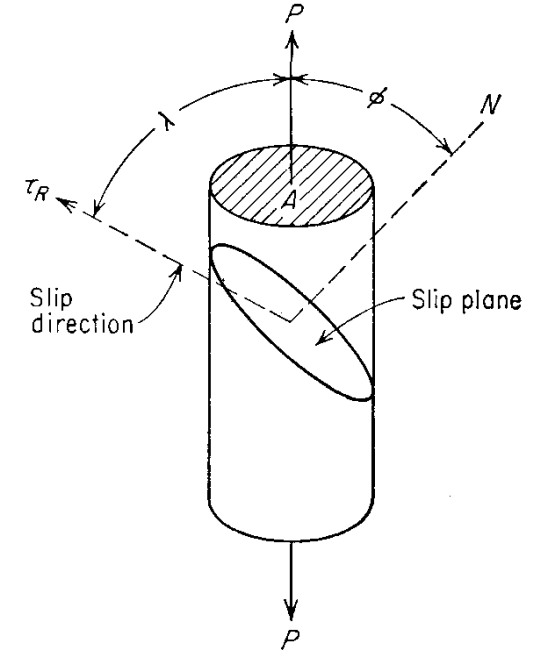


[Dieter]

**Figure 5-4** (a) Macroscopic deformation of a cube produced by glide of an edge dislocation. (b) Macroscopic deformation of a cube produced by glide of a screw dislocation. Note that the end result is identical for both situations.

# Resolved Shear Stress

- Geometry of slip: how big an applied stress is required for slip?
- Resolved shear stress: take the component of the tensile stress,  $P$ , along the slip direction which is given by  $F \cos \lambda$ ,
  - divide by the area over which the shear force is applied,  $A / \cos \phi$ .



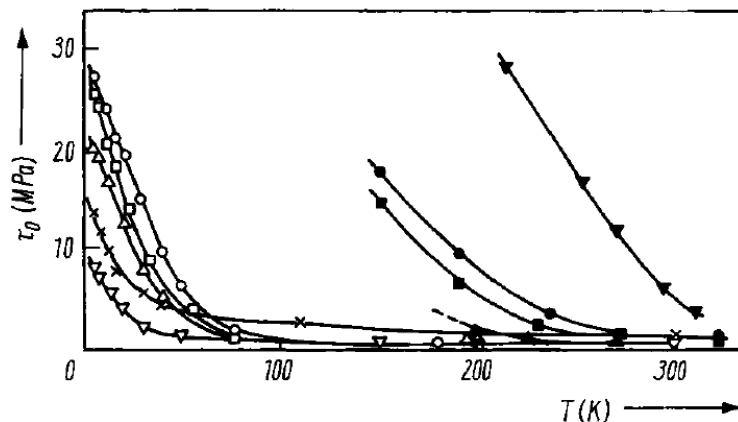
$$\tau_{\text{CRSS}} = (F/A) \cos \lambda \cos \phi = \sigma_y \underbrace{\cos \lambda \cos \phi}_{\text{Schmid factor}} = \sigma_y \times m$$

Schmid factor  $:= m$

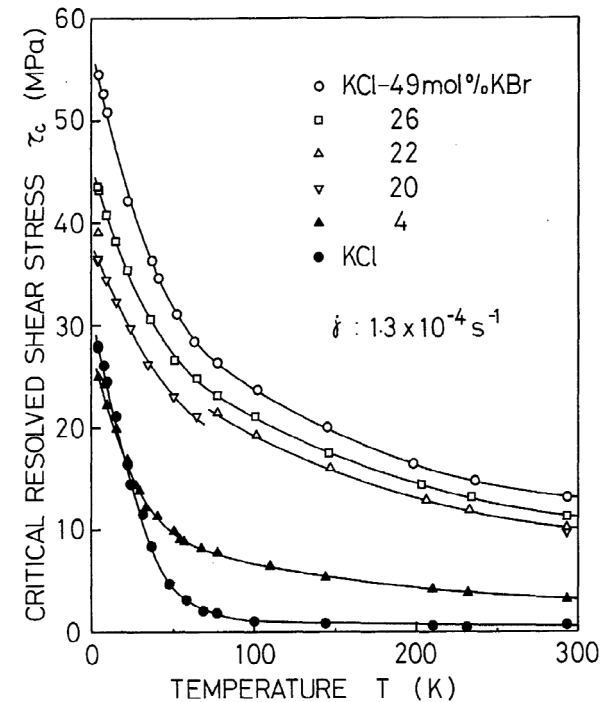
**For FCC, random grains:  $m = 1/3.06$**

# Peierls stress

- Lattice resistance,  $\tau_p$ , at 0 K;
- Above, "lattice friction stress",  $\tau_0 = \tau_p (1 - T/T_m)$

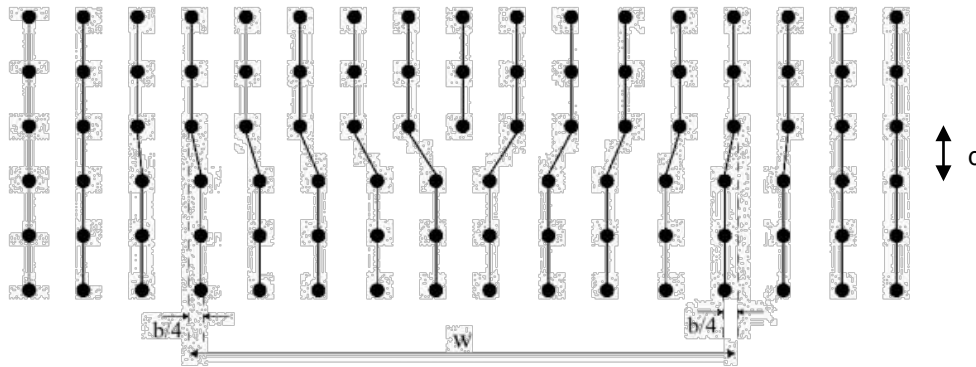


critical resolved shear stresses for slip on  
 $\{110\}$  and  $\{100\}$  planes. LiF:  $\times$   $\{110\}$ ;  
 NaCl:  $\nabla$   $\{110\}$ ,  $\blacktriangledown$   $\{100\}$ ; KCl:  $\circ$   $\{110\}$ ,  
 $\bullet$   $\{100\}$ ; KBr:  $\square$   $\{110\}$ ,  $\blacksquare$   $\{100\}$ ; KI:  
 $\triangle$   $\{110\}$ ,  $\blacktriangle$   $\{100\}$



# Peierls stress

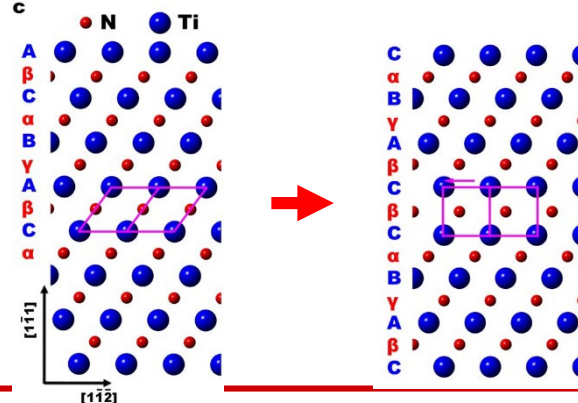
- Calculations of Peierls stress:



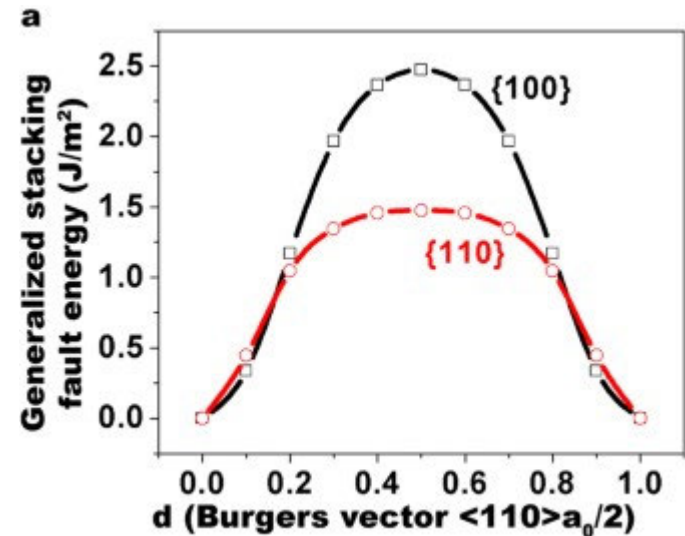
Isotropic elastic material

$$\tau_p = \frac{2G}{1-\nu} \exp\left(-\frac{2\pi d}{b(1-\nu)}\right)$$

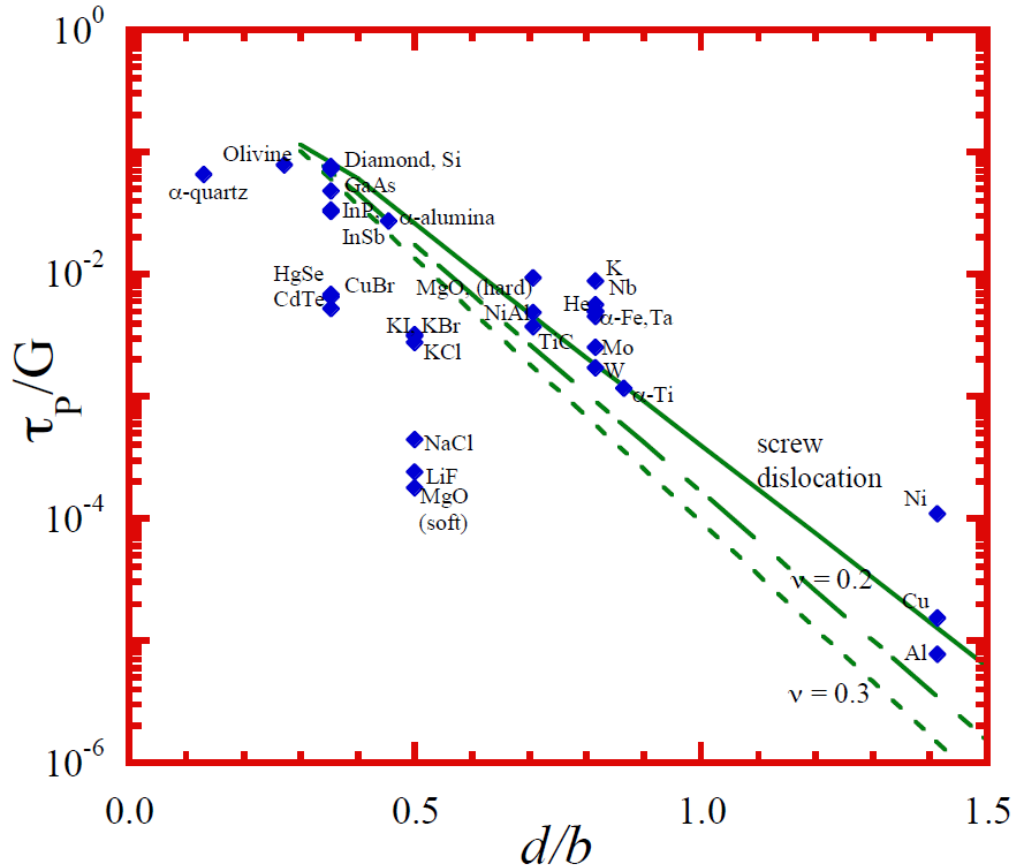
- Shape of barrier is important:  
gradient = force



Dislocations in TiN: DFT @ 0 K !!!!



# Peierls stress

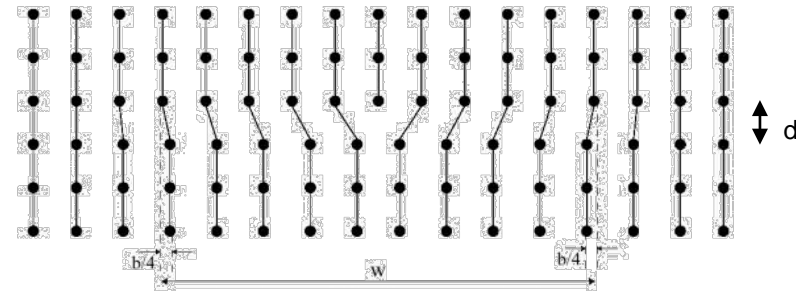


Isotropic elastic material

$$\tau_p = \frac{2G}{1-\nu} \exp\left(-\frac{2\pi d}{b(1-\nu)}\right)$$

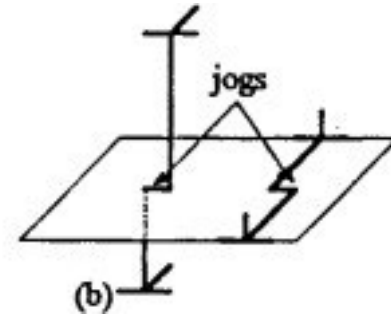
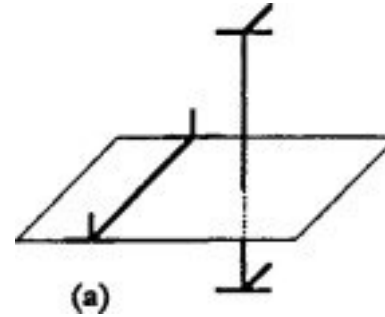
Non-isotropic material

$$\tau_p = \frac{2G}{1-\nu} \exp\left(-\frac{4\pi w}{b}\right).$$

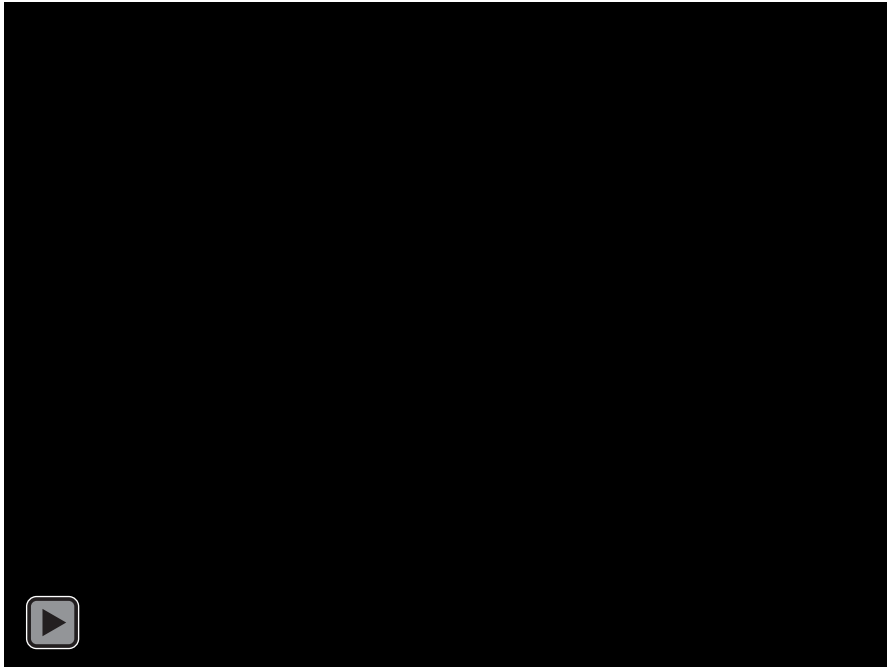


# Dislocation interactions

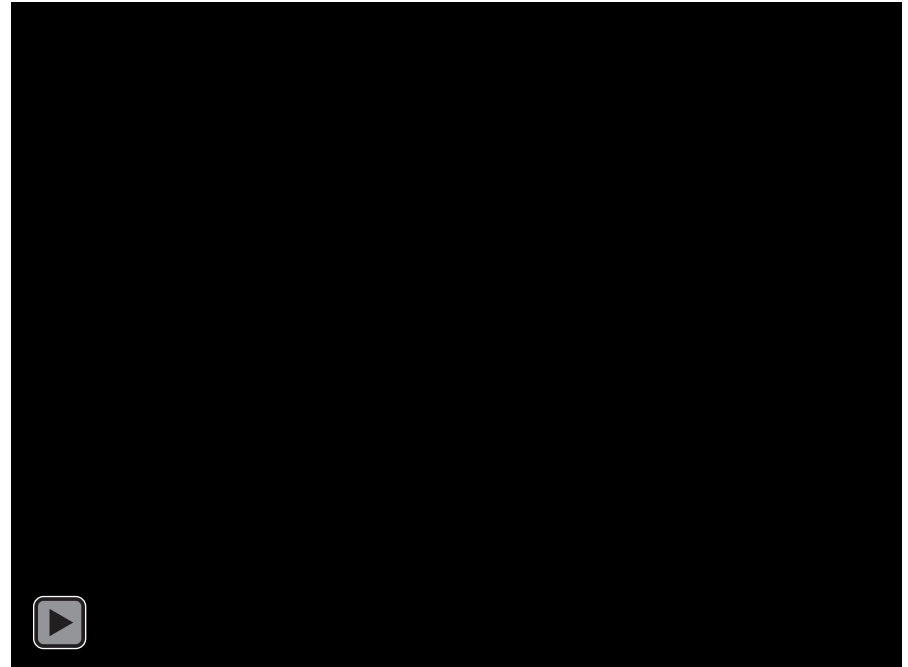
- Kinks and jogs = sessile
- Forest of dislocations develops



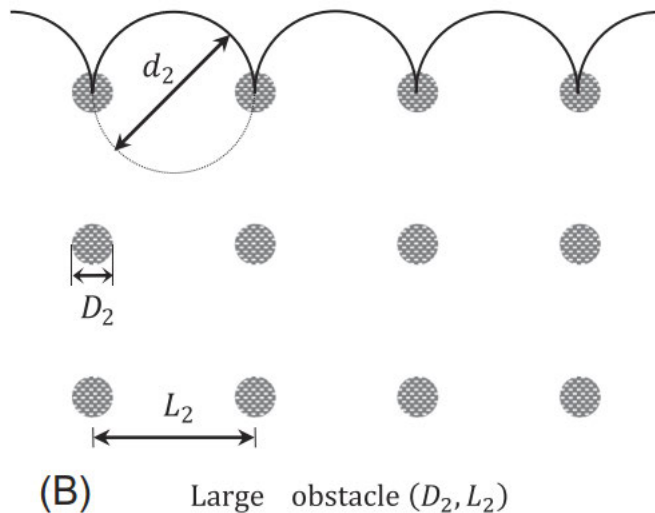
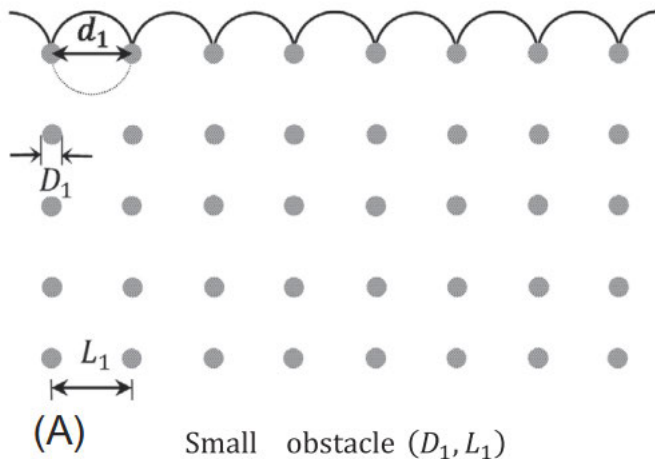
304 SS



$\alpha$ -Ti



# Intrinsic size effect - dislocation spacing



Some other microstructural equations can be reproduced using the Orowan mechanism. For example, the Taylor hardening model relates the shear strength to the dislocation density  $\rho$  as follows:

$$\tau = \alpha G b \sqrt{\rho}$$

where  $\alpha$  is a material parameter. In this case, the obstacles are forest dislocations and the obstacle spacing can be approximated by average dislocation source length  $L_{ave}$ , which can be obtained as follows:

$$L_{ave} = \frac{1}{\sqrt{\rho}}$$

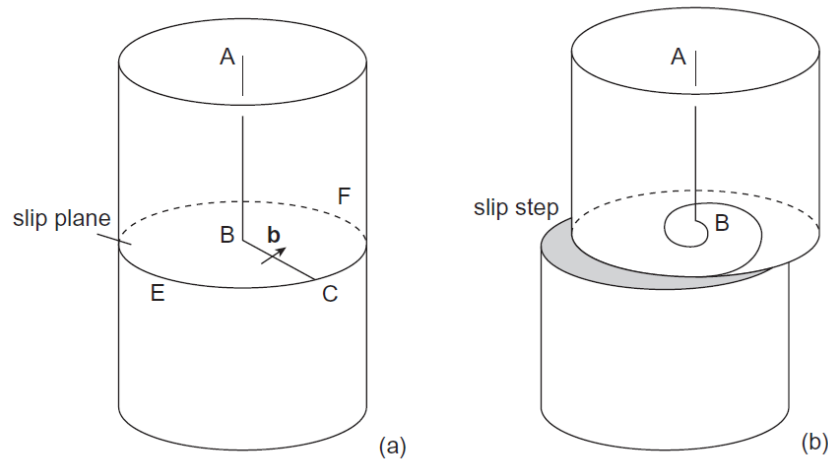
Therefore from above:

$$\tau = \frac{G b}{L_{ave}} = G b \sqrt{\rho}$$

However, one should notice that the forest dislocations as obstacles are penetrable. Accordingly we should use a reduction factor  $\alpha < 1$  as follows:

$$\tau = \alpha G b \sqrt{\rho} \quad \text{Work hardening!}$$

# Dislocation multiplication - Frank-Read source



Single ended Frank-Read source.

(a) Dislocation lying partly in slip plane CEF.

(b) Formation of a slip step and spiral dislocation by rotation of BC about B.

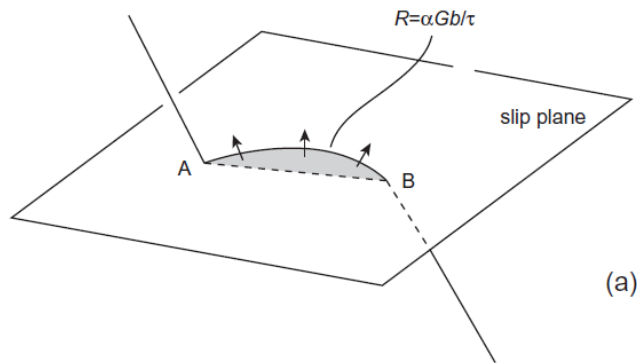
Each revolution around B produces a displacement  $b$  of the crystal above the slip plane relative to that below.

The process is regenerative since it can repeat itself so that  $n$  revolutions will produce a displacement  $nb$ .

A large slip step will be produced at the surface of the crystal



# Dislocation multiplication - Frank-Read source



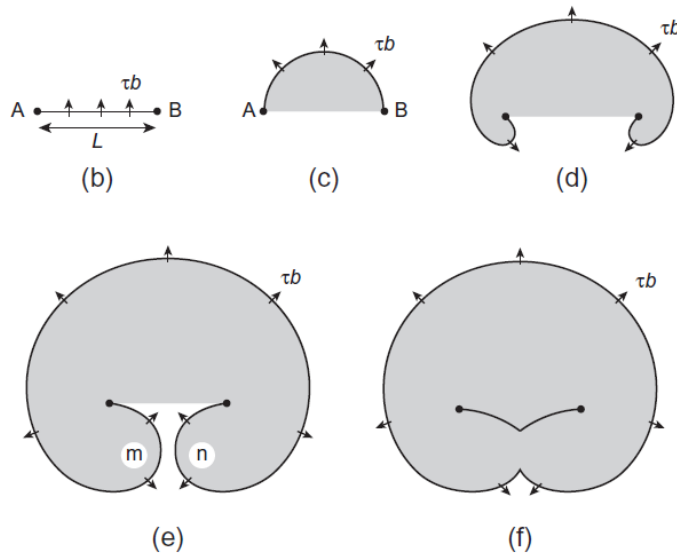
The dislocation segment is held at both ends by dislocation intersections, precipitates etc.

An applied resolved shear stress  $\tau$  exerts a force  $\tau b$  per unit length of line and tends to make the dislocation bow

The radius of curvature  $R$  depends on the stress.

$$\tau_0 = \frac{\alpha Gb}{R}$$

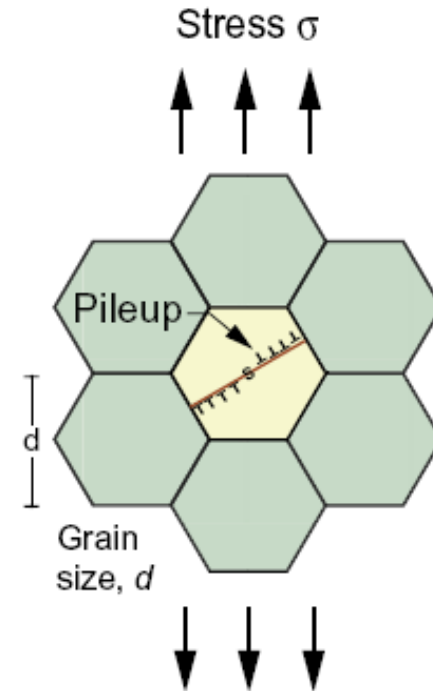
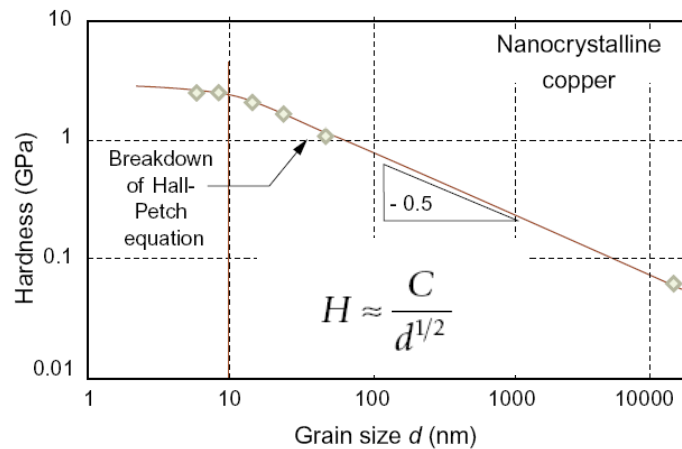
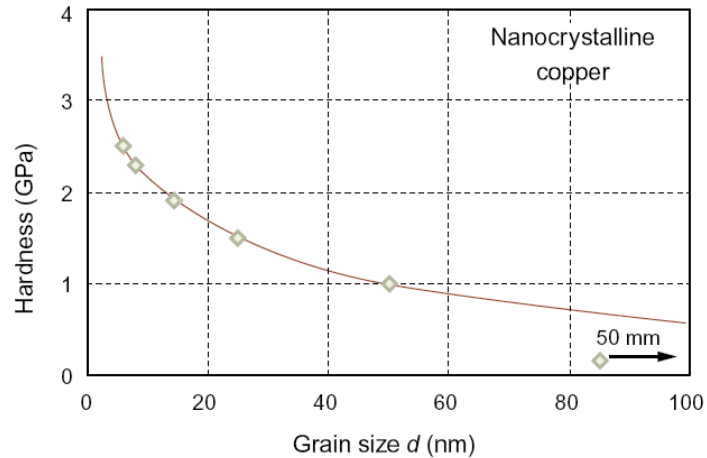
as  $\tau$  increases,  $R$  decreases and the line bows out until the minimum value of  $R$  is reached at the position illustrated in Fig. c



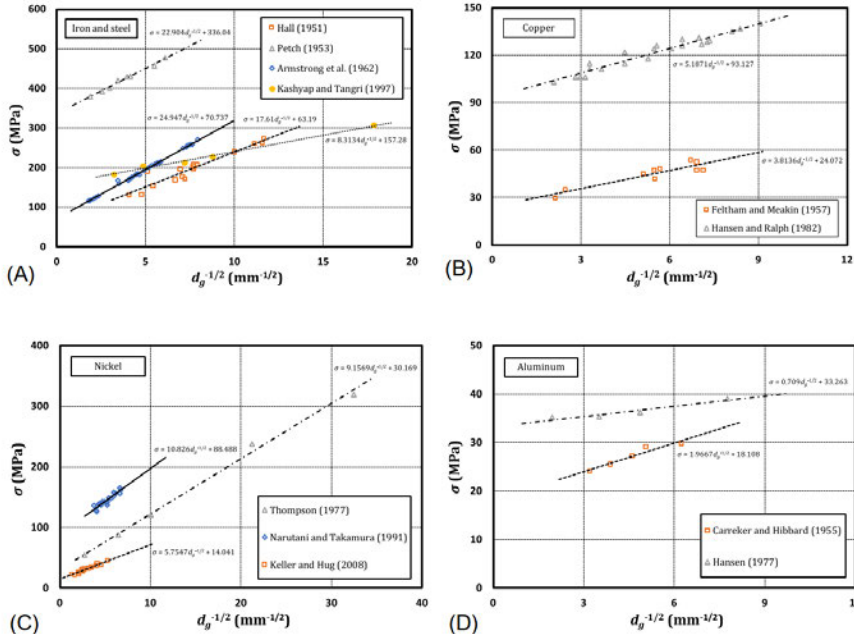
Here,  $R$  equals  $L/2$ , where  $L$  is the length of AB, and the stress is

$$\tau_{max} = Gb/L$$

# Mechanical properties of nanocrystalline solids



# Intrinsic size effect - grain size



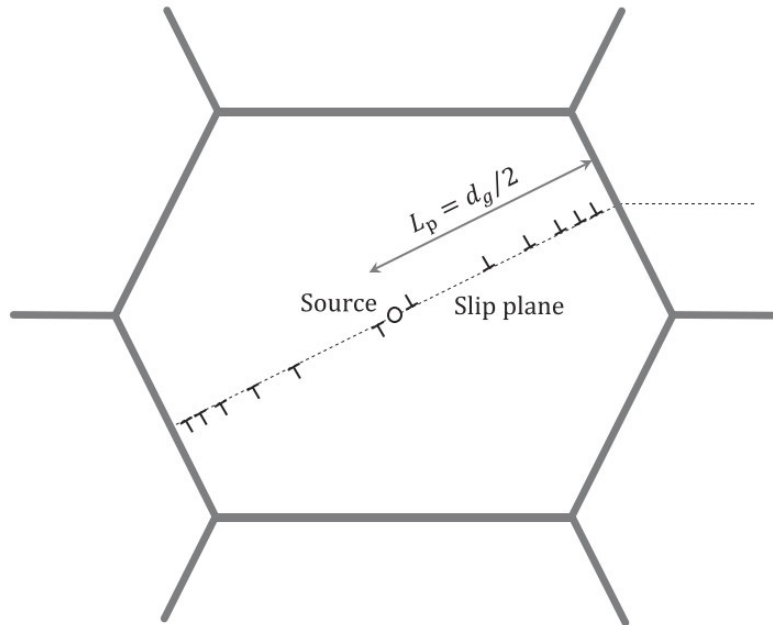
Following the studies of Hall (1951) and Petch (1953), the general equation for the dependency of the material strength on grain size can be described as follows:

$$\sigma = \sigma_0 + K_{HP}d_g^{-x}$$

here  $\sigma$  is the yield or flow stress,  $\sigma_0$  is the corresponding stress for a very large grained bulk material or bulk single crystals, and  $K_{HP}$  is a material constant. The exponent  $x$  is a constant, where  $0 < x < 1$ .

Many different experimental and theoretical studies have been performed to obtain the appropriate values of  $\sigma_0$ ,  $K_{HP}$ , and  $x$ .

# Intrinsic size effect - grain size



The **pile-up model** states that the dislocations are moving inside the grain until they reach the grain boundary that stops their movement.

Since the dislocations cannot pass the grain boundary because of the mismatch between grains, the grain boundary acts as an obstacle.

The dislocations form a pile-up behind the grain boundary with the length  $L_p$  ( $L_p = d_g/2$ ). The pile-up process continues until the stress concentration induced by the array of dislocations  $\tau_p$  reaches a critical value of  $\tau_{cr}$ . At this moment, the dislocations will pass the grain boundary and material yield occurs.

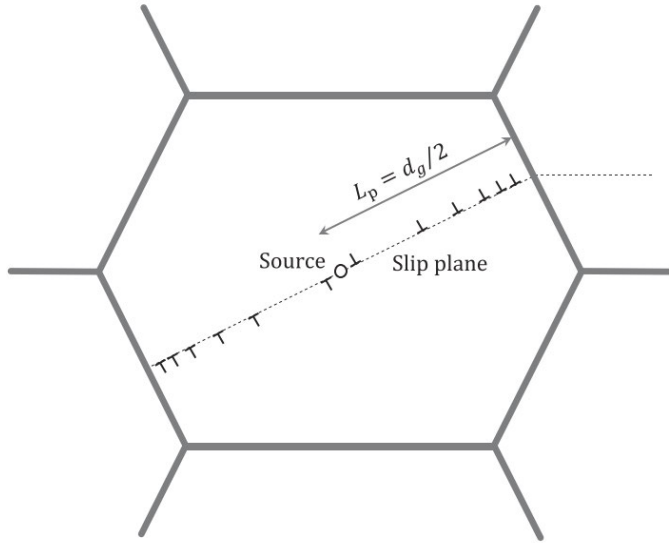
Dislocation slip occurs as soon as the shear stress becomes larger than  $\tau_0$ . The dislocations will be subjected to the slip stress  $\tau_s$  which is

$$\tau_s = \tau - \tau_0$$

The pileup stress induced by blocked dislocation can be calculated as follows:

$$\tau_p = n\tau_s$$

# Intrinsic size effect - grain size



The number of dislocations  $n$  can be related to the pile-up length  $L_p$  as follows:

$$n = \frac{\tau_s L_p b}{T}$$

The material yields at  $\tau_p = \tau_{cr}$ . Accordingly,  $\tau_s$  at yield can be calculated as follows:

$$\tau_s = \left( \frac{\tau_{cr} T}{L_p b} \right)^{1/2} \quad \tau_p = n \tau_s$$

The shear stress at which the material yields  $\tau_y$  can be obtained using

$$\tau_y = \tau_0 + \left( \frac{\tau_{cr} T}{L_p b} \right)^{1/2} \xrightarrow{L_p = d_g/2} \tau_y = \tau_0 + \left( \frac{2 \tau_{cr} T}{d_g b} \right)^{1/2}$$

For crystalline metals, the relation between the flow stress  $\sigma_y$  and shear stress  $\tau_y$  can be described as follows

$$\sigma_y = A \tau_y$$

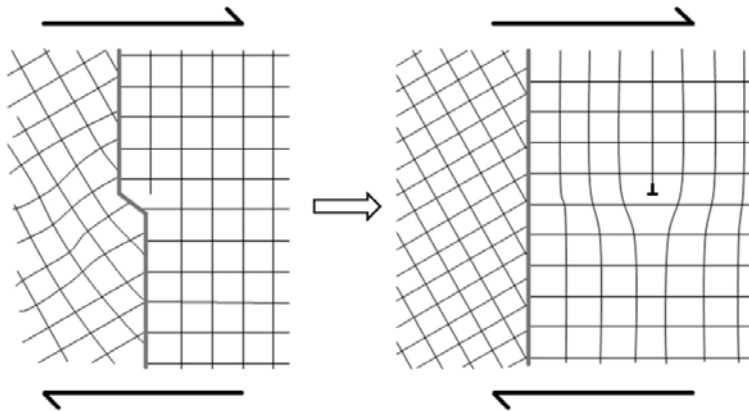
where  $A$  is the Taylor factor (inverse of Schmid). Assuming  $T = \alpha G b^2$ , where  $\alpha$  is a constant of the order of unity it follows

$$\sigma_y = \sigma_0 + \left( \frac{2 \alpha G \tau_{cr} b}{d_g} \right)^{1/2}$$

Comparing with the Hall-Petch relation yields,  $x = 1/2$  and

$$K_{HP} = A (2 \alpha G \tau_{cr} b)^{1/2}.$$

# Intrinsic size effect - grain size

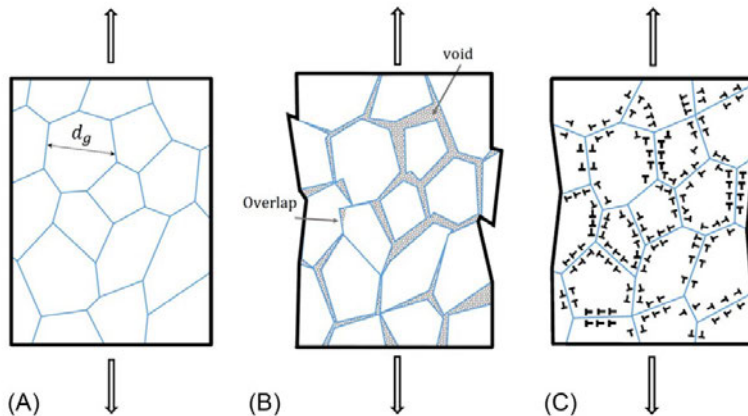


Other models that justify the Hall-Petch effect:

a) **dislocation nucleation from grain boundary ledges.** In this model, it is assumed that the yield stress is the one required to move the forest dislocations, which are nucleated from the grain boundary ledges, inside the grain.

b) **Dislocation density model.** In this model, it has been assumed that the dislocation mean free path has a linear relation with the grain size.

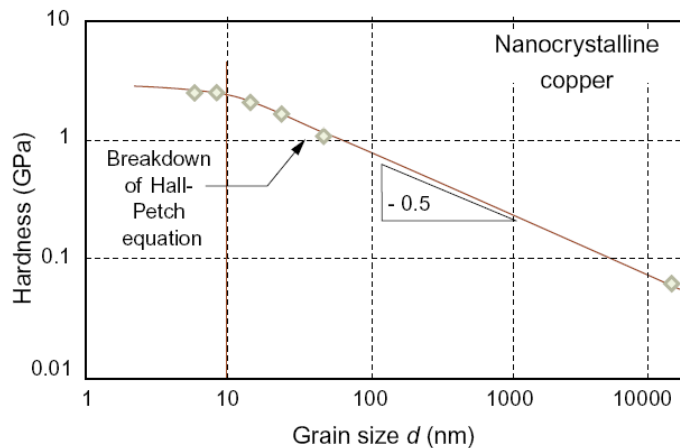
c) **The non-homogenous plastic deformation model** incorporated the concept of geometrically necessary dislocations (GNDs). The deformation in the sample is divided into two parts; a uniform deformation provided by the dislocation movement inside the grain, and a non-homogenous deformation which is the result of GNDs slip to produce the compatible deformation pattern between grains



d) **Confined layer slip model (CLS, see later)**

G.Z. Voyiadjis and M. Yaghoobi. (2018)

# Intrinsic size effect - inverse Hall Petch

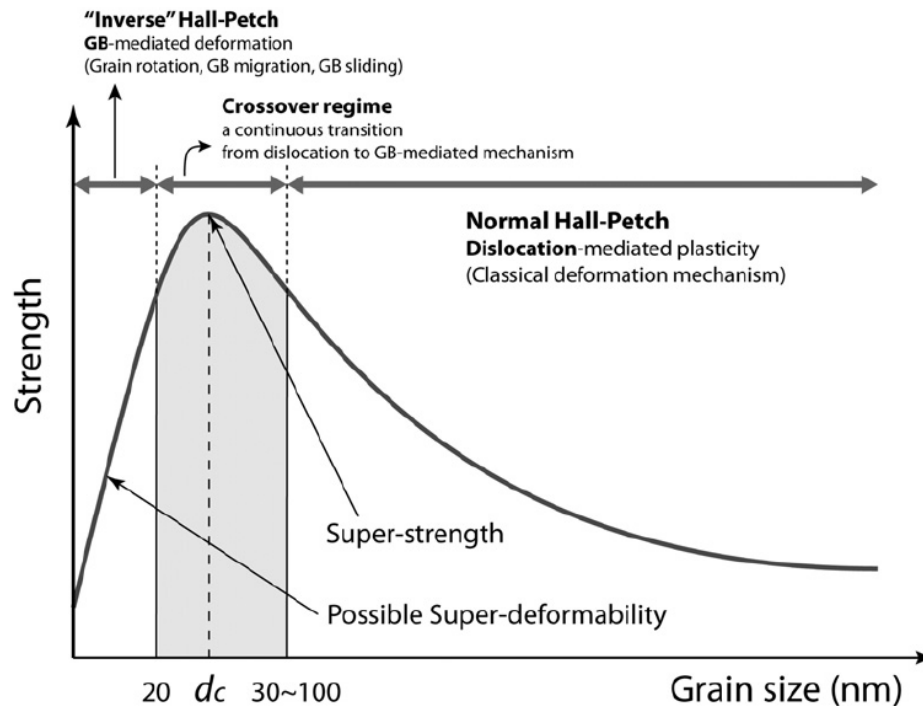


As the grain size decreases, two typical behaviors have been reported.

One trend states that the material yield or flow stress reaches a plateau for smaller grain sizes.

The other trend states that after some critical grain size, the material yield or flow stress decreases as the grain size decreases, which is commonly known as the inverse Hall-Petch effect.

# Intrinsic size effect - inverse Hall Petch



Plastic deformation of crystalline materials involves a wide range of interaction phenomena between dislocations and grain boundaries, which are still subject to extensive research.

When the grains are reduced to 40 nm they cannot accommodate multiple lattice dislocations, which engages alternative plastic deformation mechanisms like grain-boundary sliding, partial dislocation emission and absorption at grain boundaries.

At grain sizes below 20 nm, the Hall-Petch relation gives way to the so-called "inverse" Hall-Petch, due to the activation of grain boundary-assisted deformation.



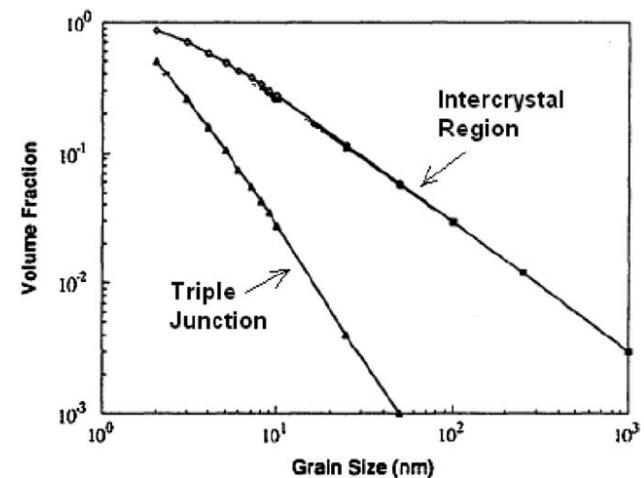
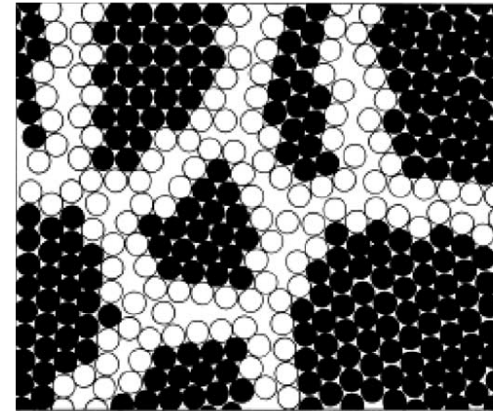
# Intrinsic size effect - inverse Hall Petch

Nanocrystalline materials are structurally characterized by a large volume fraction of grain boundaries.

As the grain size is decreased, an increasing fraction of atoms can be ascribed to the grain boundaries.

Different deformation mechanisms have been proposed to capture the deviation from the Hall-Petch relation including the

- Diffusional creep
- breakdown in pile-up model
- grain boundary sliding
- phase mixture model
- grain coalescence
- shear band formation



G.Z. Voyiadjis and M. Yaghoobi. (2018)

M.A. Meyers et al. / Progress in Materials Science 51 (2006) 427-556

# Intrinsic size effect - inverse Hall Petch

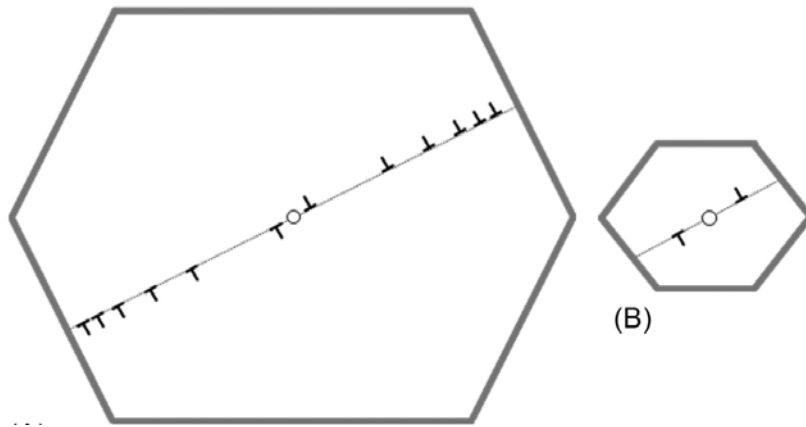
The inverse Hall-Petch was firstly reported by Chokshi et al. (1989) in which they studied the effects of grain size on the Vickers microhardness for nanocrystalline copper and palladium. They attributed the inverse Hall-Petch effect to the **diffusional creep** occurring at room temperature for nanocrystalline materials.

They incorporated the Coble creep as the governing mechanism of deformation as follows

$$\dot{\epsilon} = \frac{150\Omega\delta D_{gb}\sigma}{\pi k T d_g^3}$$

where  $\dot{\epsilon}$  is the strain rate,  $\Omega$  is the atomic volume,  $\delta$  is the width of the grain boundary,  $D_{gb}$  is the diffusion coefficient of grain boundary,  $\sigma$  is the applied stress,  $k$  is the Boltzmann's constant, and  $T$  is the absolute temperature.

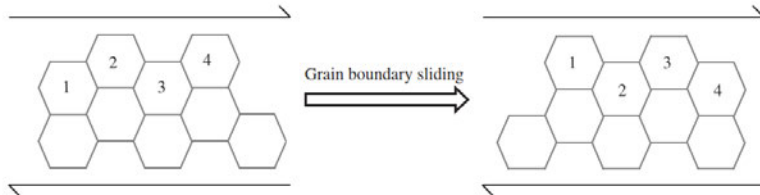
# Intrinsic size effect - inverse Hall Petch



The stress concentration due to this pile-up against the grain boundary is the driving force of the pile-up model.

As the grain size decreases, the number of dislocations inside the grain also drops. Accordingly, there is a grain size at which the number of dislocations are so few that **the pile-up theory breaks down**.

# Intrinsic size effect - inverse Hall Petch



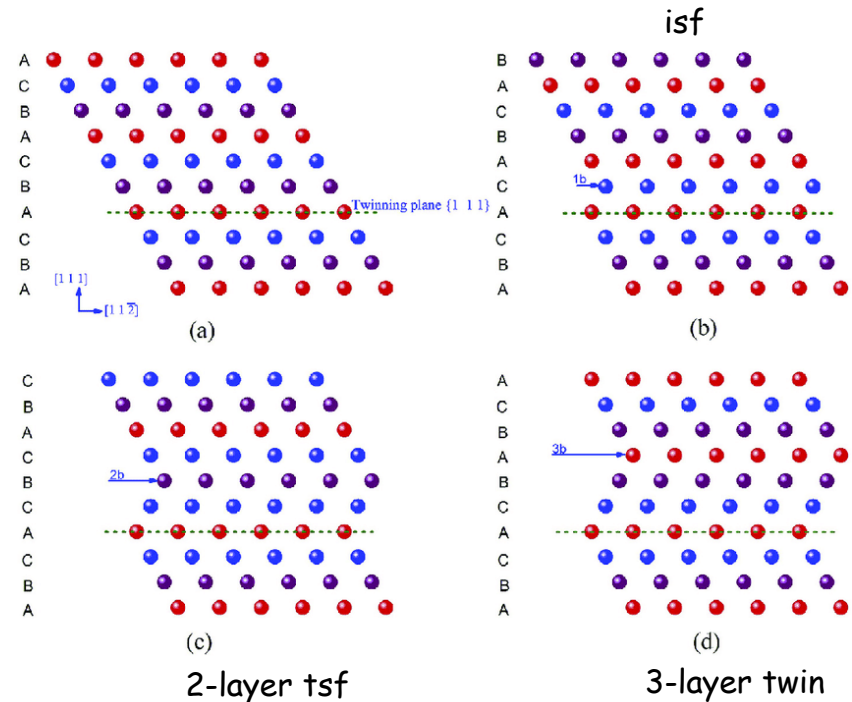
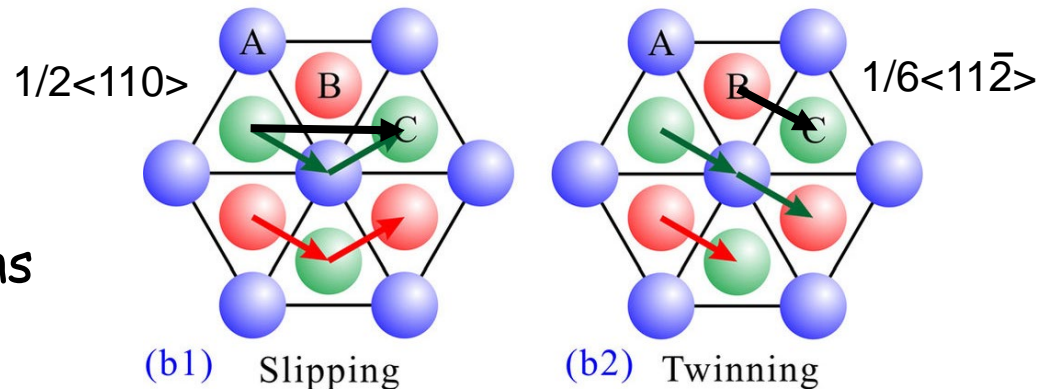
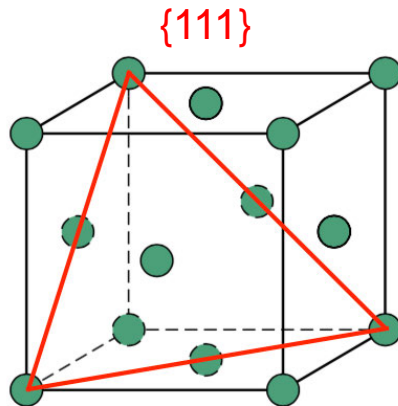
**Grain boundary sliding** has been introduced as one of the underlying mechanism of superplasticity and the combination of grain boundary sliding with diffusion creep, grain boundary migration, or dislocation slip and/or climb have been identified as superplasticity mechanisms.

As the grain size decreases, the number of dislocations fit in the grains decreases. Accordingly, the applied plastic flow cannot be sustained by the dislocations slip inside, and other mechanisms should govern the deformation process **such as diffusion or grain boundary shear**.

$$\tau_{\text{GBS}} = \frac{1}{3} \left[ L \frac{\rho_m}{M_{\text{Cu}}} \left( 1 - \frac{T}{T_m} \right) f_g + \left( \frac{\dot{\epsilon}_{\text{GBS}}}{\dot{\epsilon}_{\text{tot}}} - 1 \right) \frac{kT}{b^3} \right]$$

# Twinning

- Cooperative shear
- In FCC: mediated by Shockley partial dislocations
  - $1/6\langle 11\bar{2} \rangle \{111\}$
- In HCP: ask Nicoló

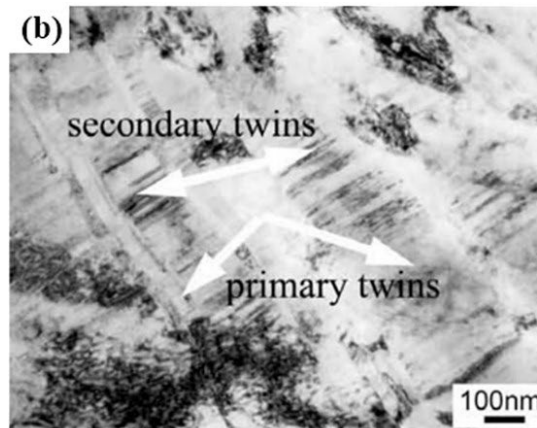
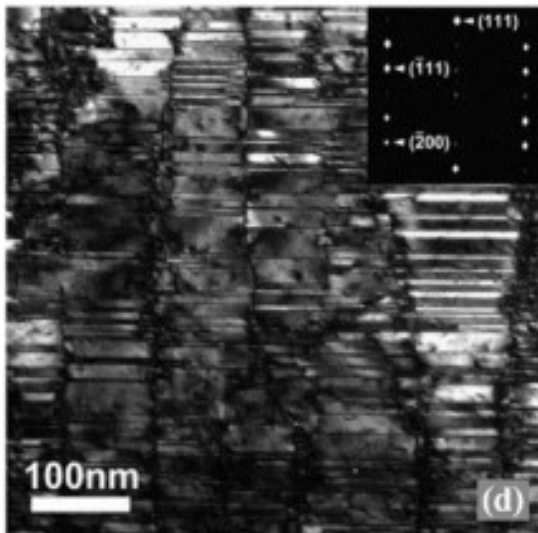


# Nanotwinned materials

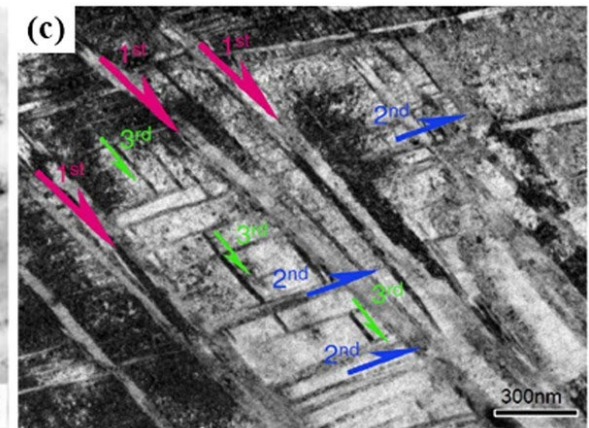
- Stacking fault energy
- Make by
  - ECAP, torsion
  - Pulsed electroplating
  - Magnetron sputtering

	Materials	$\gamma_{SF}$ (mJ/m <sup>2</sup> )
Pure Metals	Pb	6-10
	Ag	16
	Au	32-46
	Cu	45
	Ni	125
	Al	166
	Pd	180
	Pt	322
Alloys	$\gamma$ -TiAl	173
	CuNi	45-110
	FeCrNi	32-46
	Stainless steels	20-50
	FeNiCoCr	30
	FeNiCoCrMn	20-25
	CuZn	7-45
	CuAl	5-35
	Fe <sub>30wt%Mn</sub>	15
	Cu <sub>12.1at%Al</sub> 4.1at%Zn	7

nt-Ag, sputtered



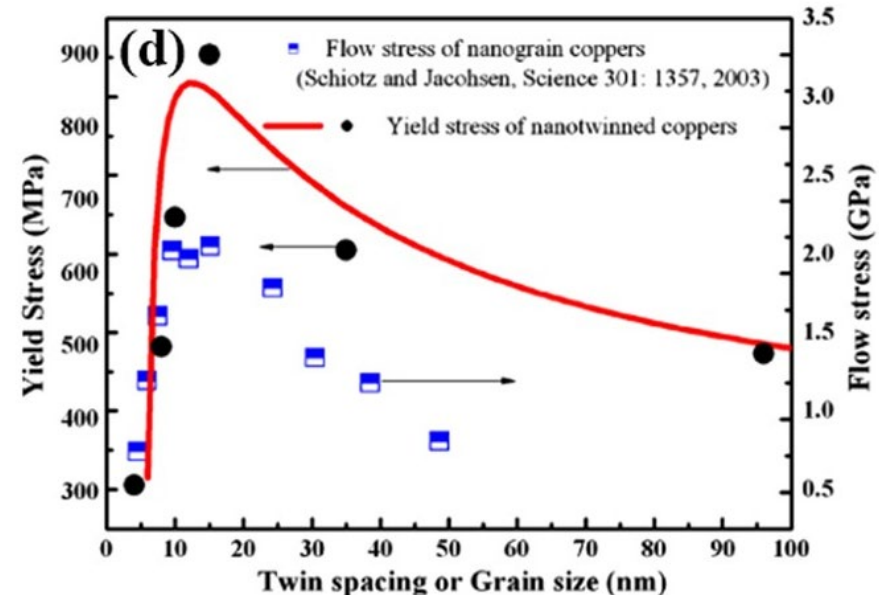
Cu-Al, ECAP



TWIP steel, torsion

# Nanotwinned materials

- Stacking fault energy
- Make by
  - ECAP, torsion
  - Pulsed electroplating
  - Magnetron sputtering
- Strength: competition between:
  - Pile-up type strengthening
  - Detwinning of the nanotwins
  - [or dislocation nucleation at the TB-GB junctions]



$$\sigma_{HP} = \sigma_0 + k_{HP}/\sqrt{\lambda}$$

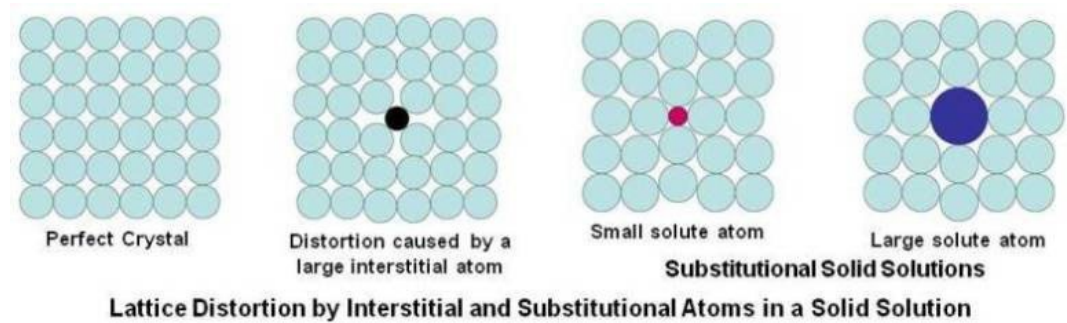
$$\sigma_{detwinning} = M \left[ \frac{2.28E_0\lambda}{\pi R h} - \frac{\gamma_{isf}}{h} + \left( \frac{\dot{\epsilon}_{DT}}{\dot{\epsilon}_{tot}} - 1 \right) \frac{2kT}{\pi R^2 h} \right]$$

$$\sigma_{DN} = M \left[ \frac{\Delta U}{S^*V^*} - \frac{kT}{S^*V^*} \ln \left( \frac{d\nu_D}{\lambda \dot{\epsilon}} \right) \right]$$



# Solid solution strengthening

- Substitutional
- Interstitial



- Key idea: local distortion of lattice

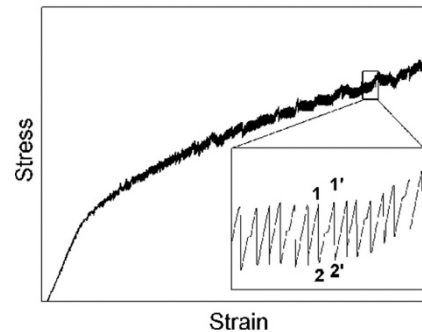
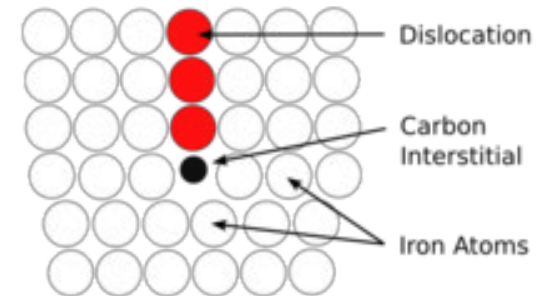
$$\Delta\tau_{\text{SSS}} = Gb\epsilon^{3/2}c^{1/2}$$

$$\epsilon = \left| \frac{\Delta G}{G\Delta c} - \beta \frac{\Delta a}{a\Delta c} \right| \quad \text{i.e. the distortions in atomic positions and elastic moduli}$$

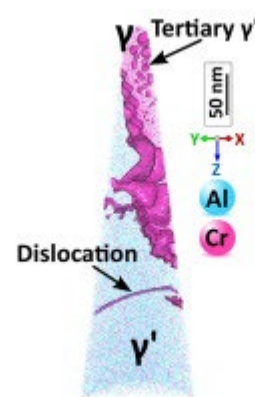
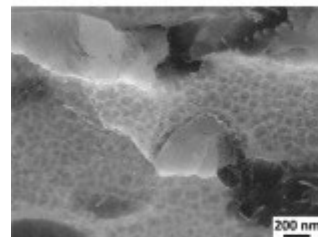


# Solid solution strengthening

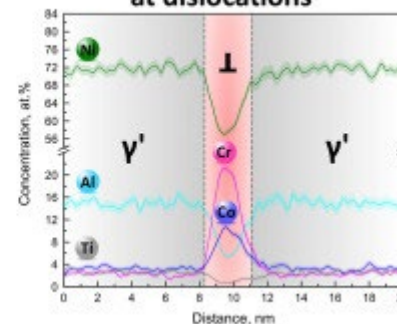
- Arrangement of solutes along the dislocation line
- Interstitials
  - C in steel: Cottrell atmospheres
  - Lüders bands, Portevin-Le Chatelier
  - Hinder formability
- But also substitutionals:
  - Ni superalloy:



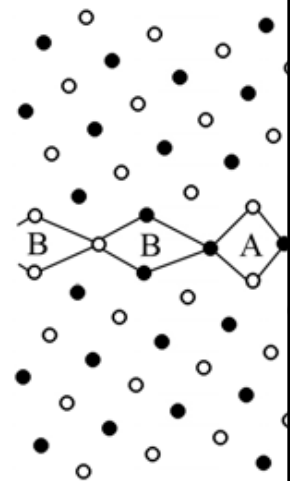
Dislocations in a rafted single crystal superalloy



Cr/Co segregation at dislocations

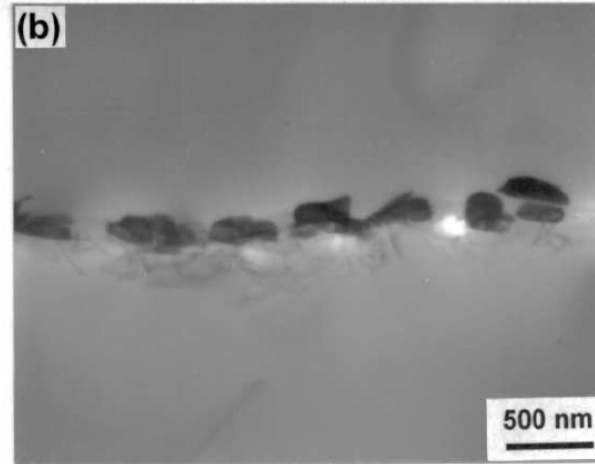
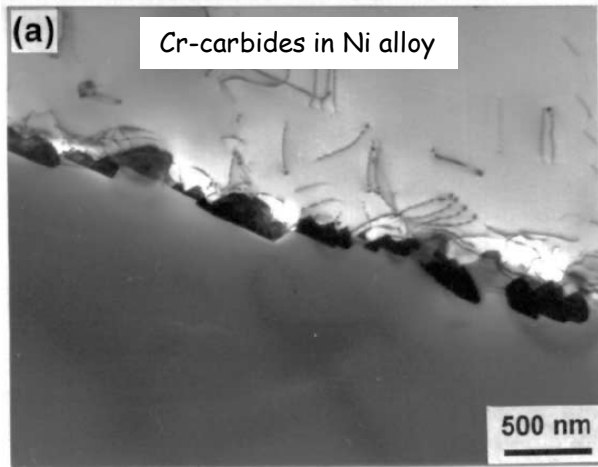


# Solid solutions: Complexions

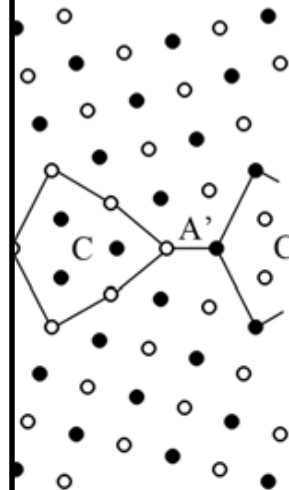
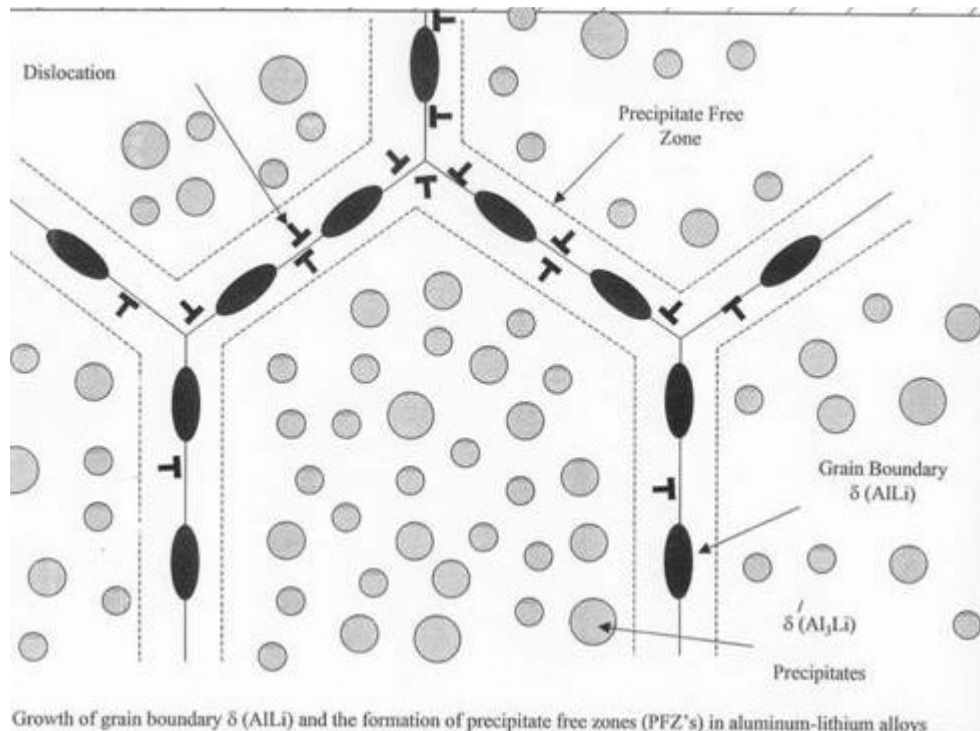
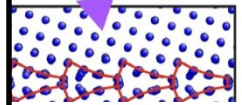


$$\Sigma 17(410)\theta = 28.07^\circ$$

[B.BA]

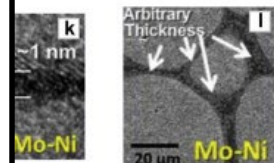


split-kite

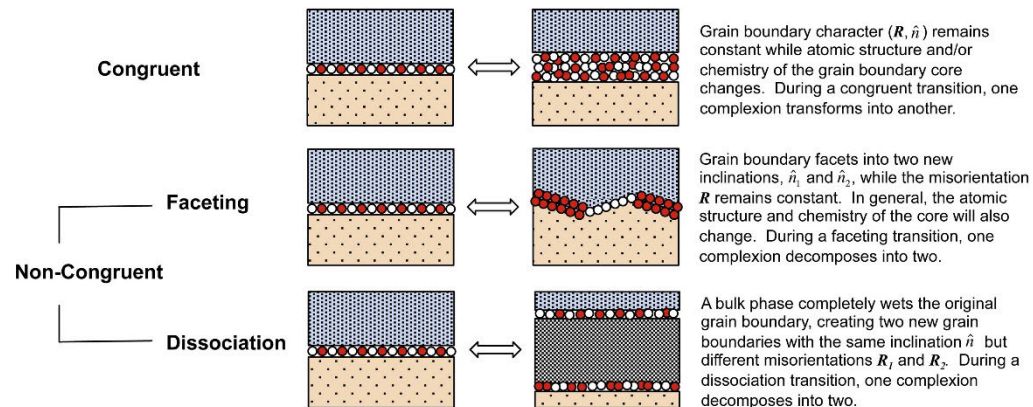


$$\Sigma 7(530)\theta = 61.93^\circ$$

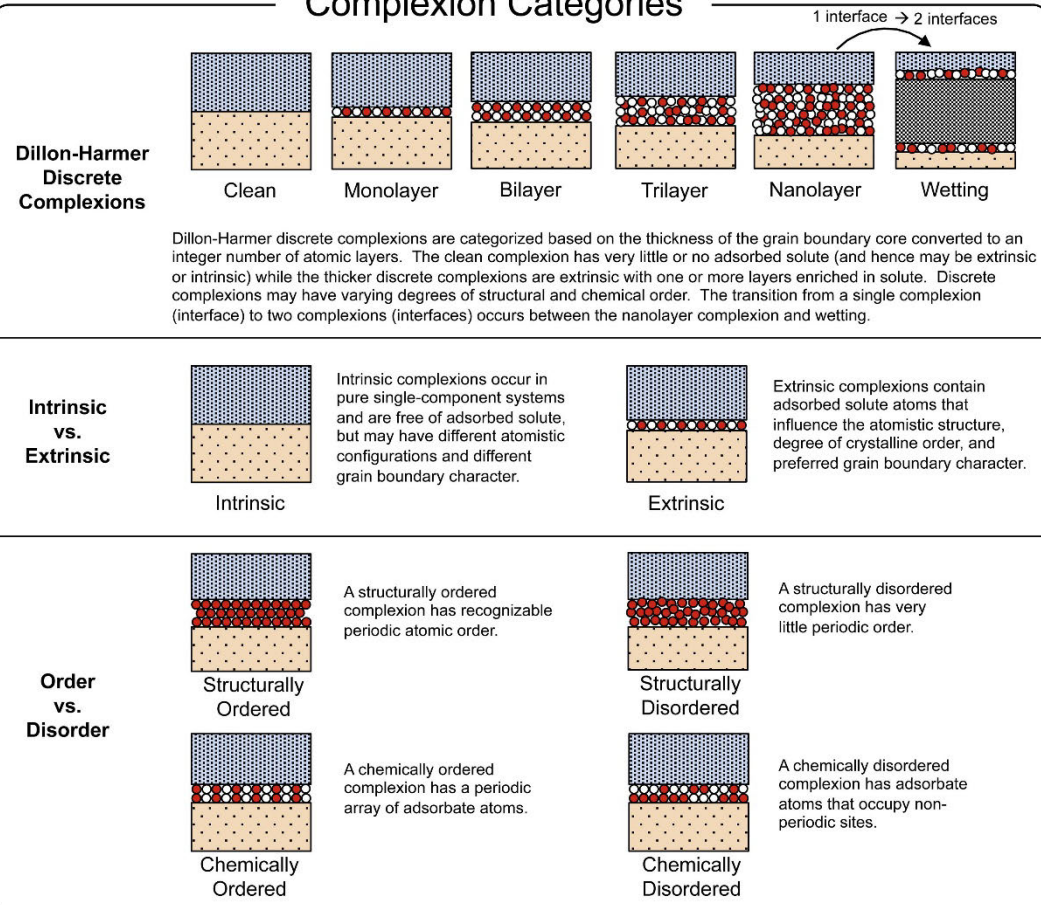
[CA'.CA']



## Complexion Transitions

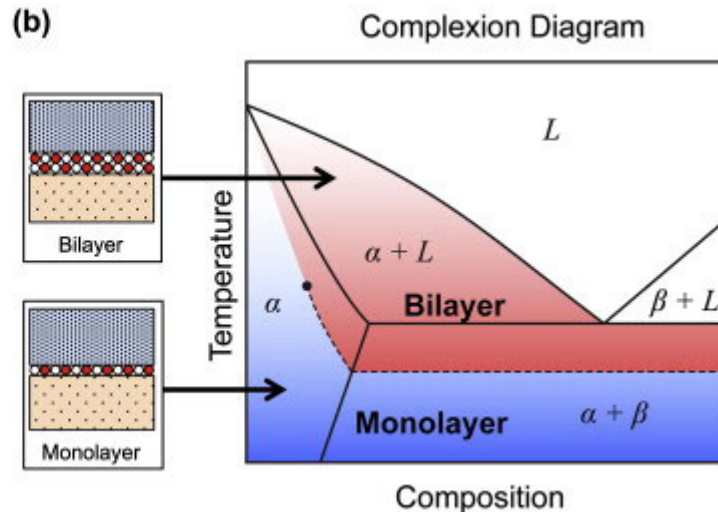
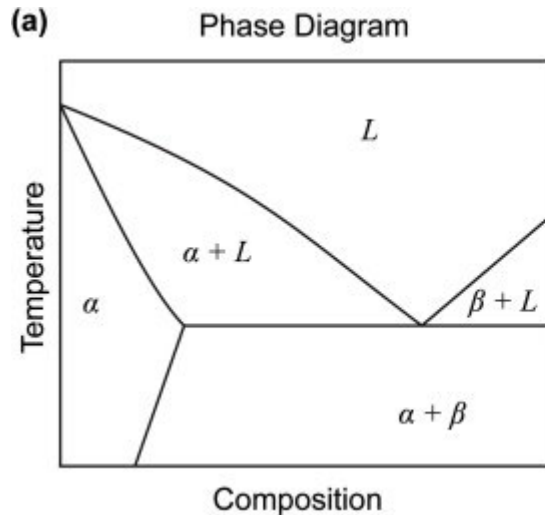
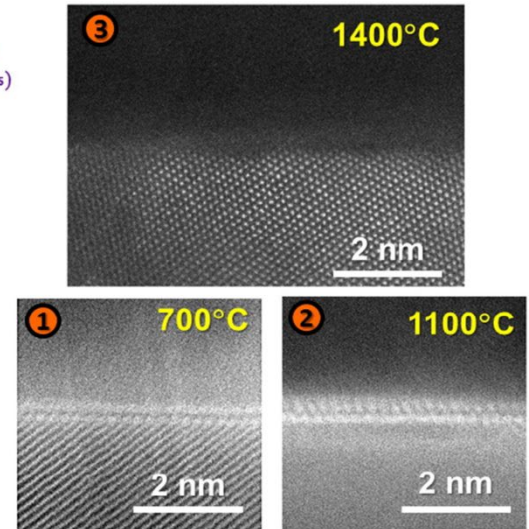
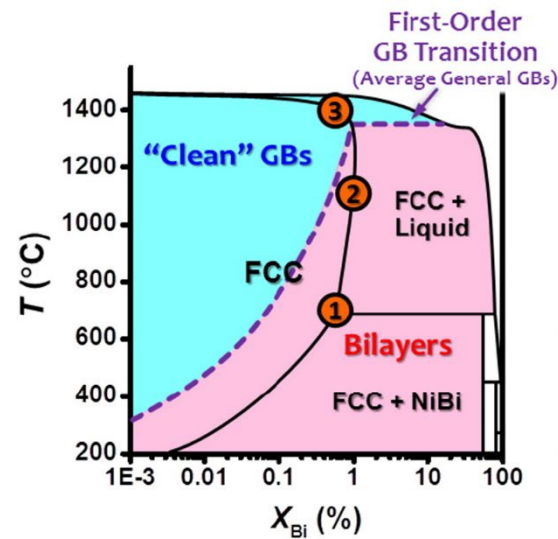


## Complexion Categories



# Solid solutions: Complexions

## Phase diagrams

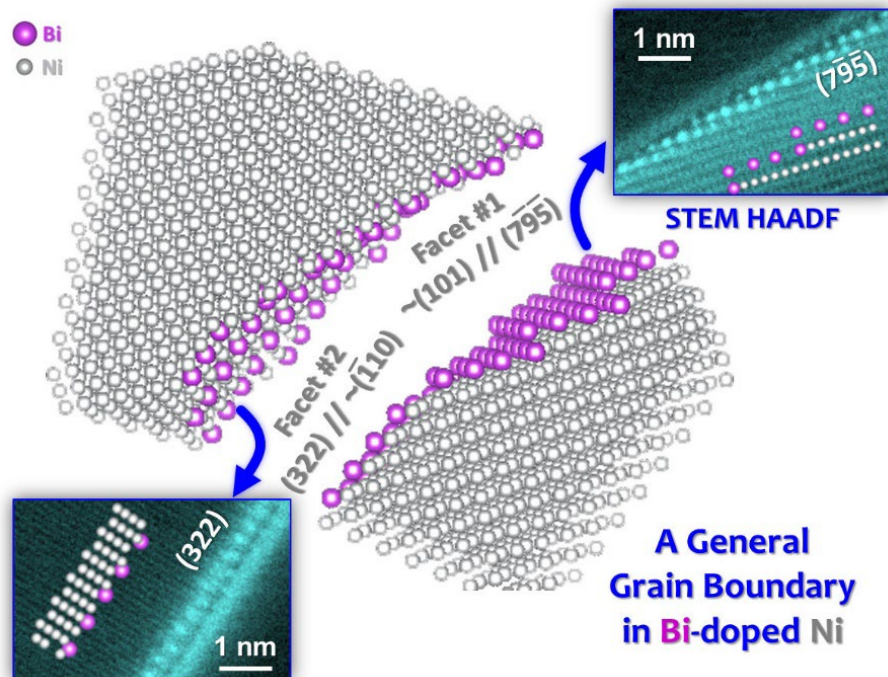




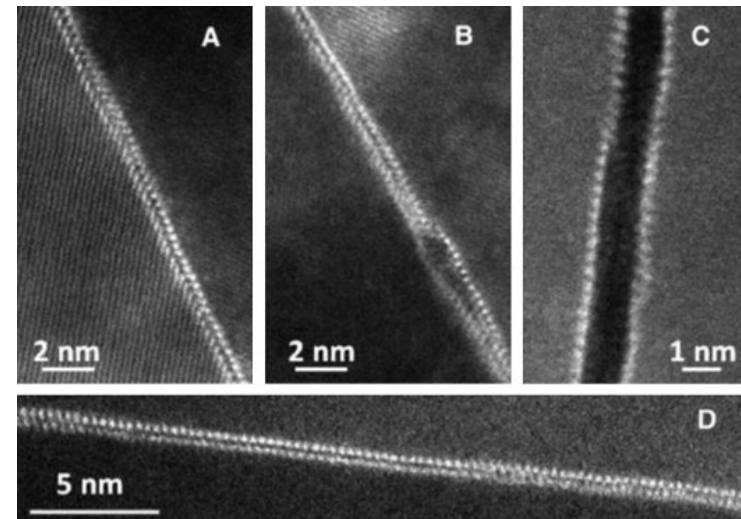
# Complexions: Mechanical effects

## Embrittlement...

- Ni-Bi



Ni-Bi alloy

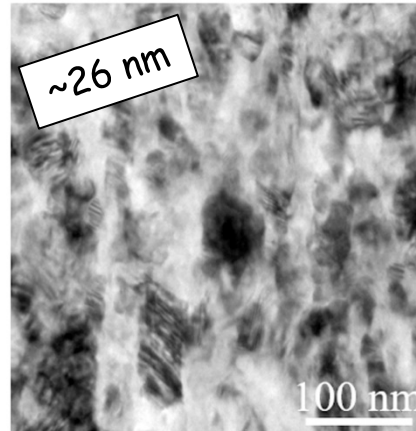


# Complexions in Nano-materials

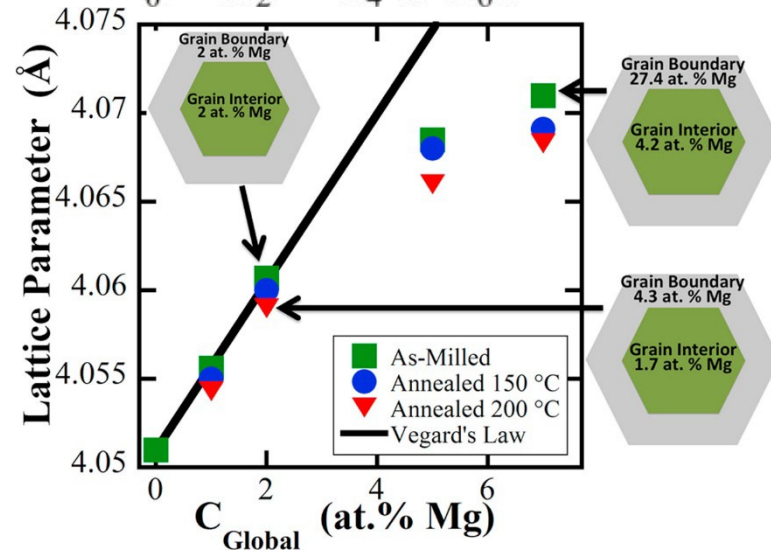
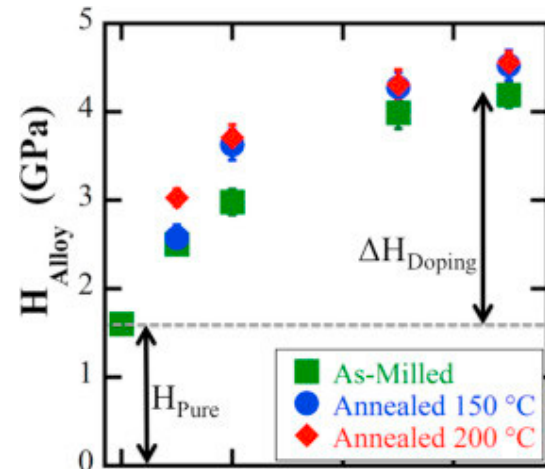
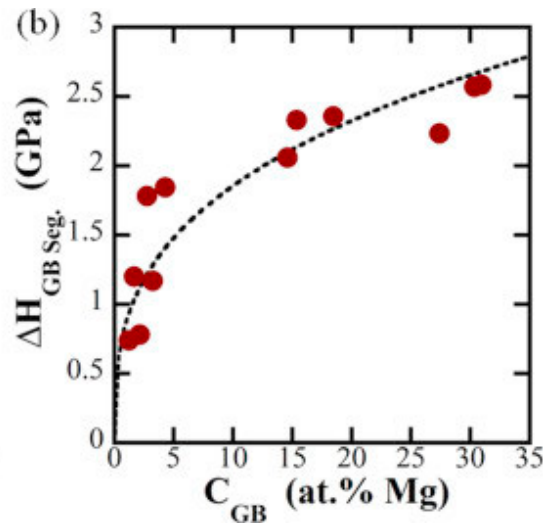
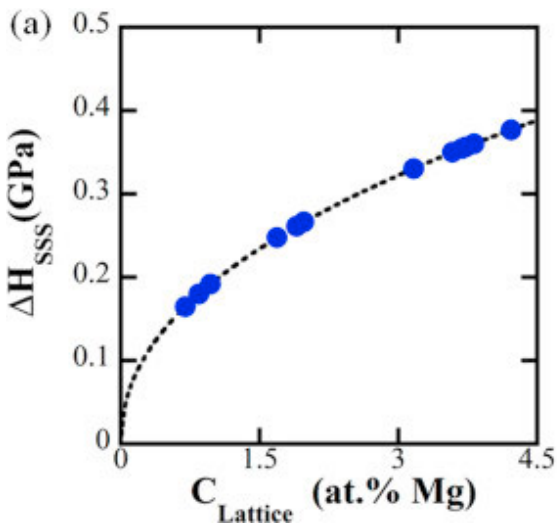
Strengthening:

- Grain refinement: nanocrystalline

(b) Al-7 at.% Mg, Annealed



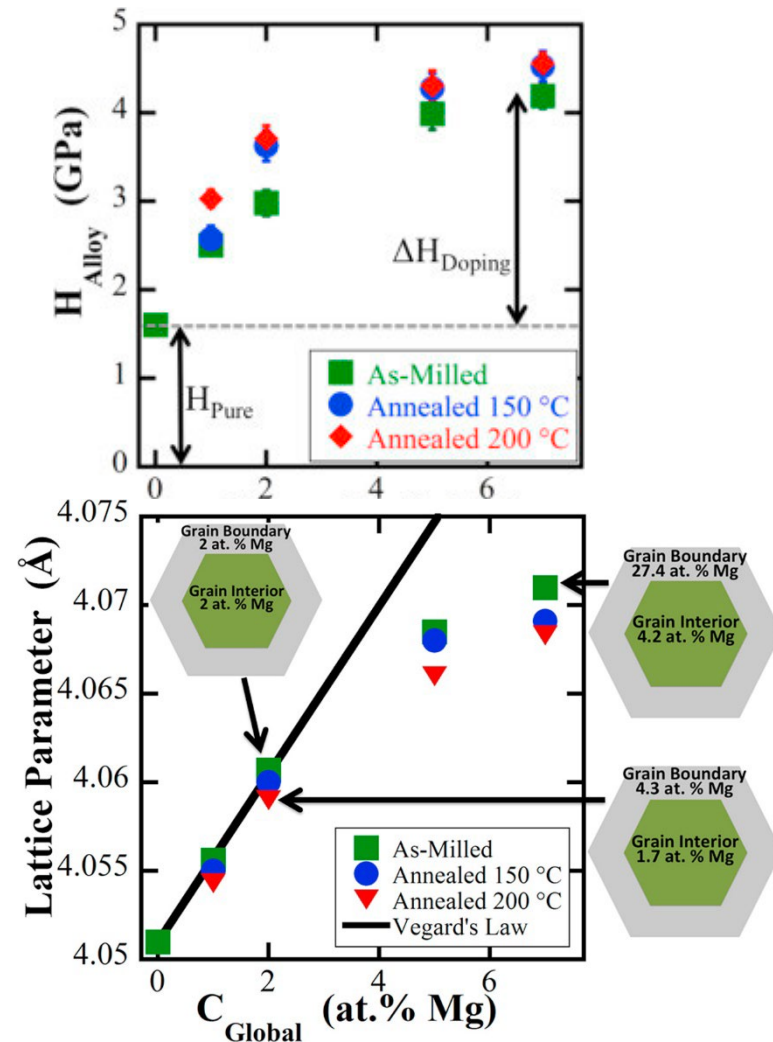
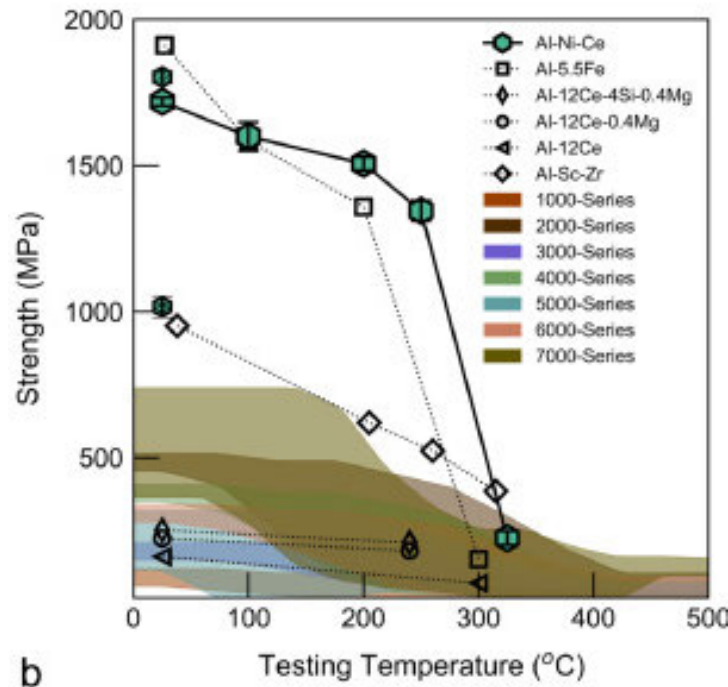
$$\tau_{ss} = \alpha E c^{1/2}$$



# Complexions in Nano-materials

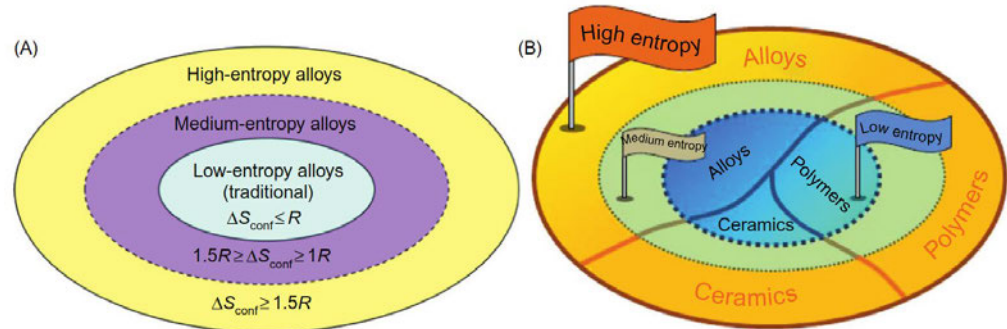
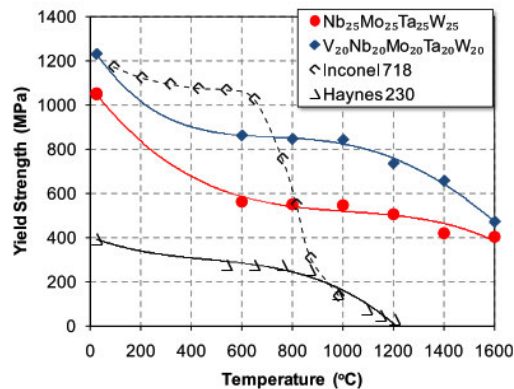
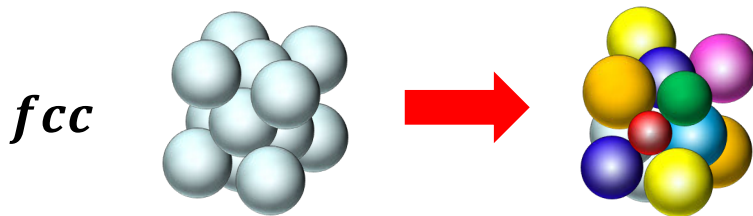
## Strengthening:

- Grain refinement: nanocrystalline
- High temperature strength through microstructural stability



# High entropy alloys

- 4 key effects:
  - Entropy stabilisation
  - **Severe lattice distortion**
  - **Sluggish diffusion**
  - **Cocktail synergies**



$$\Delta S_{mix} = -R \sum_{i=1}^n c_i \ln c_i$$

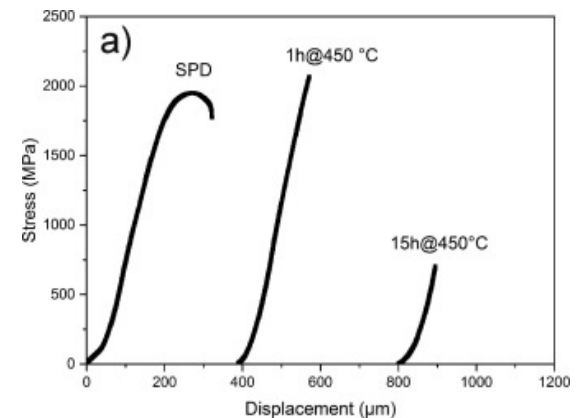
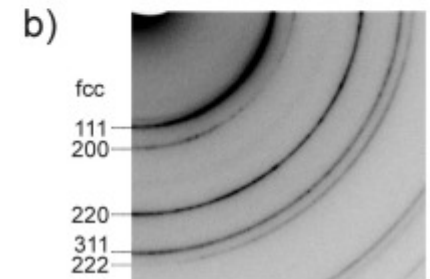
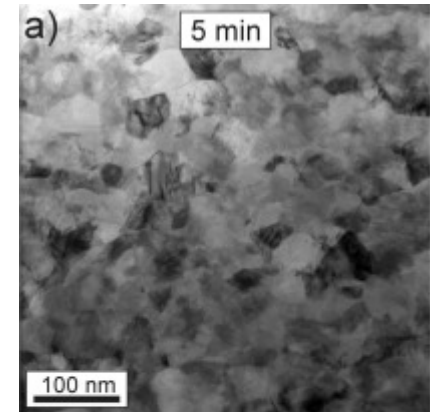
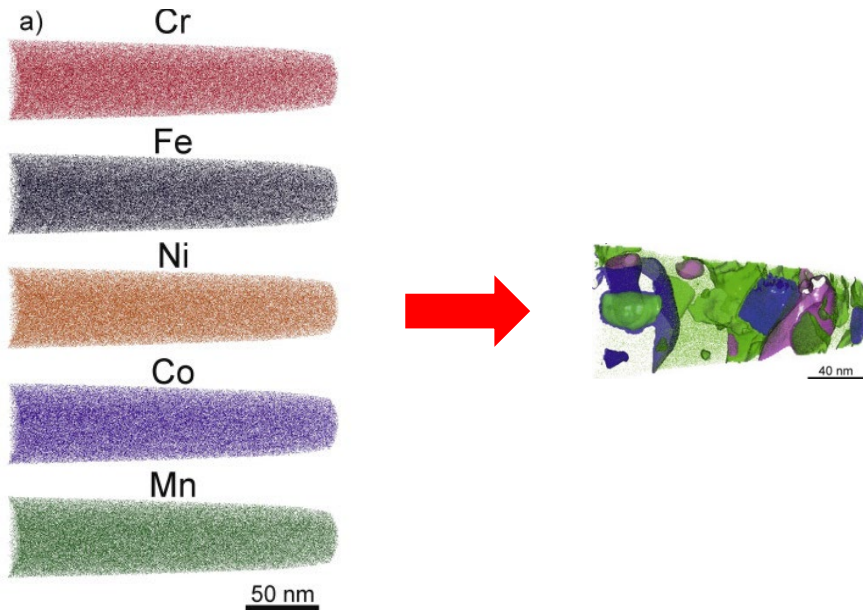
$$\Omega = \left| T_m \Delta S_{mix} / \Delta H_{mix} \right| \quad \Omega \geq 1.1$$

- magnitude of configurational entropy  $\Delta S_{mix} > 1.61R$
- more than 5 principal elements
- % of elements between 5% and 35%
- difference in atomic radii  $< 6.6\%$
- $\Delta H_{mix}$  between  $-10 \frac{\text{kJ}}{\text{mol}}$  and  $5 \frac{\text{kJ}}{\text{mol}}$



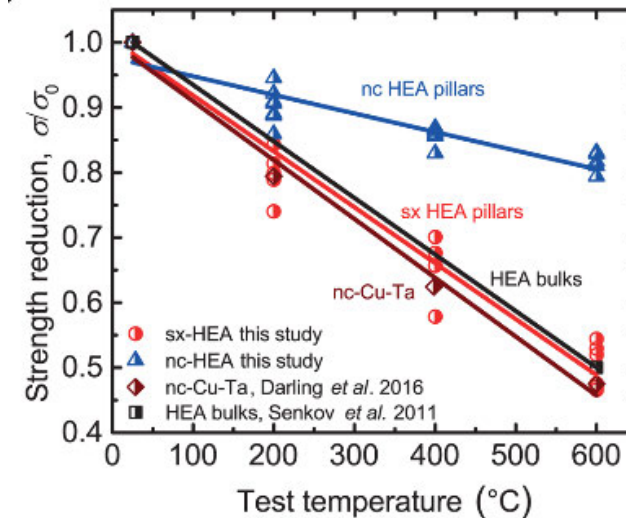
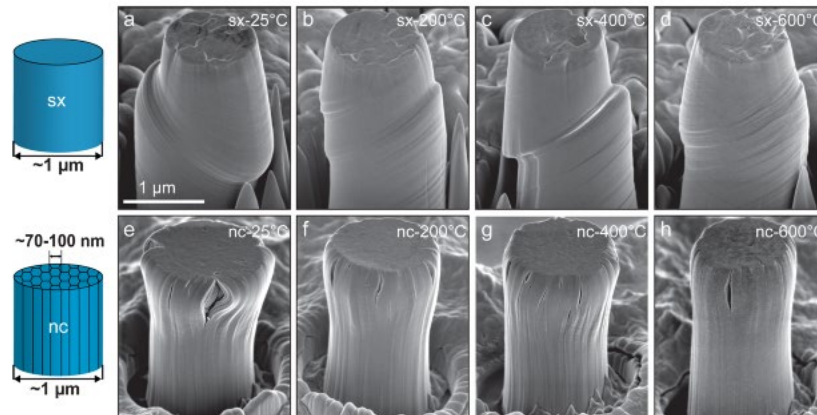
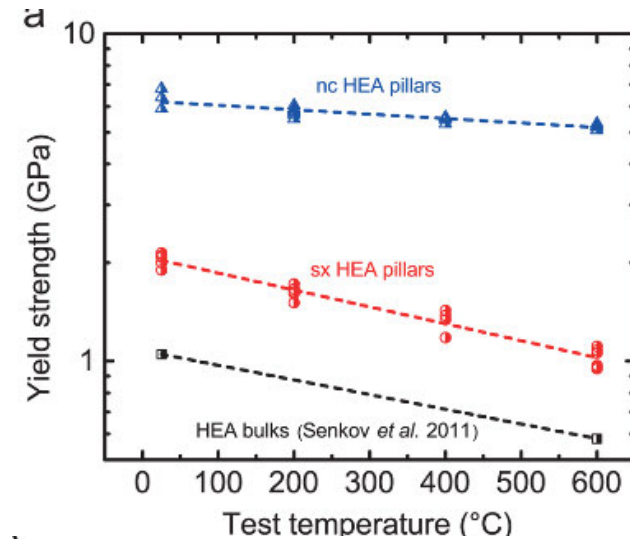
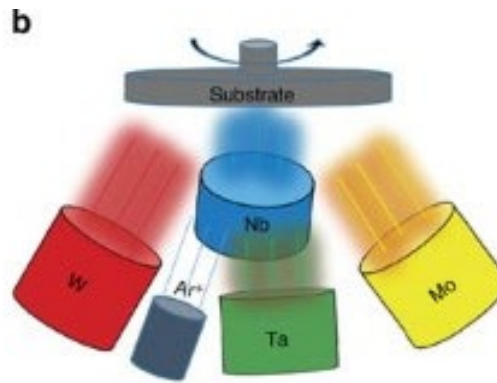
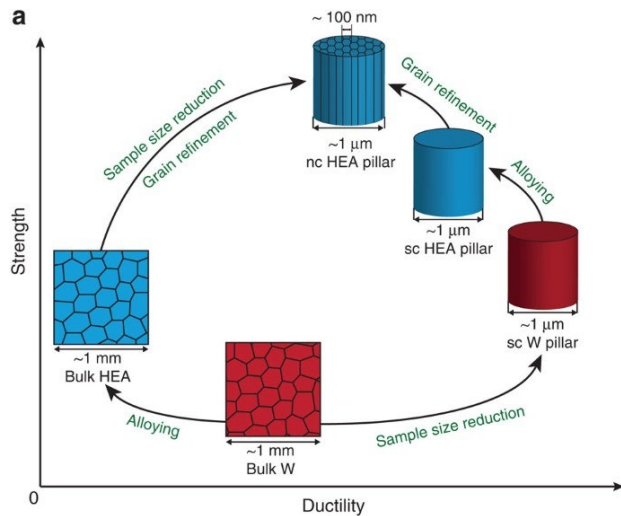
# High entropy nano-materials

- Mechanical alloying: milling powders + sinter
  - B.S. Murty & group:  
AlFeTiCrZnCu, CuNiCoZnAlTi,  
FeNiMnAlCrCo, and NiFeCrCoMnW
- High pressure torsion (HPT)
  - Cantor alloy: CrMnFeCoNi



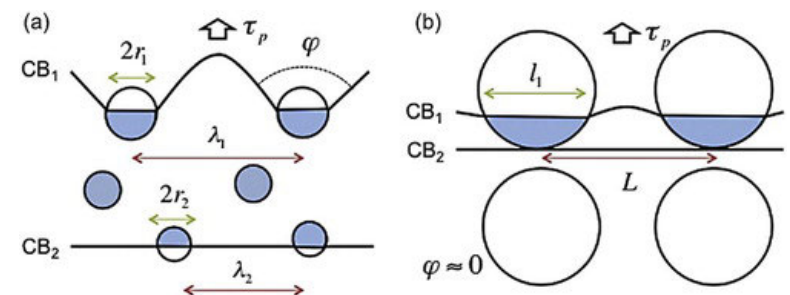
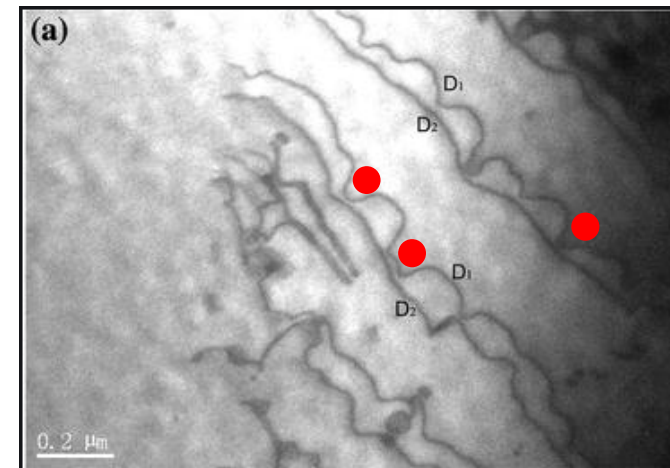
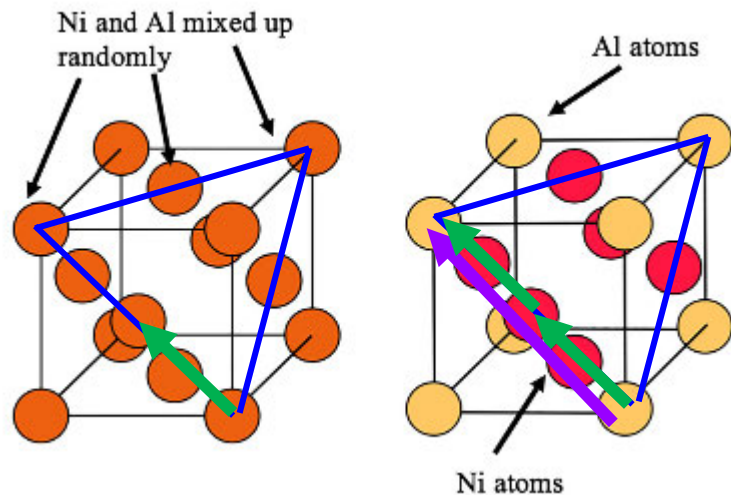
# High entropy nano-materials

- Nanocrystalline, e.g.  $\text{Nb}_{25}\text{Ta}_{25}\text{Mo}_{25}\text{W}_{25}$



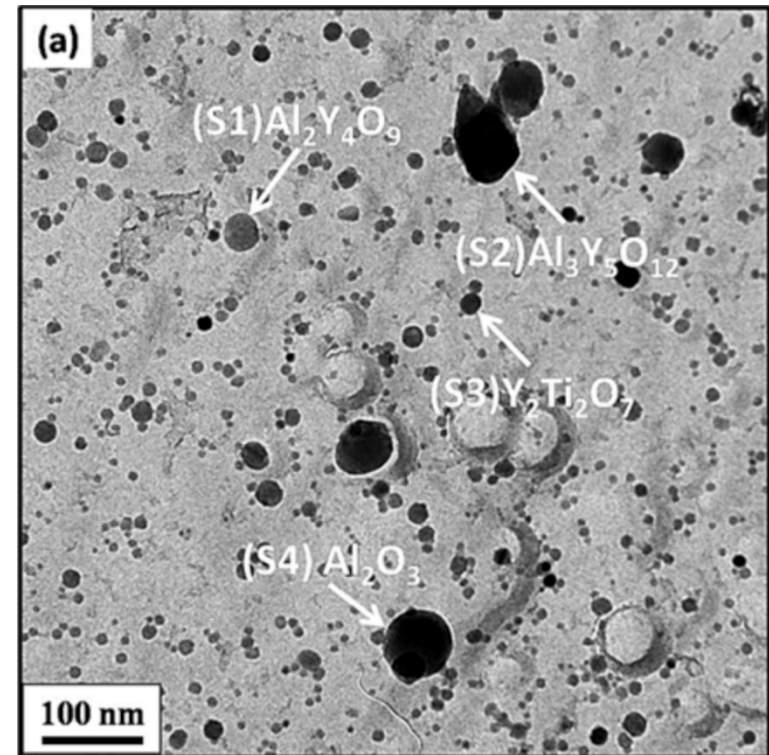
# Order strengthening

- Regular ordering in sub-lattices
- Relevant for:
  - Intermetallics: aluminides (FeAl, TiAl, Ni<sub>3</sub>Al...), silicides (Mo<sub>3</sub>Si...)
  - Salts
  - Ceramics (TiN: forbidden slip directions)
- Plasticity by super-dislocation motion



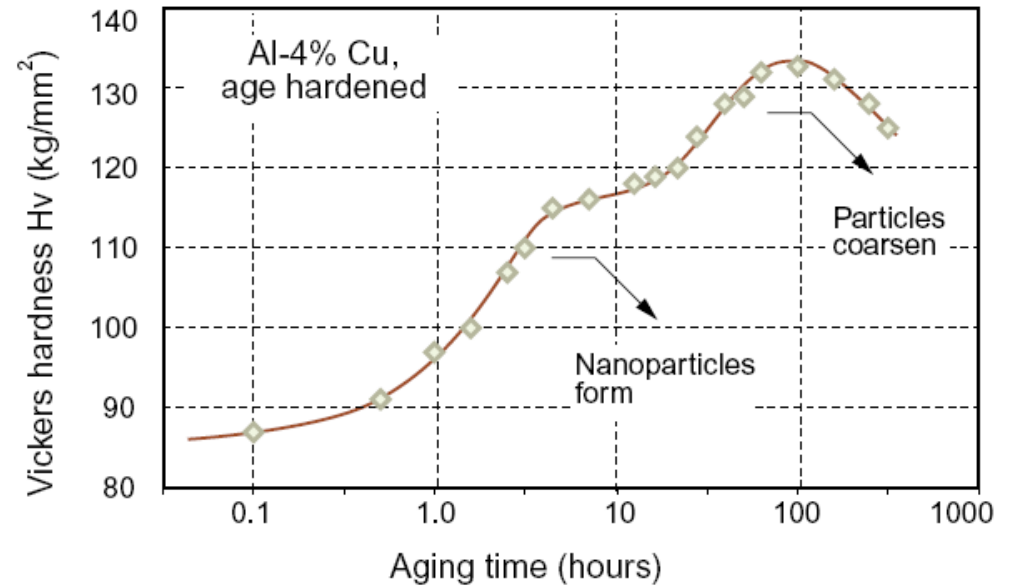
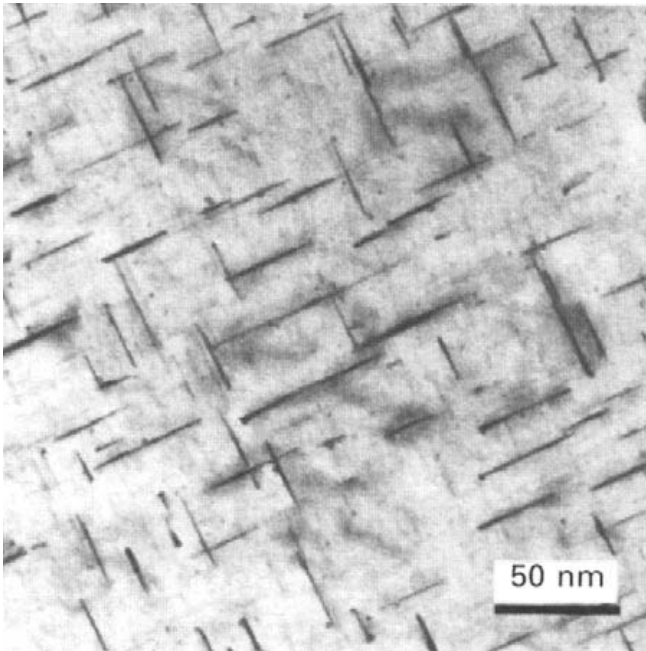
# Particle dispersion strengthening

- “Particle”:
  - Oxide: ODS;  $\text{Al}_2\text{O}_3$  &  $\text{Y}_2\text{O}_3$
  - Intermetallic
  - Metallic
- Sizes: few nm -> 100s nm
- Shapes: depend on formation
- Semi-coherent / incoherent
- Obtained by:
  - Segregation/internal reaction
  - Mechanical mixing
    - Alloy powders
    - Co-sputtering (Emese)

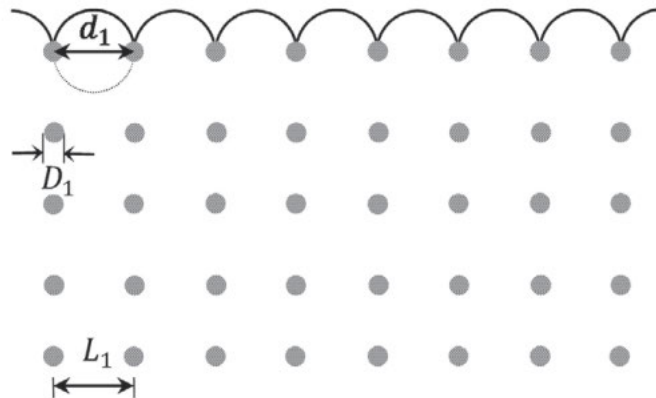




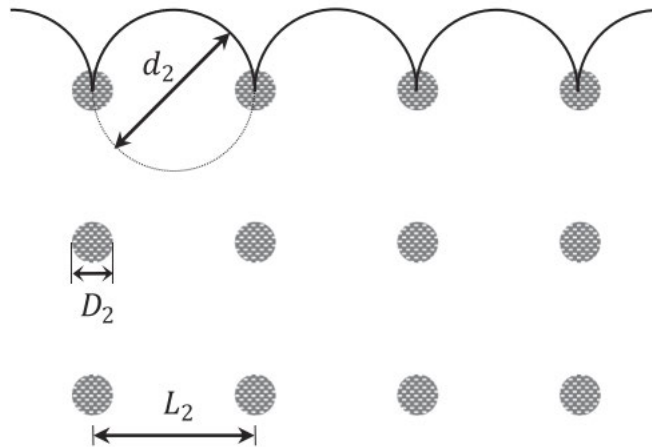
# Mechanical properties of nanodispersion



# Intrinsic size effect - precipitate size



(A) Small obstacle ( $D_1, L_1$ )



(B) Large obstacle ( $D_2, L_2$ )

For an array of hard objects with different diameters of  $D_1$  and  $D_2$  for a given volume fraction: The smaller hard objects ( $D_1 < D_2$ ) leads to the smaller obstacle spacing ( $L_1 < L_2$ ).

The dislocation loop bypasses the hard obstacle if the equilibrium diameter of the curved dislocation  $d$  is smaller than the obstacle spacing  $L$ .

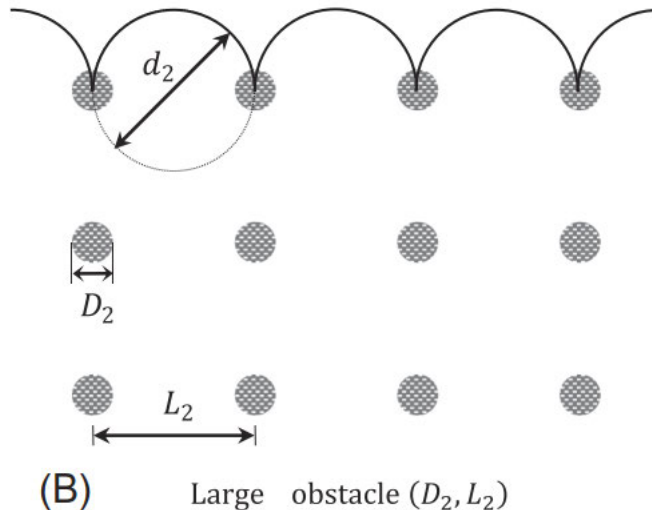
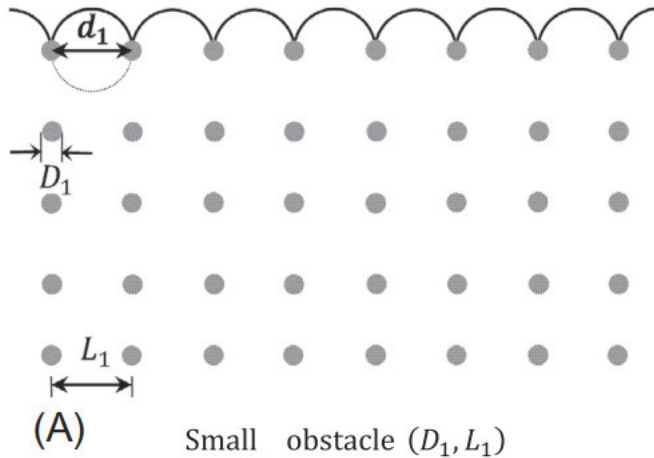
In other words, plastic deformation occurs through the elongation and multiplication of dislocation loops that can fit between two obstacles.

The equilibrium diameter of a dislocation for an elastic isotropic material can be described as follows:

$$d = \frac{2T}{b\tau} \approx \frac{Gb}{\tau}$$

where  $\tau$  is the shear stress,  $G$  is the shear modulus,  $b$  is the magnitude of Burgers vector, and  $T$  is the dislocation line tension, which can be simplified as  $T = Gb^2/2$ .

# Intrinsic size effect - precipitate size



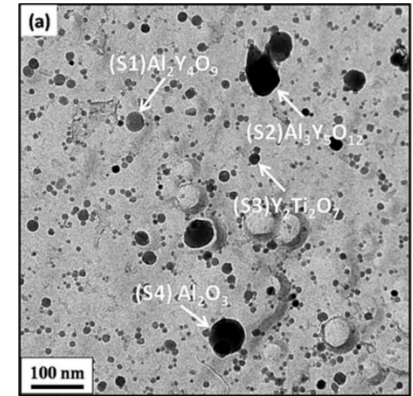
Now, the minimum shear stress to activate the dislocation source, i.e.  $d = L$ , can be calculated as follows:

$$\tau \approx \frac{Gb}{L}$$

accordingly, the sample with the smaller obstacle spacing  $L_1$  shows more strength compared to the one with the larger obstacle spacing  $L_2$

# Particle concentration and spacing?

- Measure vol. fraction,  $f$ , and number density,  $n$ 
  - By area: optical, SEM
  - By vol.: TEM: less straightforward
- Particle spacing,  $\chi$  (or  $L$ )
  - Cubic
  - Average spacing nearest-neighbours 3D (ideal gas)
  - Average spacing IN slip plane (2D)

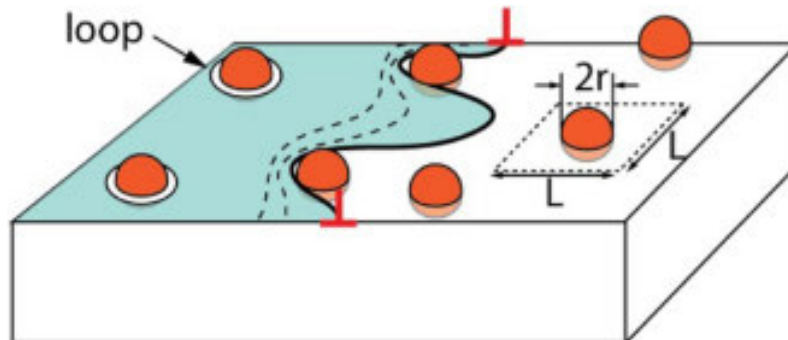


$$\chi_{cubic} = \left(\frac{1}{n}\right)^{1/3} - 2r$$

$$\chi_{3D} = 0.893 \left(\frac{3}{4\pi n}\right)^{1/3} - 2r$$

$$\chi_{2D} = (\sqrt{\pi/f} - 2)r_s$$

$$r_s = \sqrt{2/3} r$$





# The full story - particle strengthening

$$\tau \approx \frac{Gb}{L}$$

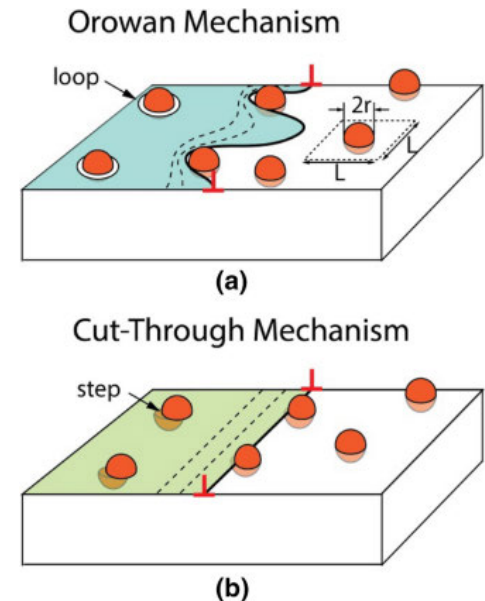
- Orowan bowing:

$$\Delta\tau_{\text{Oro}} = 0.4 \frac{Gb_p}{\pi\chi} \ln\left(\frac{2r_s}{b_p}\right) (1-\nu)^{-0.5}$$

$$\chi = (\sqrt{\pi/f} - 2)r_s \quad r_s = \sqrt{2/3}r$$

- Cutting (for semi-coherent particles):

$$\Delta\sigma_{\text{Cut}} = \sqrt{\frac{Gb_p G_W}{2C\chi}}$$

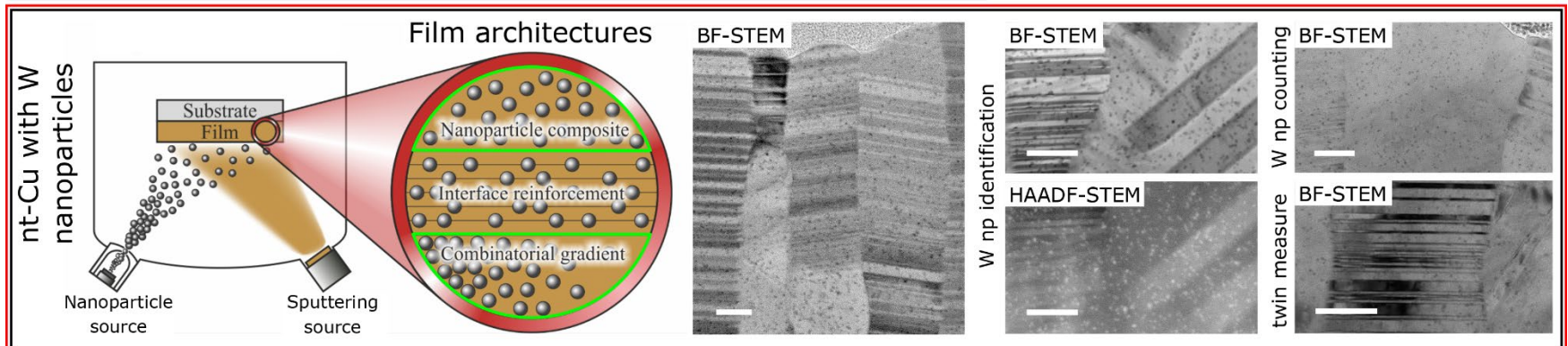
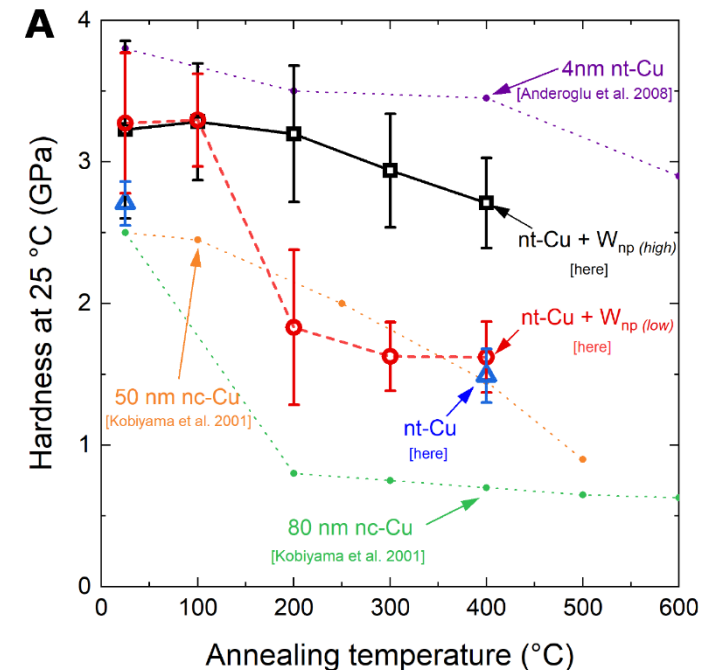


# Dispersion strengthening in Nano-materials

- Particle strengthening
- But mainly: microstructural stability
  - Zener pinning of boundaries
  - Nucleation sites for nanotwins?

Critical grain radius: 
$$R_c = \frac{K r}{f m}$$

$K = 0.17$  and  $m = 1$  for  $f < 0.05$



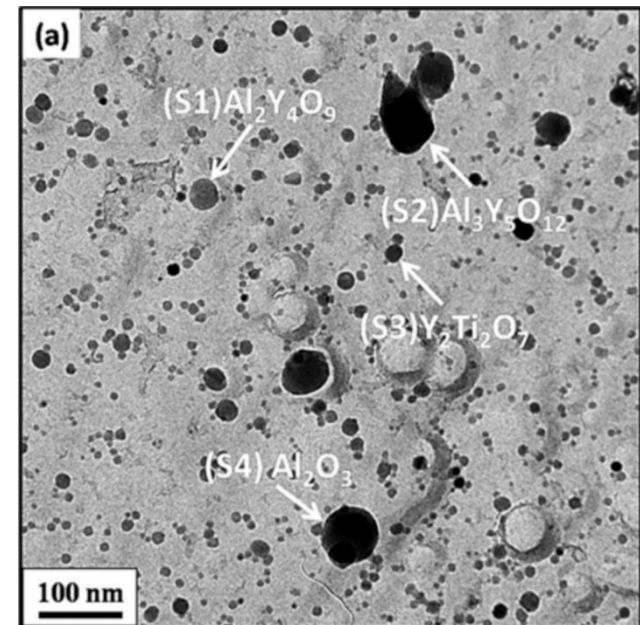
# Combining strength contributions

$$\sigma_Y = \left[ \sigma_0^i + \sigma_{HP}^i + \sigma_{Tay}^i + \sigma_{SSS}^i + \sigma_{Oro}^i + \sigma_{twin}^i + \sigma_{coh}^i + \sigma_{ord}^i \right]^{1/i}$$

(already converted from  $\sigma$  to  $\tau$  using Schmid factor)

e.g. ODS copper:

$$\sigma_Y = \sigma_0 + \sigma_{HP} + \sigma_{SSS} + \sqrt{\sigma_{Tay}^2 + \sigma_{Oro}^2}$$



---

# Size dependence of mechanical materials properties

## physical size effects

# Size effects ductile materials

---

**size effects** can be attributed to many different deformation and strengthening mechanisms.

They can be **originated** from

**internal characteristic length scales**, such as grain size

or

**external length scales**, such as the film thickness, pillar diameter, and indentation depth.

The size effects in crystalline metals are commonly categorized in two groups of

**intrinsic**, related to the internal characteristic length scales such as grain size and dislocations mean free path,

and

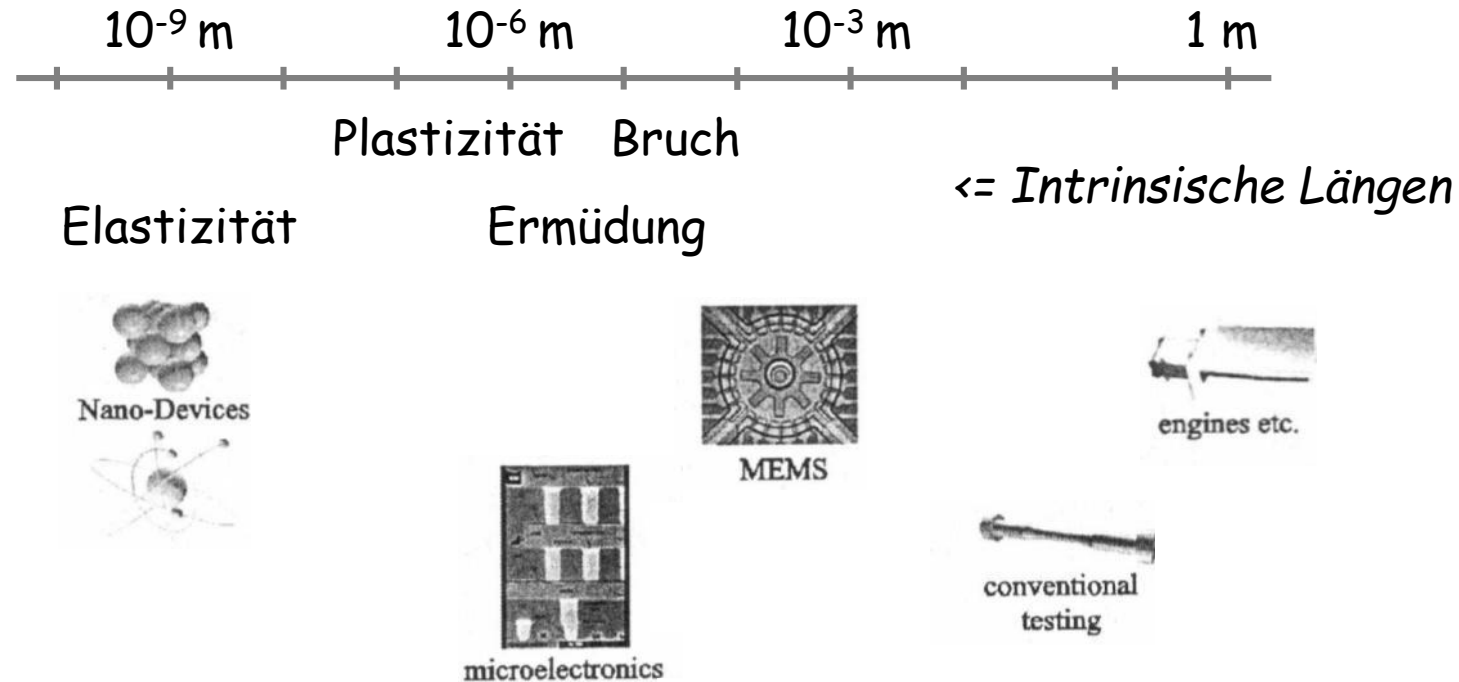
**extrinsic**, originated from an external length scale such as thin film thickness or pillar diameter.

G.Z. Voyiadjis and M. Yaghoobi. (2018) Size Effects in Plasticity: From Macro to Nano, Academic Press, Elsevier

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# Extrinsic size effects

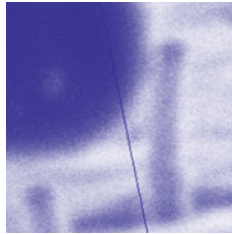
# Materialeigenschaften und Längenskalen



Objekt Dimensionen < Intrinsische Längen => Neue mech. Eigenschaften

# Size effects in materials: Swiss version

nanowires for solar cells / microelectronics



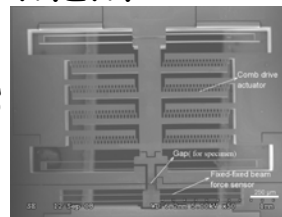
UV-LIGA watch part



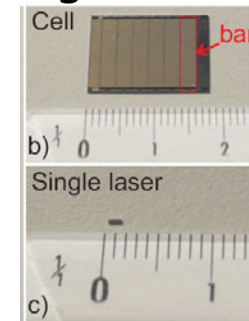
sawing of thin solar cells



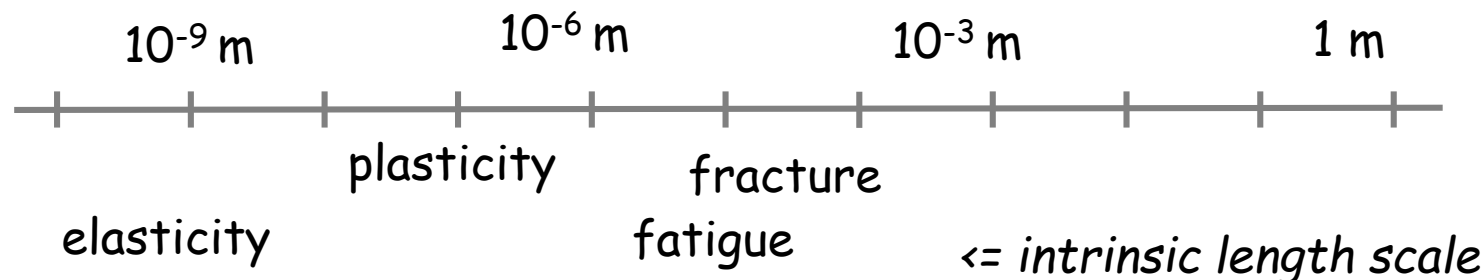
MEMS device



cleavage of laser bars



multilayer hard coatings





# Size effects in materials

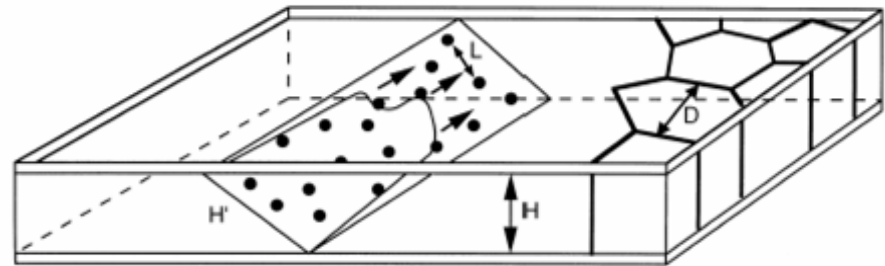
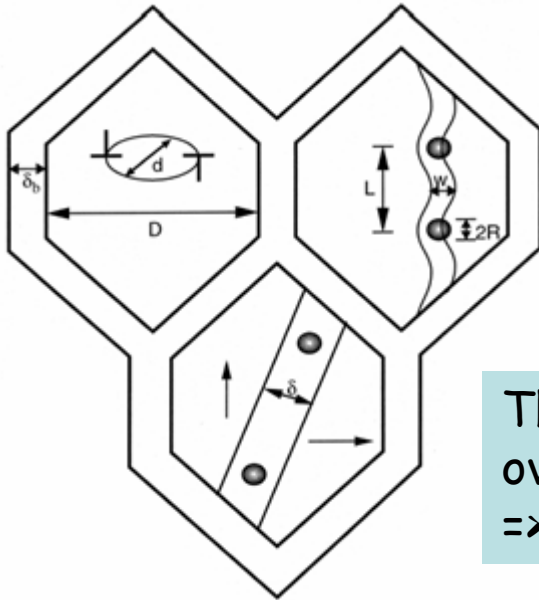
dimension of the physical phenomena involved  $\Rightarrow$  intrinsic length  
micro-structural dimension  $\Rightarrow$  size parameter

## Size Parameters:

Grain size  $D$ , Grain boundary width  $\delta_b$ , Obstacle spacing  $L$ , Obstacle radius  $R$ , Film thickness  $H$

## Characteristic lengths:

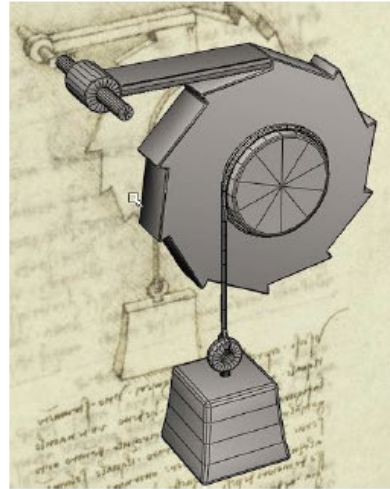
Equilibrium parameter of dislocation loop  $d$ , Spacing between partial dislocations  $w$ ,  
Width of magnetic domain wall  $d$



The range where characteristic lengths and size parameters overlap is of interest  
 $\Rightarrow$  conventional laws may break down

E. Arzt, Acta mater. 46(16), pp. 5611-5626, 1998

# Early studies of size effects



*da Vinci found that the shorter the wire...  
... the higher the fracture strength*

*Leonardo da Vinci, 1500s*

Observe what the weight was that broke the wire, and in what part the wire broke . . . Then shorten this wire, at first by half, and see how much more weight it supports; and then make it one quarter of its original **length**, and so on, making various lengths and noting the weight that breaks each one and the place in which it breaks.

# Early studies of size effects

*FINE METALLIC FILAMENTS*

## A METHOD OF DRAWING METALLIC FILAMENTS AND A DISCUSSION OF THEIR PROPERTIES AND USES

By G. F. TAYLOR

BUREAU OF PLANT INDUSTRY,  
U. S. DEPARTMENT OF AGRICULTURE,  
WASHINGTON, D. C.  
December 10, 1923.

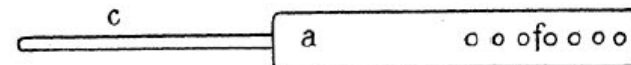


Fig. 1

The smaller sizes have greater tensile strength and the extremely small sizes, .002 cm and less, will stand indefinite bending.

-G.F. Taylor, *Phys. Rev.* 23, 655 - 660 (1924)

# Early studies of size effects

JOURNAL OF APPLIED PHYSICS

VOLUME 27, NUMBER 12

DECEMBER, 1956

## Tensile Strength of Whiskers

S. S. BRENNER

*General Electric Research Laboratory, Schenectady, New York*

(Received June 2, 1956)

Tensile tests have been performed on whiskers of iron, copper, and silver 1.2 to 15  $\mu$  in diameter. The strongest whiskers which were less than 4  $\mu$  in diameter exhibited resolved elastic shear strengths of from two to six percent of their shear moduli. Stress-strain determinations on iron have shown that large deviations from Hooke's law occur beyond two percent strain. As the whiskers increase in size, their strengths decrease with considerable scatter.

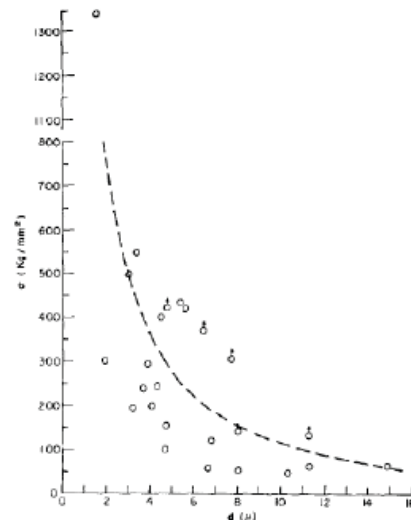


FIG. 6. The effect of size on the strength of iron whiskers.  $\phi$  fracture occurred at or near grips. True fracture stress may have been higher.

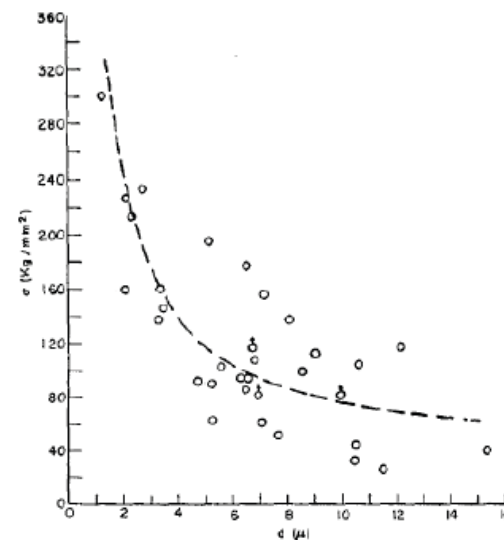
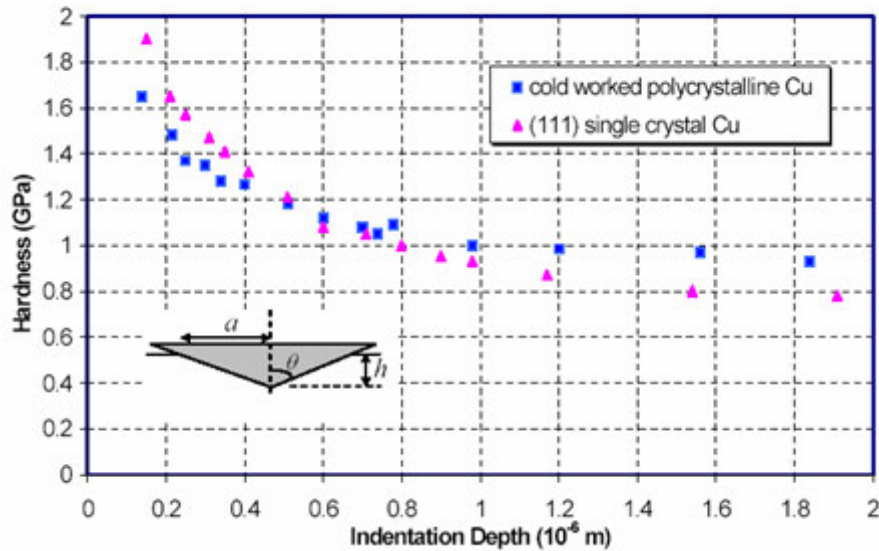
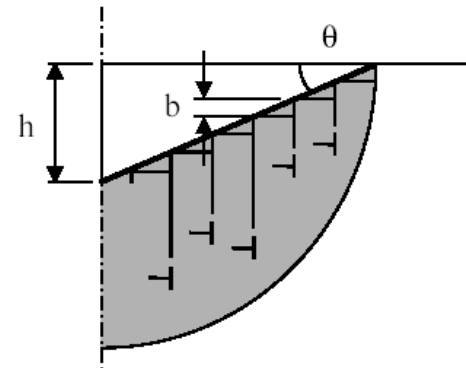


FIG. 7. The effect of size on the strength of copper whiskers.

# Hardness testing: scale effects



Explanation:

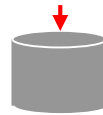


Stress concentration at tip leads to higher dislocation density, which leads at low penetration depth to higher hardness

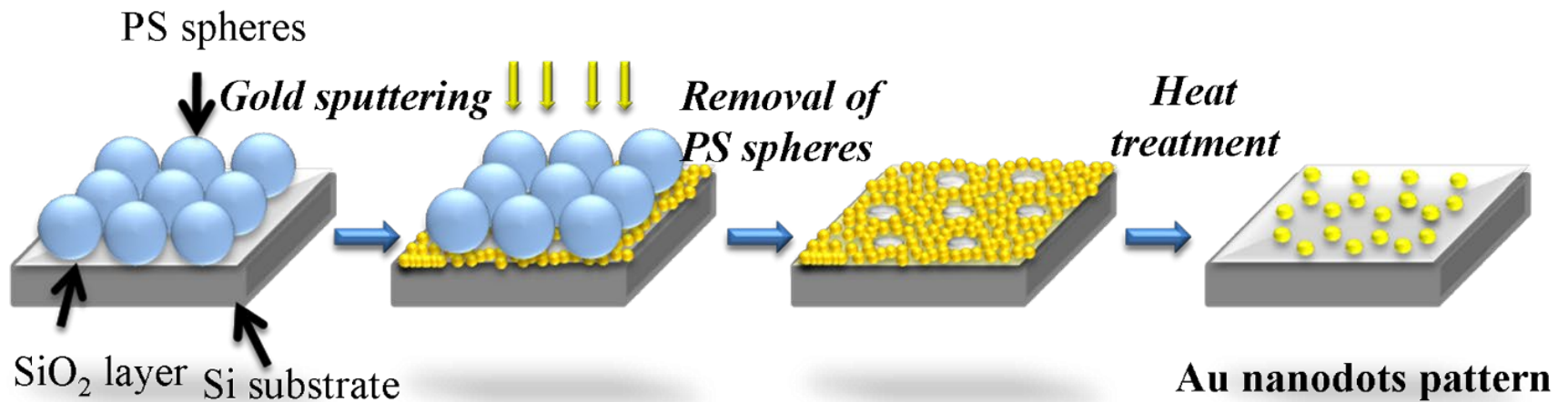
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# strain bursts - gold dots in compression

$E, \sigma_y, n, \sigma_f$



# ordered arrays of gold dots

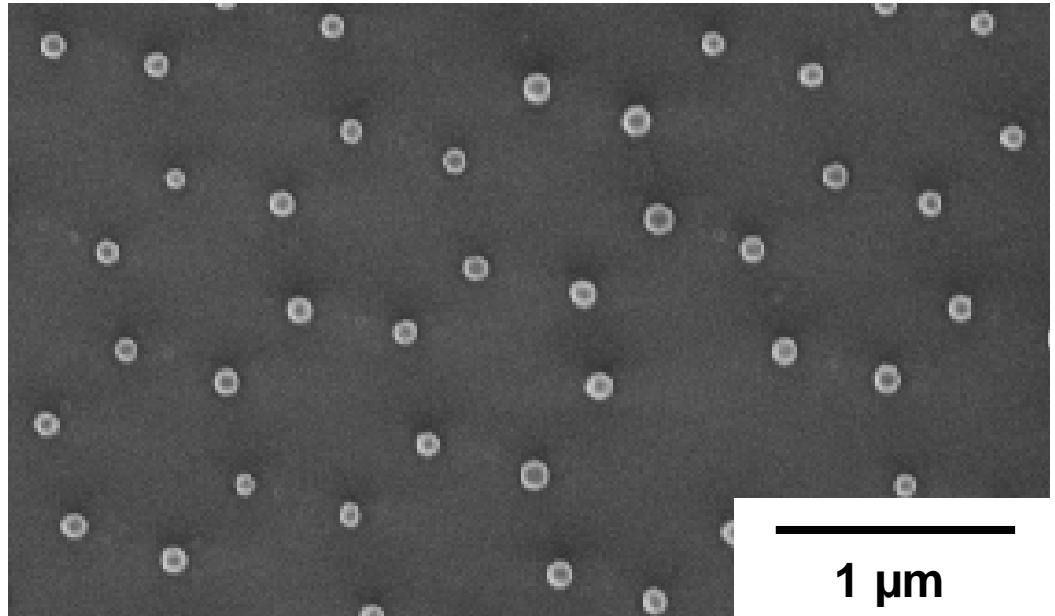




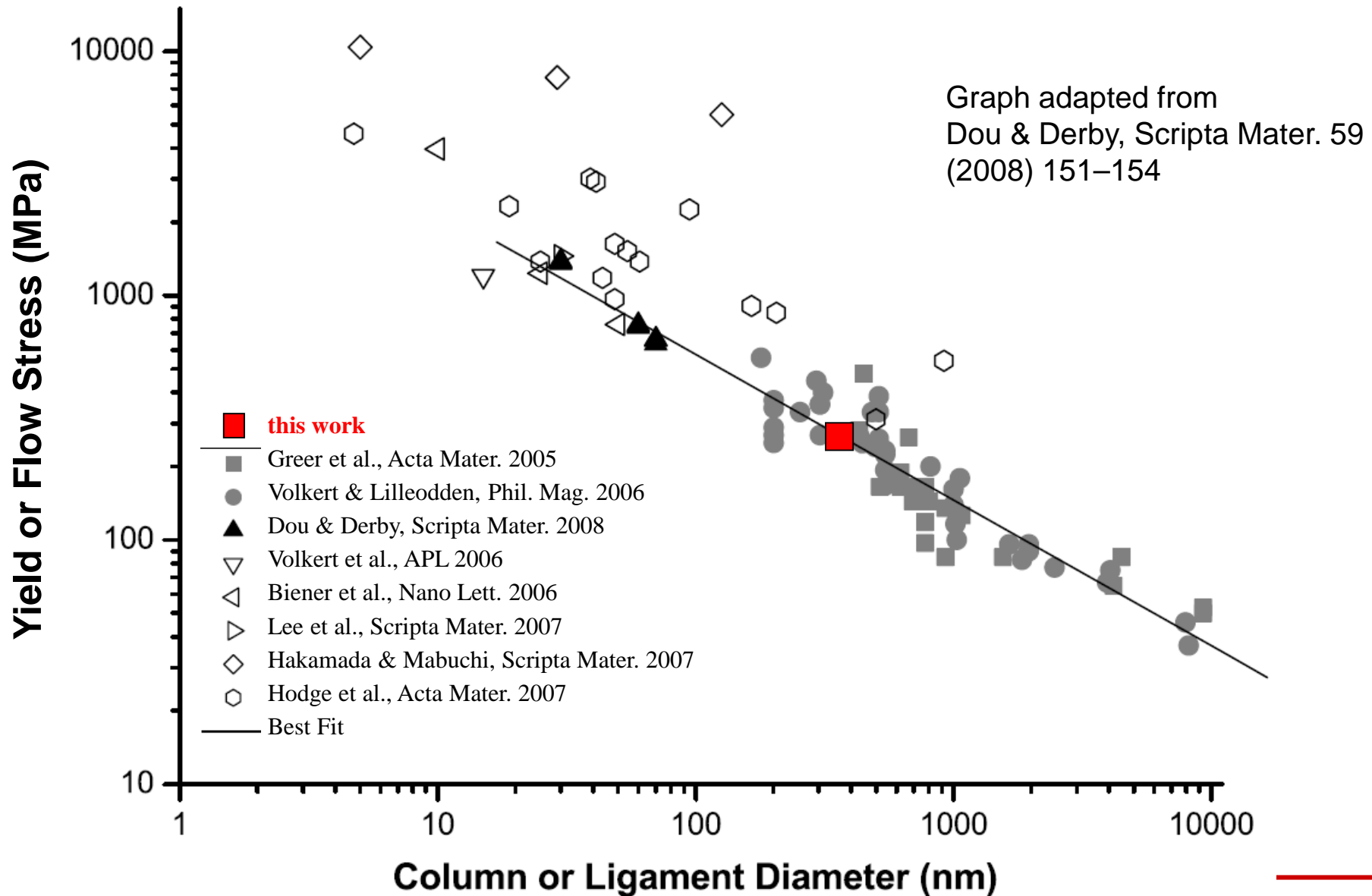
# ordered arrays of gold dots

---

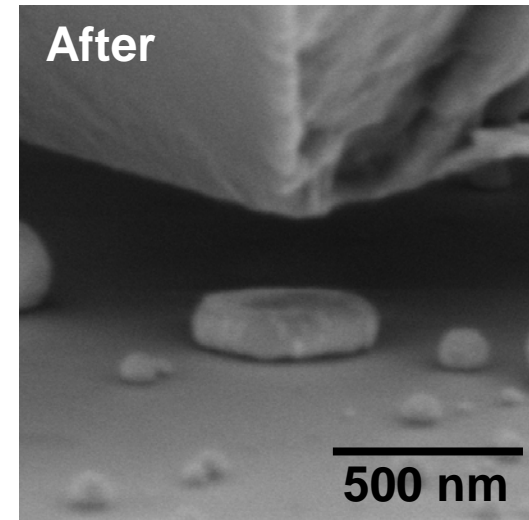
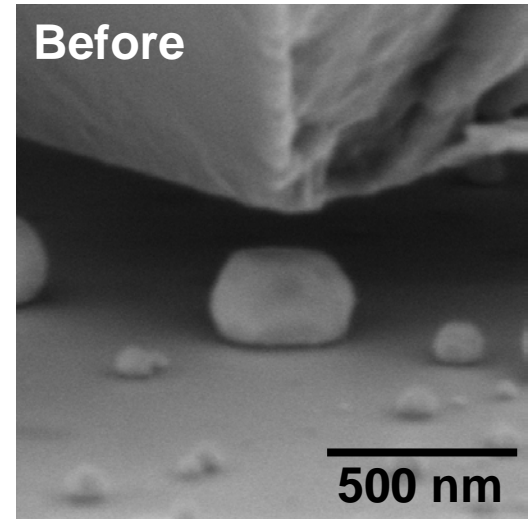
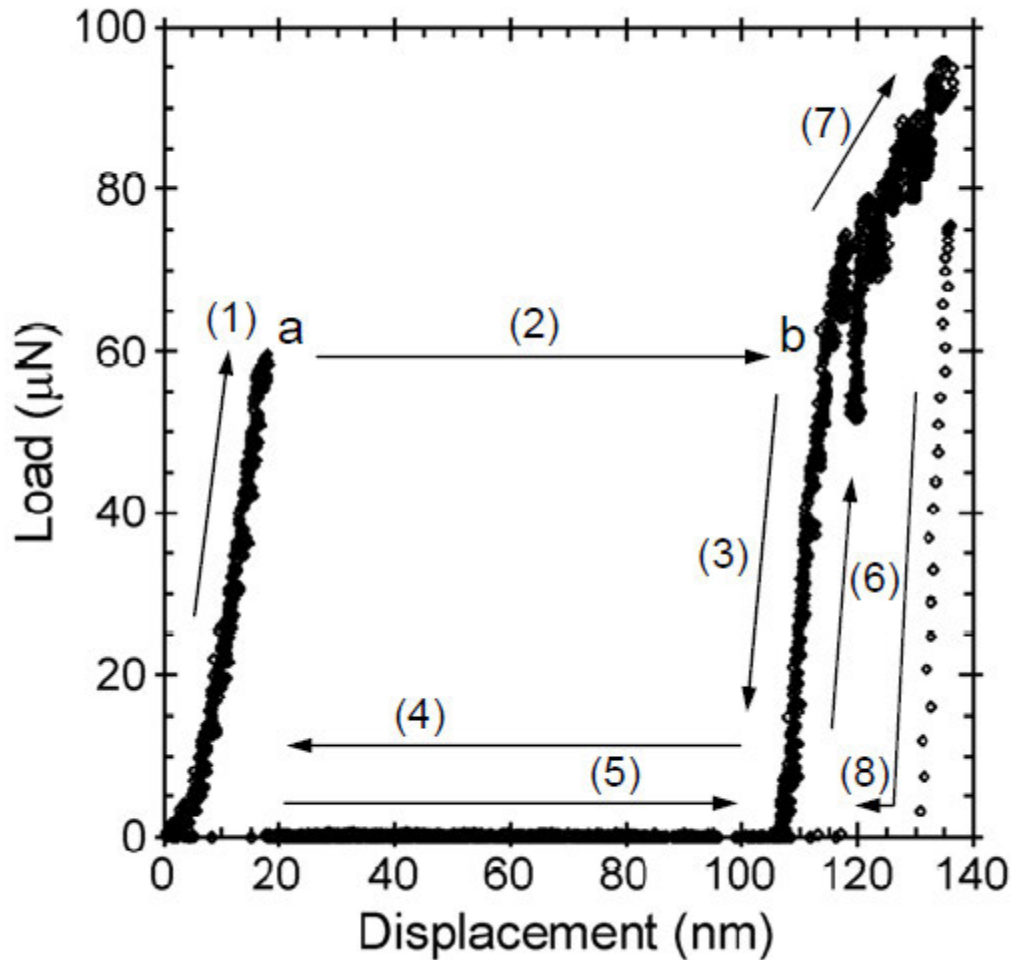
Fabrication steps:  
Colloidal templating  
Au PVD  
annealing at 1000°C/1h



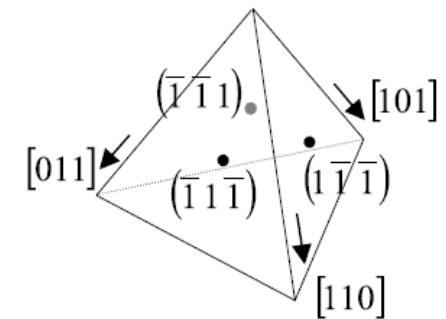
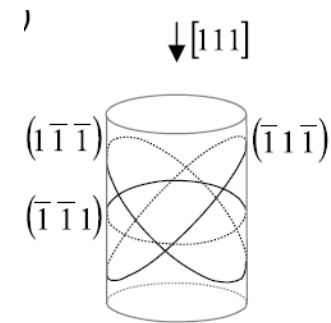
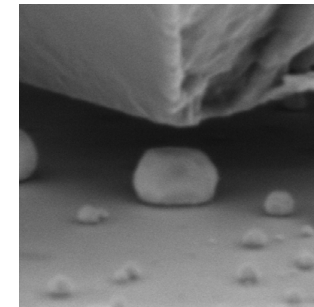
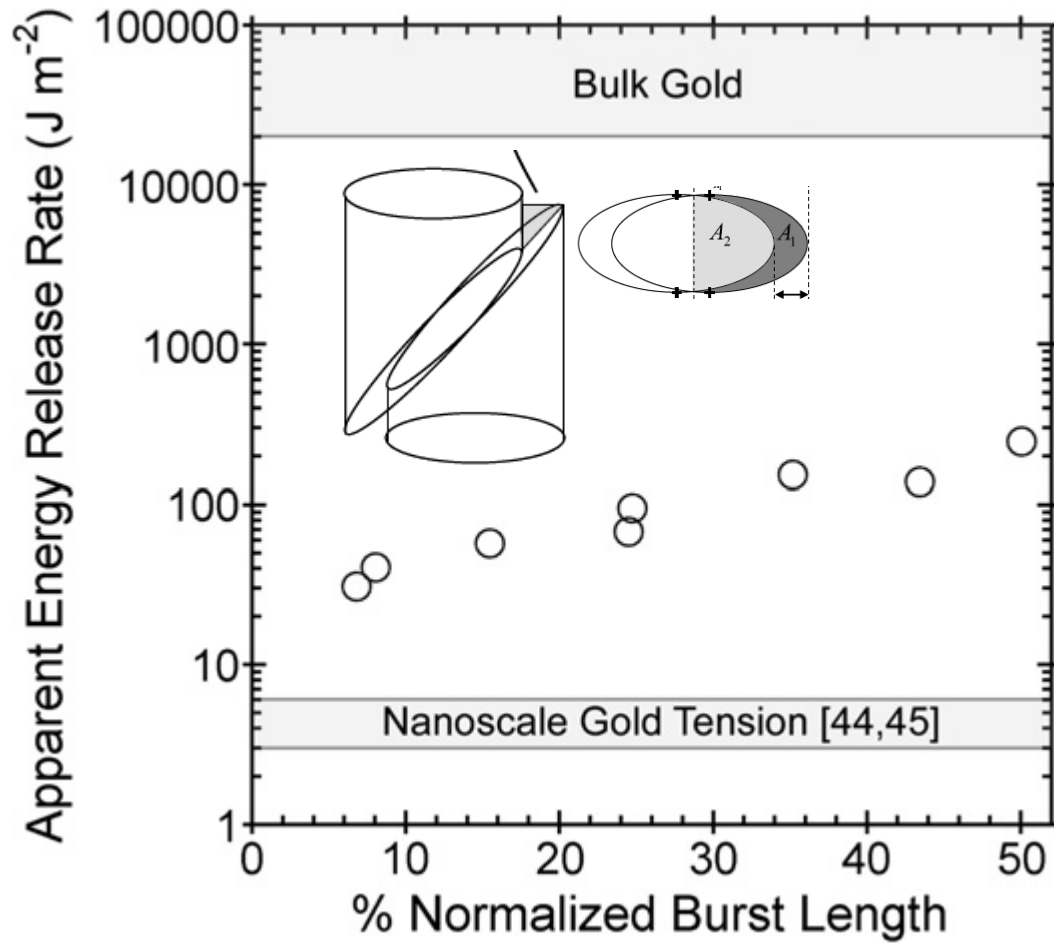
# yield or flow stress of gold pillars and wires



# yield or flow stress of gold pillars and wires



# yield or flow stress of gold pillars and wires



# Extrinsic size effect - thin films

The thin film yield occurs by the motion of dislocations which are constrained to move inside the thin film.

For an impenetrable film surface (A) the yield occurs when a dislocation loop can fit inside the thin film:

$$d(\tau) = H'$$

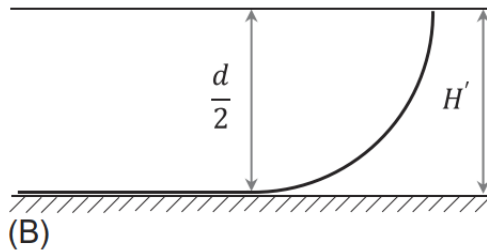
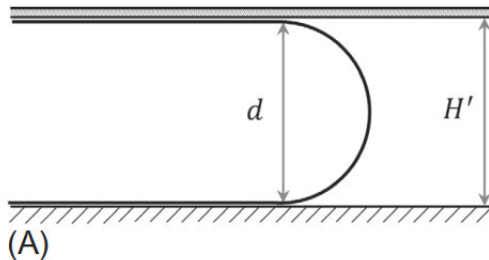
where  $d(\tau)$  is the equilibrium diameter of a dislocation loop for an elastic isotropic material.

$H' = H / \sin(\phi)$  is the size variable, where  $\phi$  is the angle between thin film normal and that of the dislocation loop plane. Accordingly, the yield stress can be described as follows:

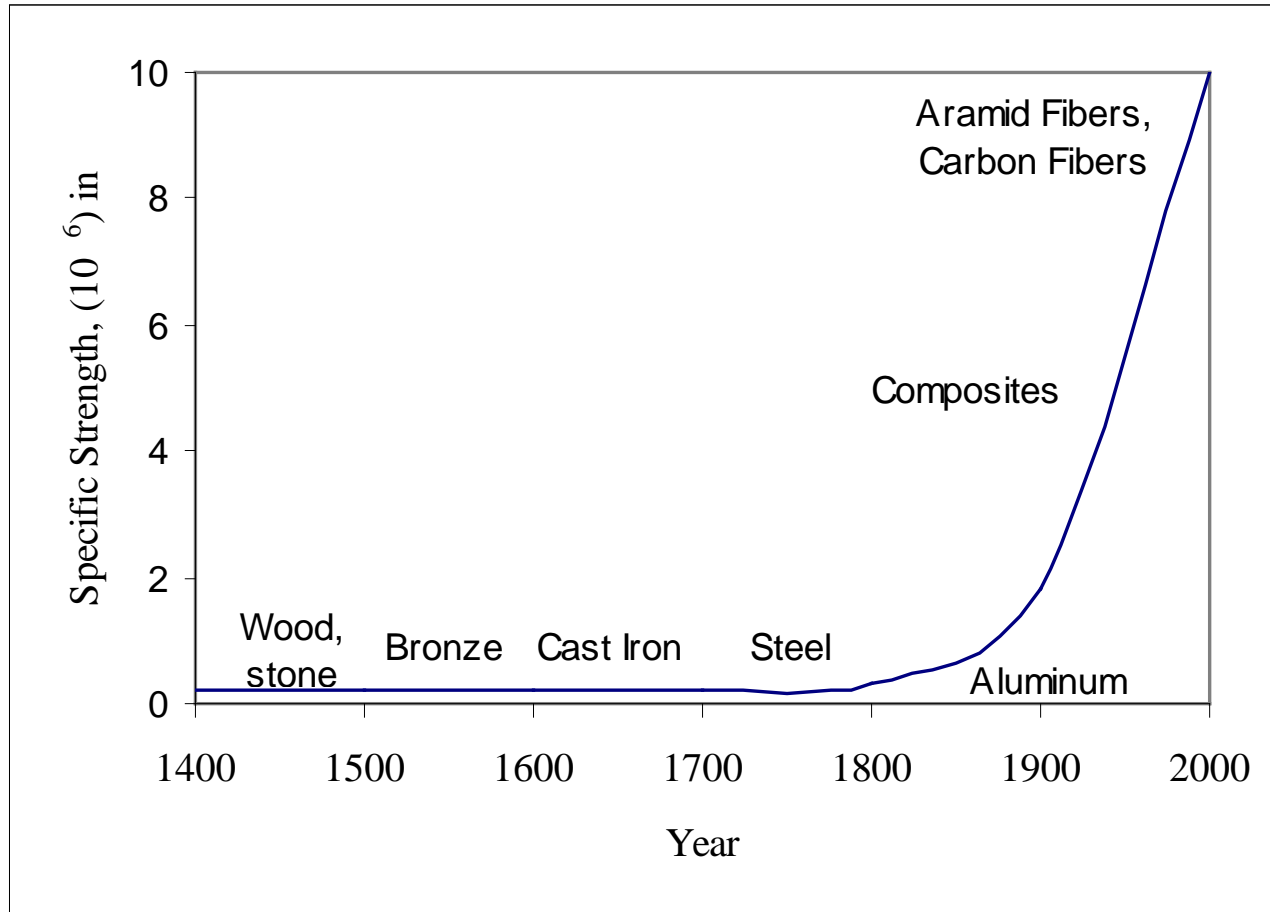
$$\tau = \frac{G_f b}{H'}$$

where  $G_f$  is the thin film shear modulus.

In the case of free film surface (B), the surface induces image forces the yield stress occurs when half of the dislocation loop fits inside the thin film.



# Composite mechanics



# Composite mechanics

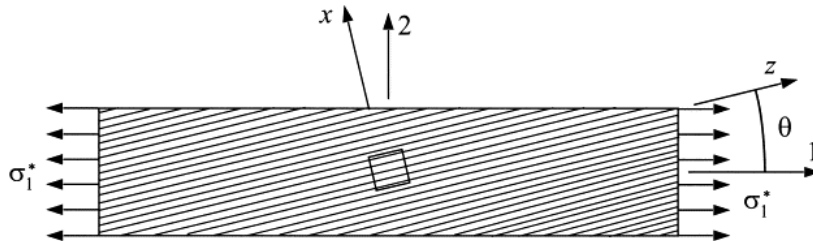
- Tailored stiffness

$$E_{//} = v_f E_f + v_m E_m$$

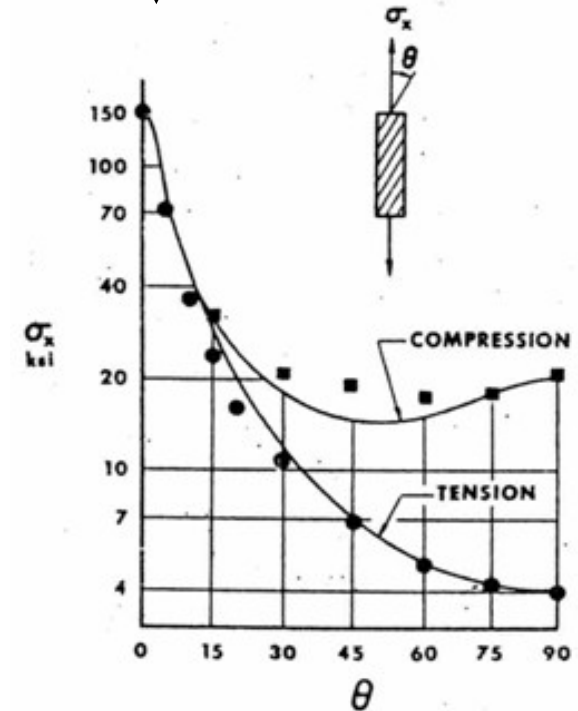
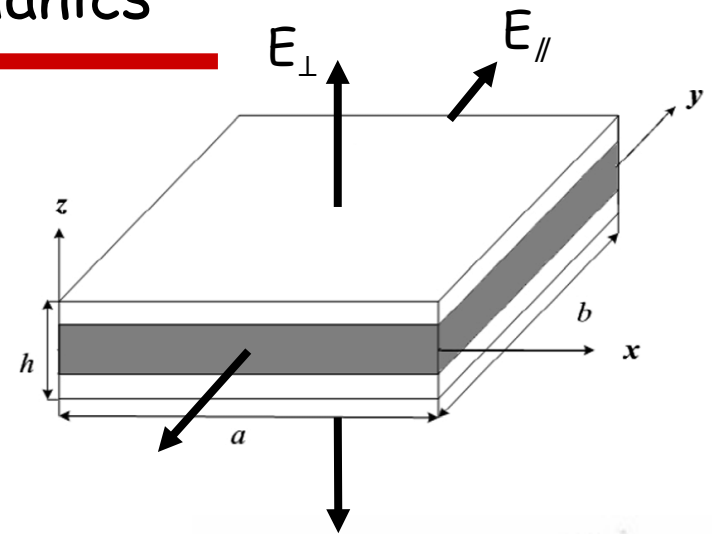
$$E_{\perp} = \frac{E_f E_m}{v_f E_m + v_m E_f}$$

- Tailored strength: Tsai Hill failure criterion

$$\left[ \frac{\sigma_1}{(\sigma_1^T)_{ult}} \right]^2 - \left[ \frac{\sigma_1 \sigma_2}{(\sigma_1^T)_{ult}^2} \right] + \left[ \frac{\sigma_2}{(\sigma_2^T)_{ult}} \right]^2 + \left[ \frac{\tau_{12}}{(\tau_{12})_{ult}} \right]^2 < 1$$



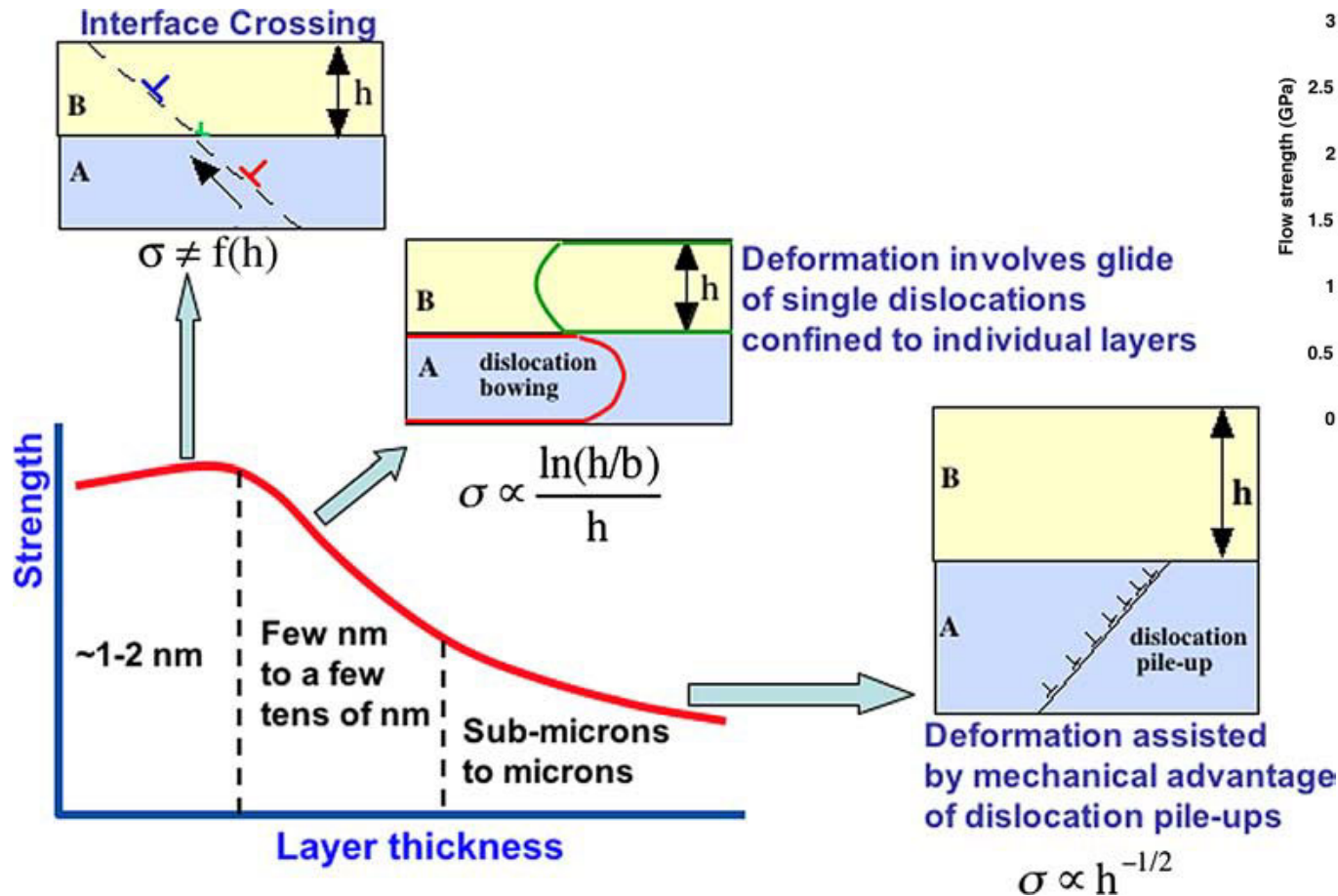
- Classically, brittle failure of strong phase:
  - Fibre pullout, ...



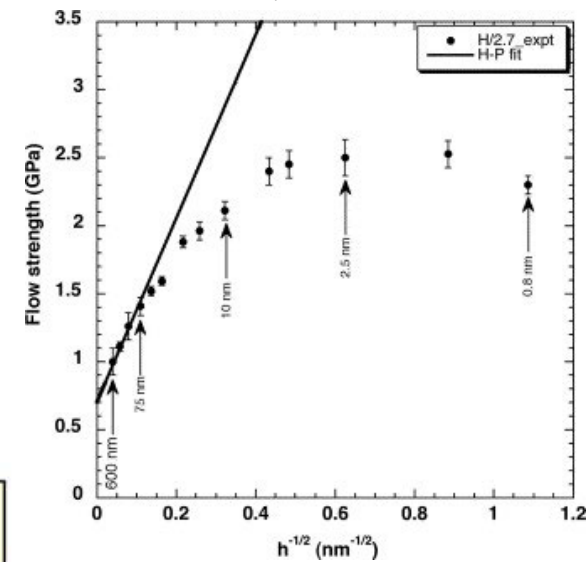


# Plasticity of multilayers - mechanisms

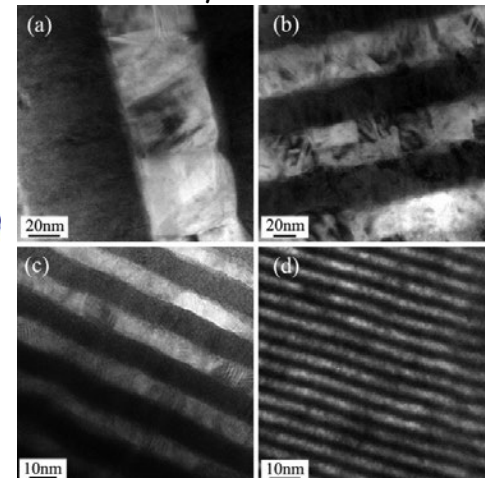
“Incoherent metallic multilayered composites”!



Cu-Nb multilayers



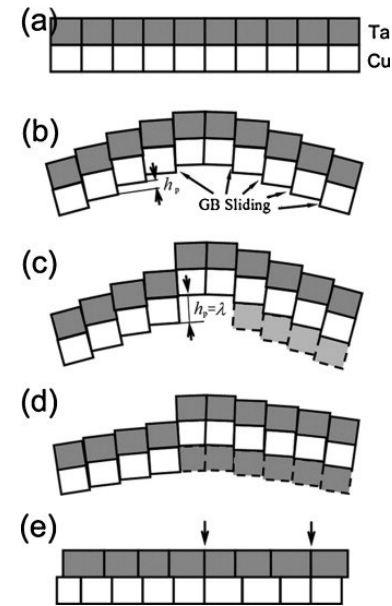
Cu-Ta multilayer



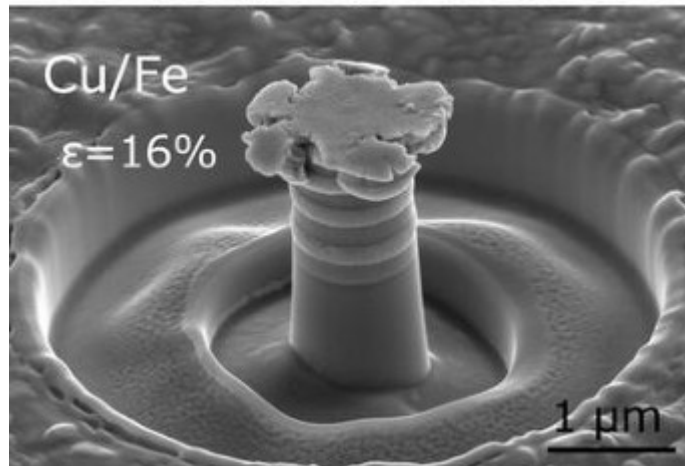
(A. Misra, R.G. Hoagland, J.P. Hirth, Acta Mater., (2005))

# Plasticity of multilayers - mechanisms

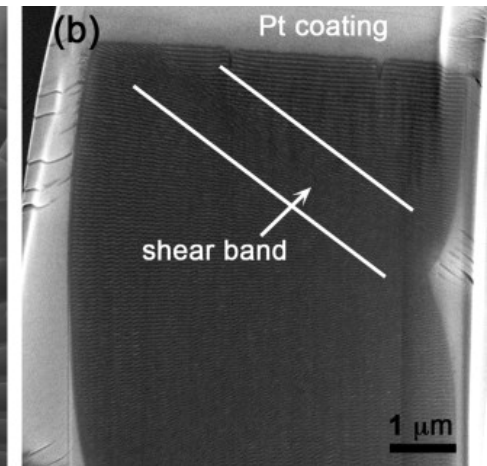
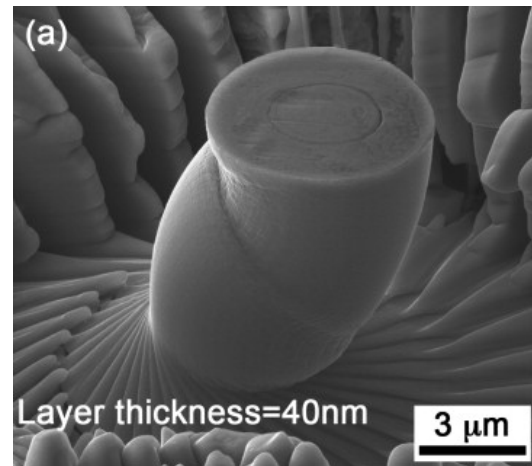
- Bulging/extrusion of softer phase
- Shear banding: thinner layers
  - Shear by slip perpendicular to layers
  - Or interfacial sliding of incoherent boundaries?



200 nm layers

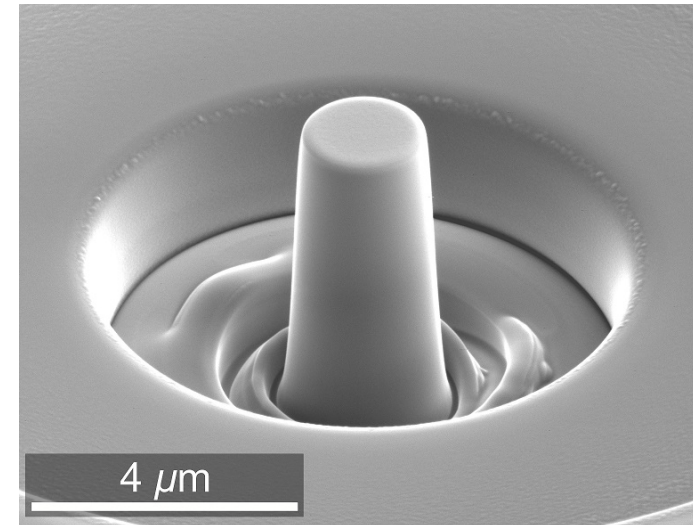


40 nm layers

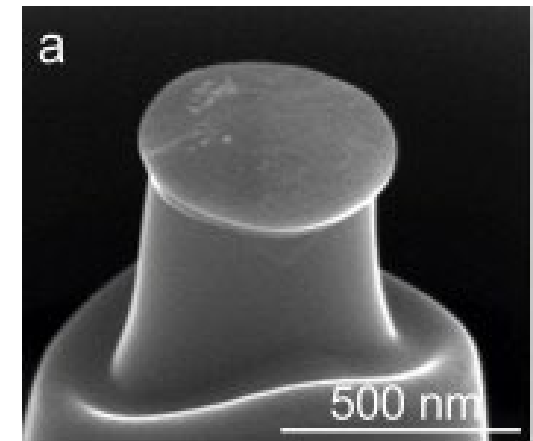


# Micropillars, but... why?

- **Micro-compression, -tensile, -cantilever**
- Small volumes:  
achieve plasticity in brittle materials:
  - ceramics, intermetallics, glassesmechanical properties at the small scale
  - metals, multiphase alloys, nano-materials
- Measure mechanical properties of individual grains or deformation mechanisms:
  - $\tau_c$  : slip, twinning, shear banding
  - $E$  (elastic modulus): not a good choice
  - $\dot{\epsilon}$  [jump tests]: activation volumes & energies

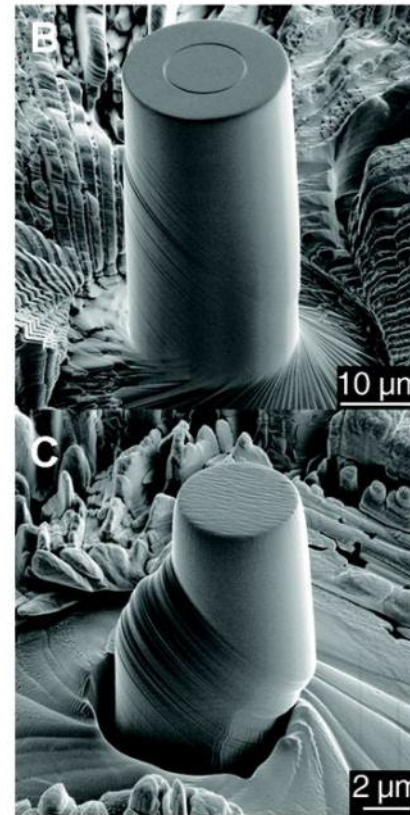
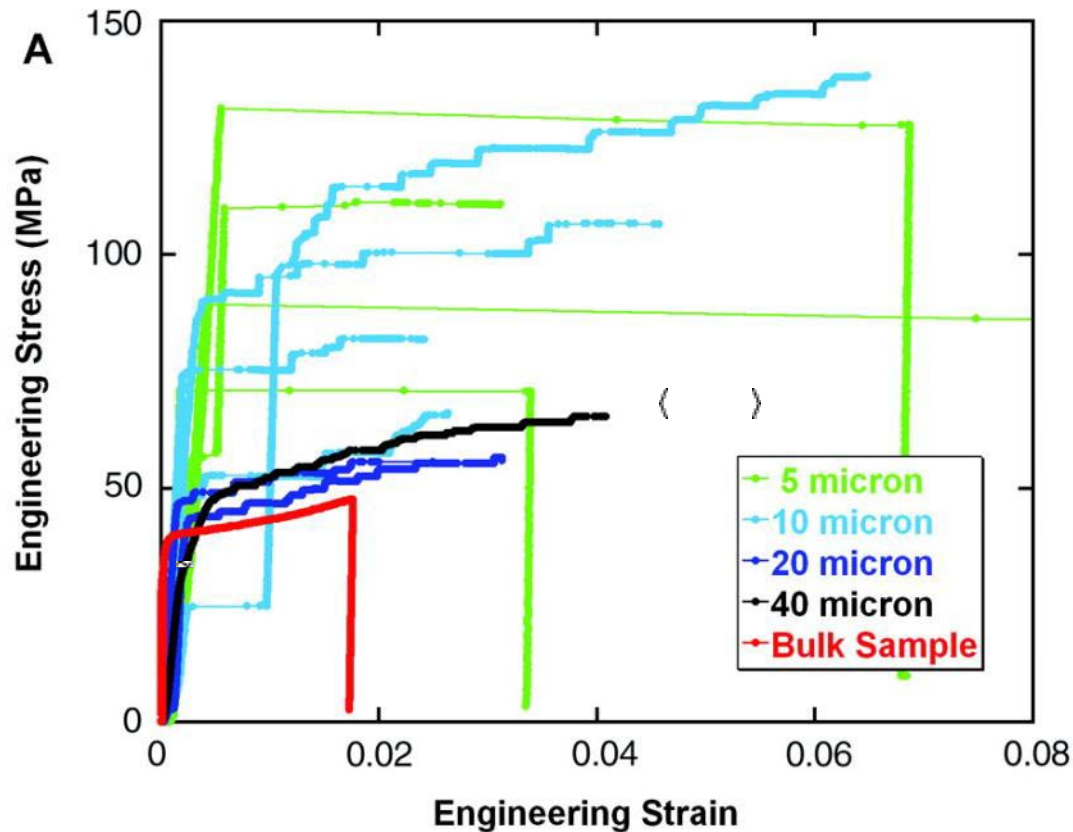


$\text{Cr}_2\text{AlC}$ , Pürstl, J. (2018) Thesis, Cambridge



Si, 500nm, 25 °C; Korte, S. et al, Int J Plast, 2011, 27

# Micro compression tests



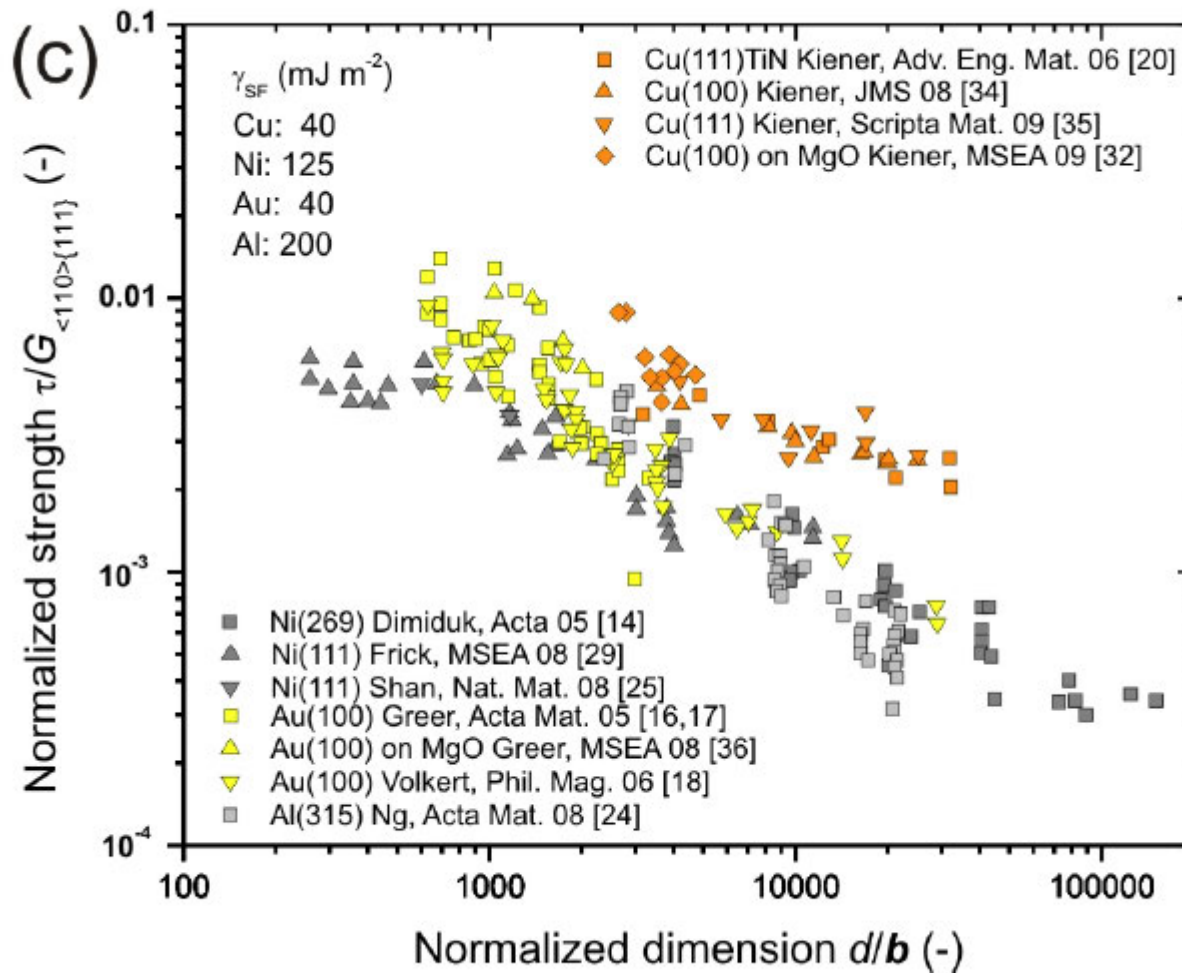
**Note: true load-controlled device !  $\neq$  Alemnis**

MD Uchic, DM Dimiduk, JN Florando, WD Nix (2004) Sample dimensions influence strength and crystal plasticity, *SCIENCE* 305, 986-989



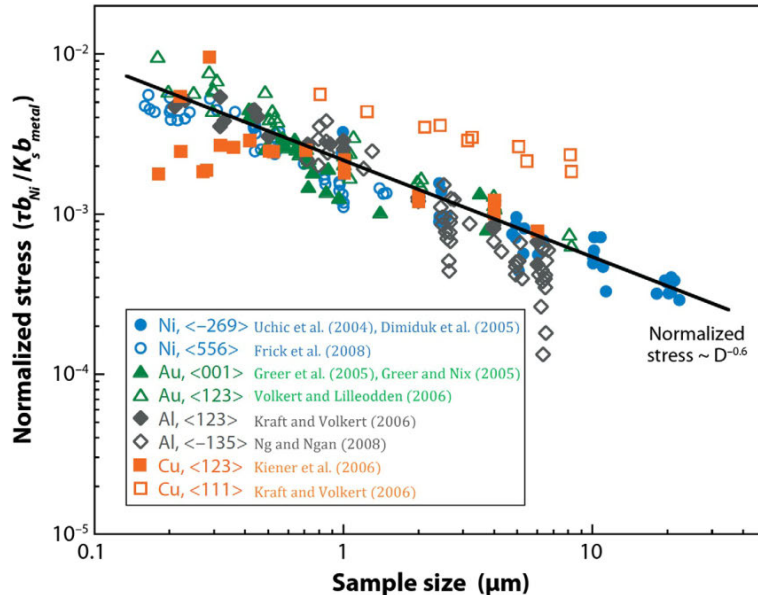
# Smaller is stronger

Smaller is stronger



Kiener D, Motz C, Dehm G, Pippan R. *Int. J. Mat. Res.* 2009;100.

# Extrinsic size effect - pillars



**FIG. 1.39** Variation of normalized flow or yield shear stress  $\tau b_{Ni} / K_s b_{metal}$  as a function of pillar diameter for different FCC metals. The original experimental data has been reported by Uchic et al. (2004), Dimiduk et al. (2005), Frick et al. (2008), Greer et al. (2005), Greer and Nix (2005), Volkert and Lilleodden (2006), Kraft and Volkert (2006), Ng and Ngan (2008), and Kiener et al. (2006). (After Uchic, M.D., Shade, P.A., Dimiduk, D.M., 2009. Plasticity of micrometer-scale single crystals in compression. *Annu. Rev. Mater. Res.* 39, 361–386.)

Au samples have been favorable since the oxide layers may alter the observed results during pillar compression experiments.

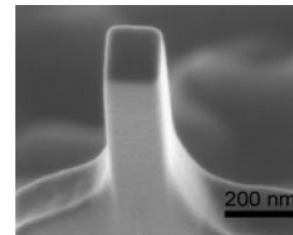
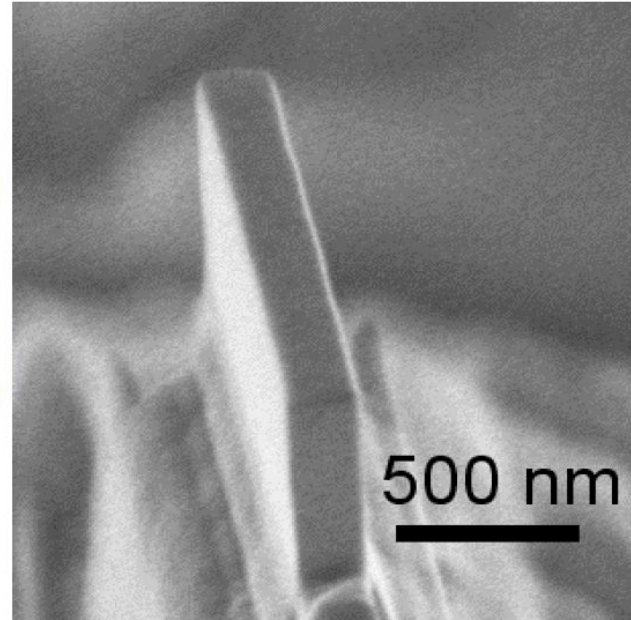
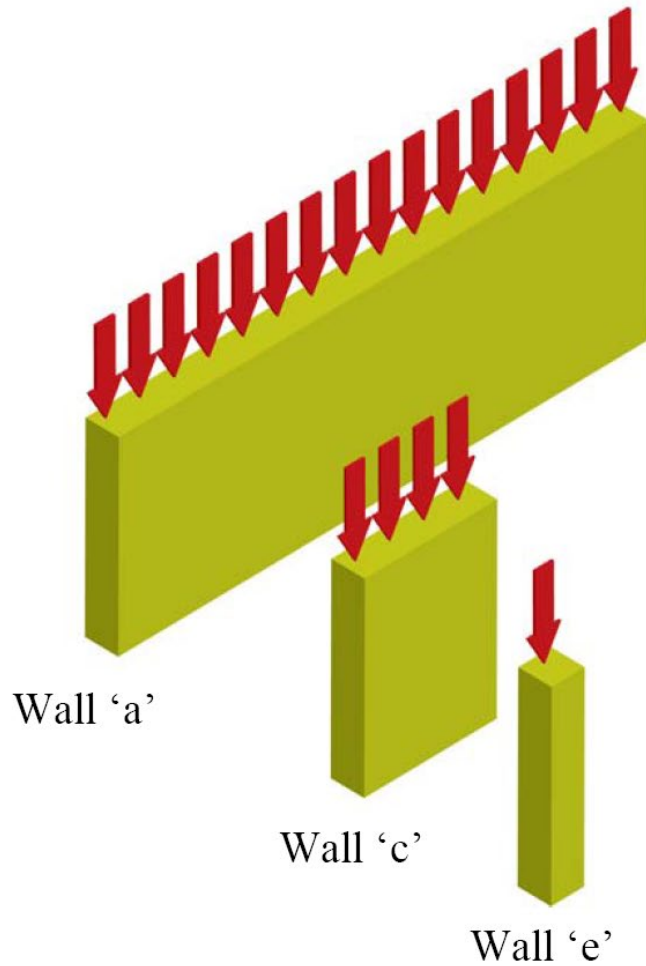
It was observed that the relation between the sample yield or flow stress  $\sigma$  and the pillar diameter  $d$  can be captured using a power law as follows:

$$\sigma = A d^{-n}$$

where  $A$  is a constant, and  $n$  is the power-law exponent, which is reported to be 0.61–0.97.

The figure illustrates the results of pillar compression experiments for several FCC metals. Assuming that  $\tau_0$  is negligible and considering the Burgers vector of Ni as the reference one, a reasonable fit can be obtained for  $n = 0.6$ .

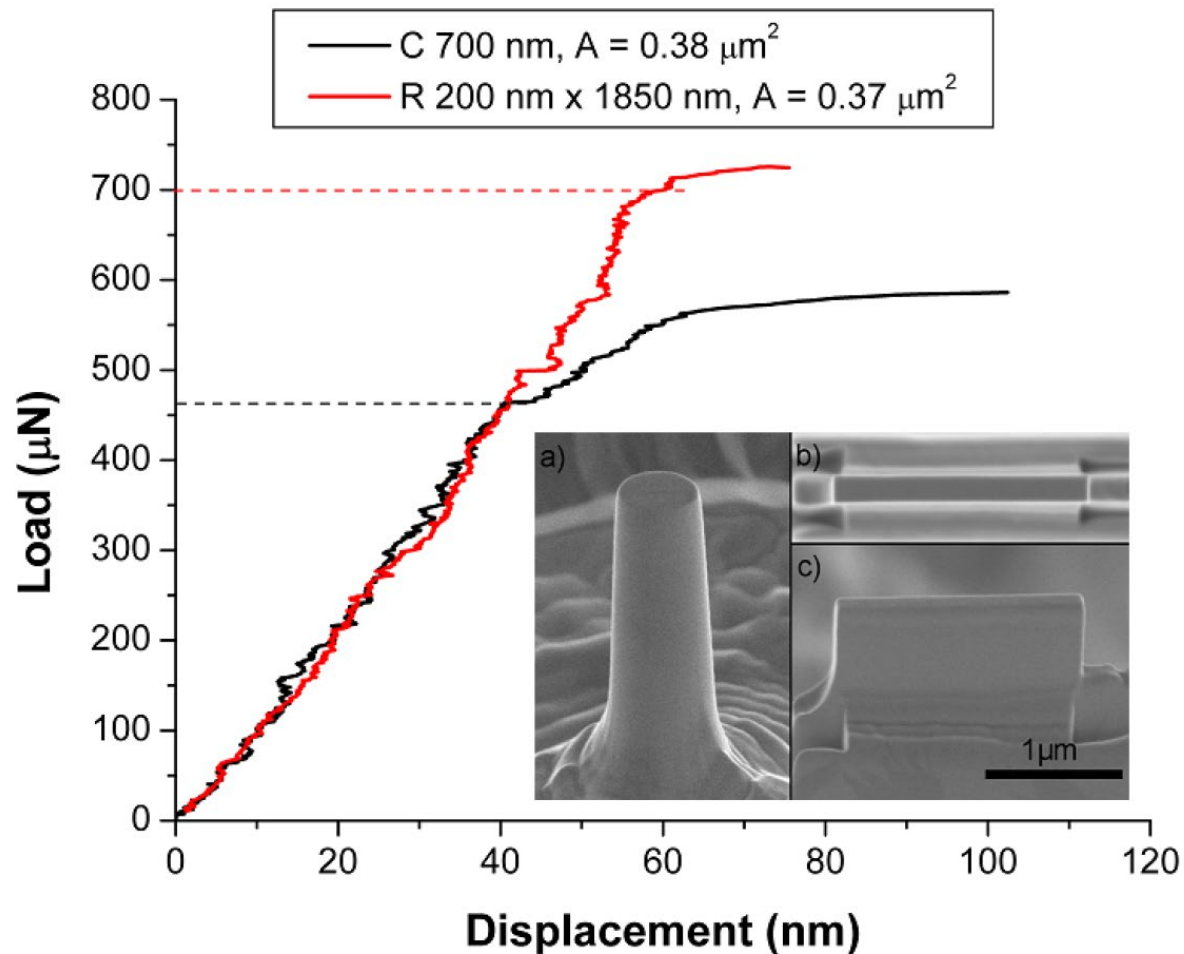
# rectangular walls



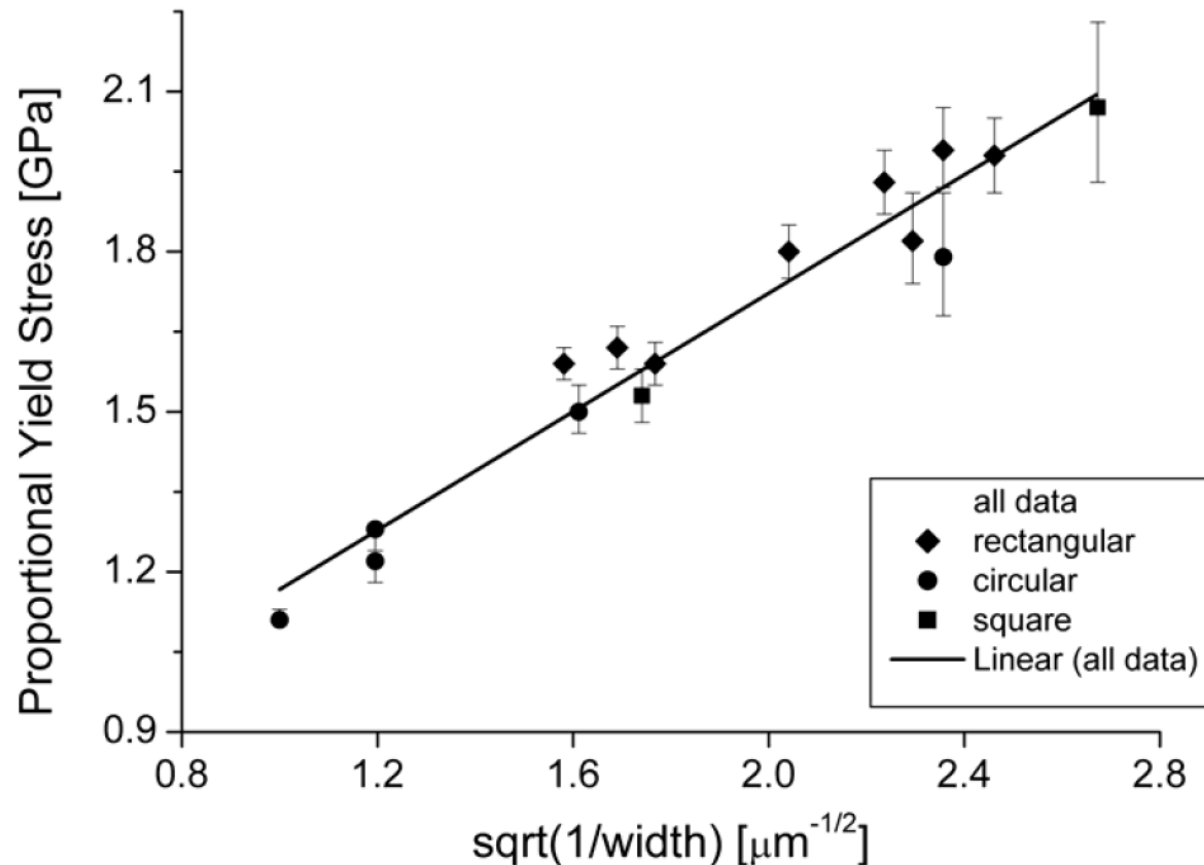
Jennett (2009) APL



# rectangular walls versus circular pillars

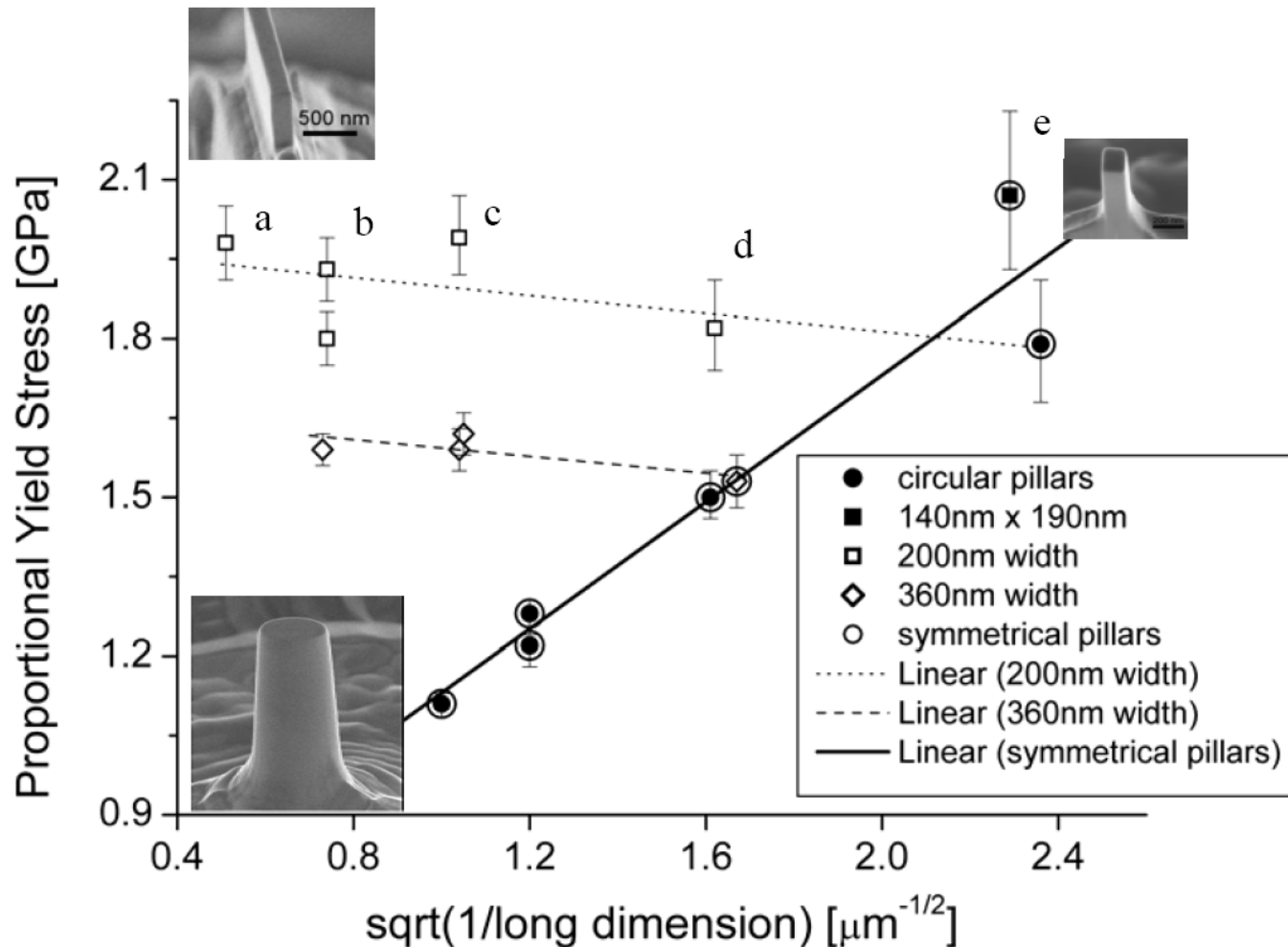


# rectangular walls versus circular pillars



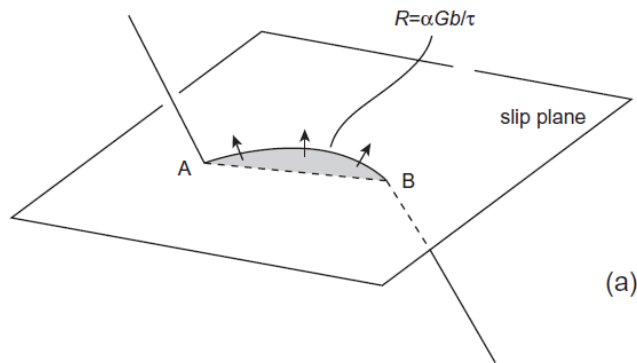
(Supporting info) Figure 2: The proportional yield point of all structures is proportional to the inverse square root of the smallest dimension. Square, rectangular and circular cross-section structures behave equivalently. Error bars represent 95% confidence intervals.

# The "thinness effect"



„From a practical engineering design perspective, this means that it is not necessary to shrink the entire size of the structure to obtain length-scale engineered strengthening; only the thinnest dimension needs to be reduced to obtain improved properties“

# Dislocation multiplication - Frank-Read source



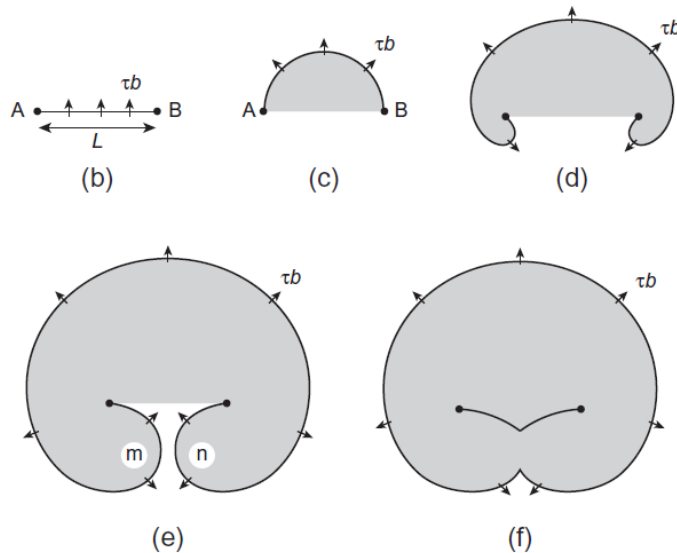
The dislocation segment is held at both ends by dislocation intersections, precipitates etc.

An applied resolved shear stress  $\tau$  exerts a force  $\tau b$  per unit length of line and tends to make the dislocation bow

The radius of curvature  $R$  depends on the stress.

$$\tau_0 = \frac{\alpha Gb}{R}$$

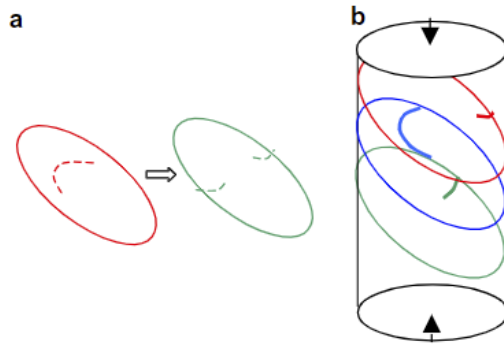
as  $\tau$  increases,  $R$  decreases and the line bows out until the minimum value of  $R$  is reached at the position illustrated in Fig. c



Here,  $R$  equals  $L/2$ , where  $L$  is the length of AB, and the stress is

$$\tau_{max} = Gb/L$$

# Extrinsic size effect - source truncation



**Figure 1.** (a) A schematic sketch of how double-pinned Frank-Read sources quickly become single-ended sources in samples of finite dimensions. (b) Schematic sketch of single-ended sources in a finite cylindrical sample in critical configuration, which occur where the distance from the pin to the free surface is the shortest. The longest arm among the available sources (blue in this case) determines the critical resolved shear stress. Thus the statistics of pins within a sample of finite size determines the yield strength of the sample. (For interpretation of the references in colour in this figure caption, the reader is referred to the web version of this article.)

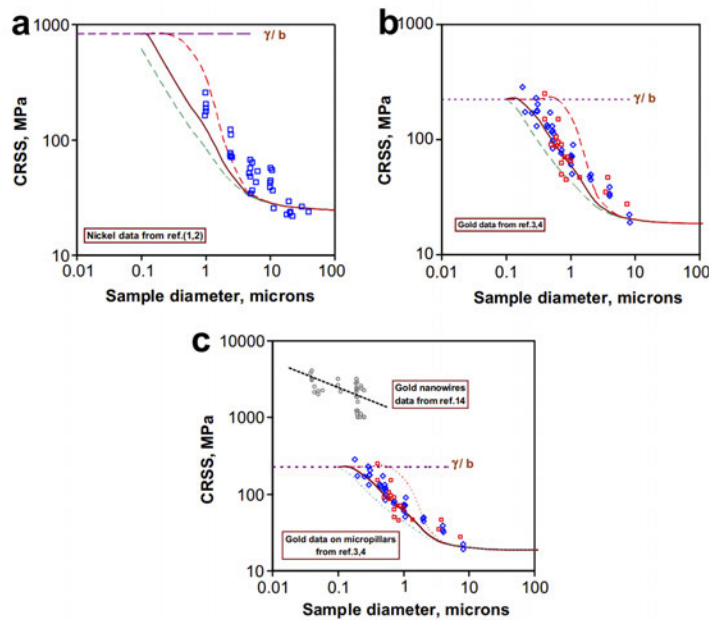
In the case of pillars with confined volumes, the double-ended dislocation sources are transformed into the single-ended ones due to the interaction of dislocations with the pillar free surfaces.

The length of the new dislocation source is a function of pillar size in a way that as the sample size decreases, the length of dislocation sources also decreases. Accordingly, a smaller sample has a higher strength.

G.Z. Voyiadjis and M. Yaghoobi. (2018)

T. A. Parthasarathy et al. / Scripta Materialia 56 (2007) 313-316

# Extrinsic size effect - source truncation



**Figure 3.** The model predictions for (a) nickel and (b) gold are shown in comparison with reported experimental data (from Refs. [1–4]). The dotted lines (green and red in the web version) correspond to the lower and upper standard deviations from the mean as predicted by the model. The plot in (c) includes data for gold nanowires (from Ref. [18]) to show that these differ from gold micropillars, suggesting that the nanowires are likely dislocation free with smooth surfaces that do not favor easy nucleation as in whiskers [8]. (For interpretation of the references in colour in this figure caption, the reader is referred to the web version of this article.)

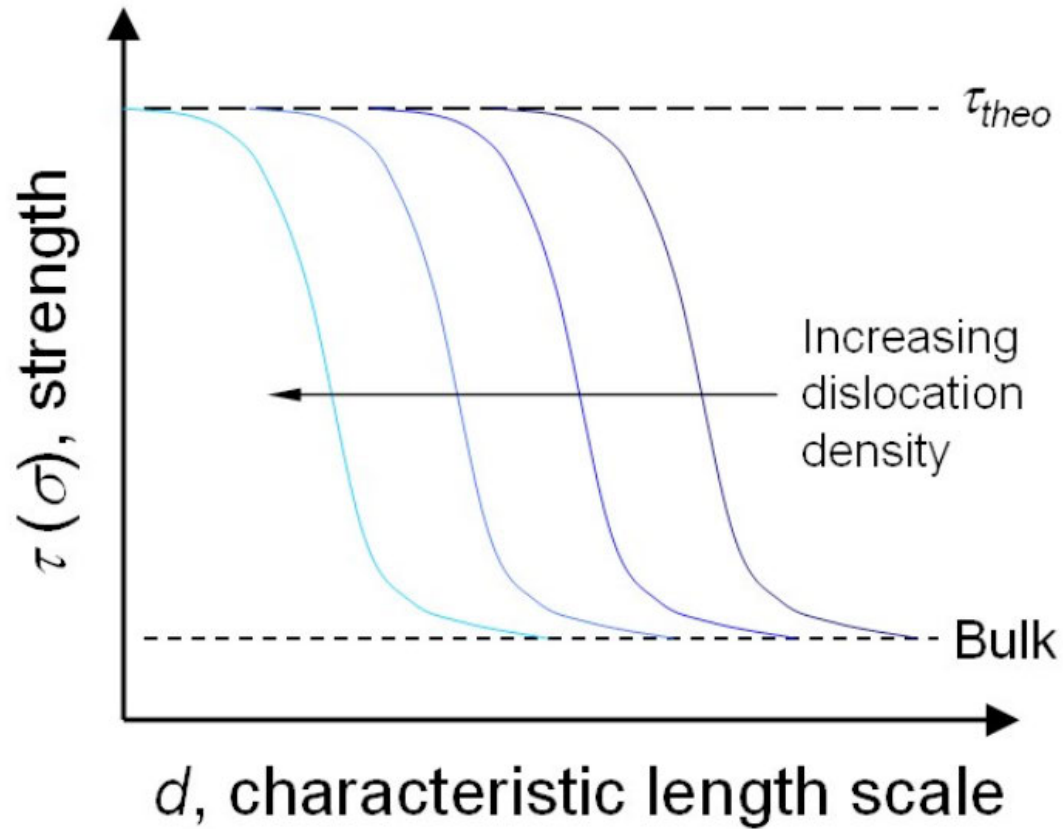
The statistical variation in the source length of dislocations imposed by finite dimensions of a cylindrical sample is sufficient to rationalize much of the effect of sample size on the measured flow stress of micropillars.

Correction factor

$$\Delta\tau_{pillar} = \frac{\alpha G b}{\bar{\lambda}_{max}}$$

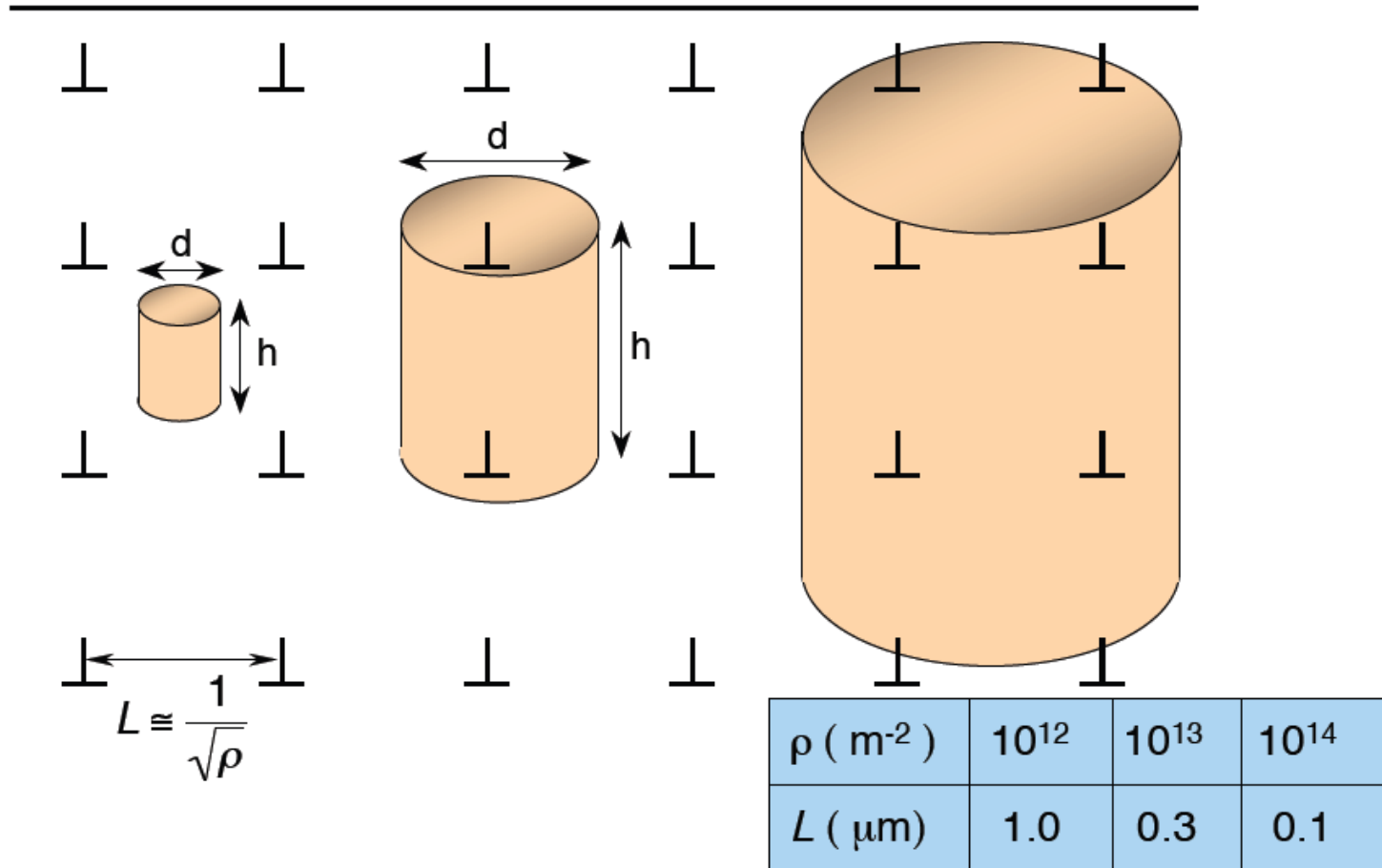
Pillar diameter

# Micro compression tests

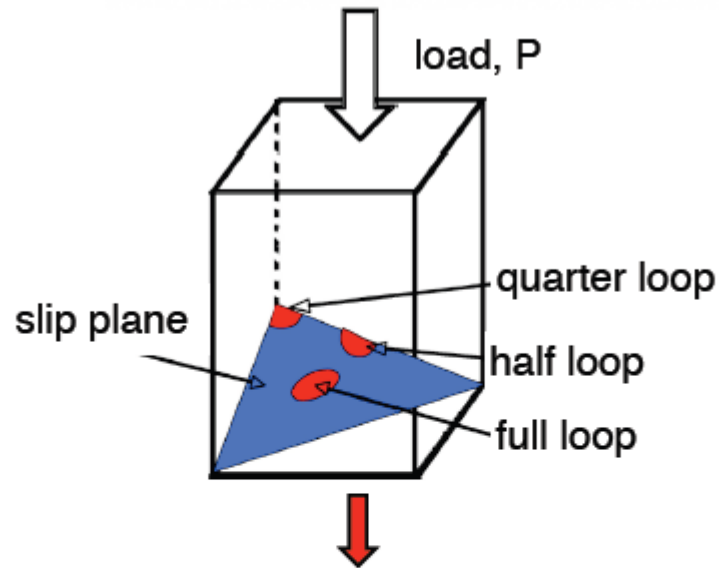




# External size effects



# Dislocation nucleation in micropillars



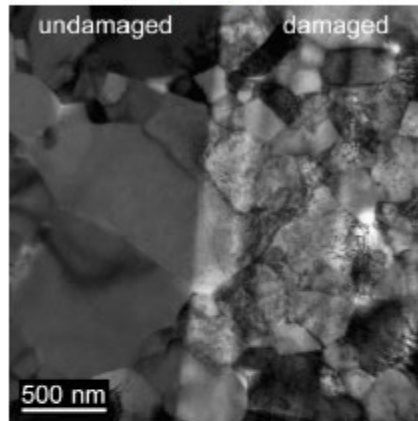
*Heterogeneous*

$$\tau_{crit} = \frac{Gb}{\pi e^2 r_o} \left( \frac{2-\nu}{1-\nu} \right) m ; m = \begin{cases} 1 & \text{(full loop)} \\ \sim 0.5 & \text{(half loop)} \\ \sim 0.3 & \text{(quarter loop)} \end{cases}$$

# Extrinsic influences of FIB milling on pillar strength

Kiener et al, *Mater. Sci. Eng. A* 459, 262 (2007)

*TEM of polycrystalline Cu*



## *Important parameters*

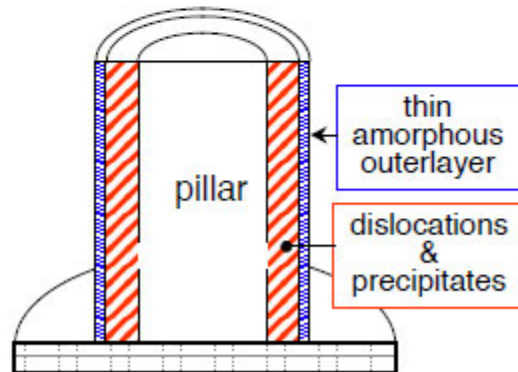
- beam incidence (normal/grazing)
- accelerating voltage (5–30 kV)
- current (10–2000 pA)

## *Strengthening mechanisms*

- hard amorphous film formation
- dislocations
- precipitation

## *Conclusions*

- FIB damage reduced at smaller accelerating voltages & grazing incidence
- even for grazing incidence, effects on strength may be significant for submicron pillars



20

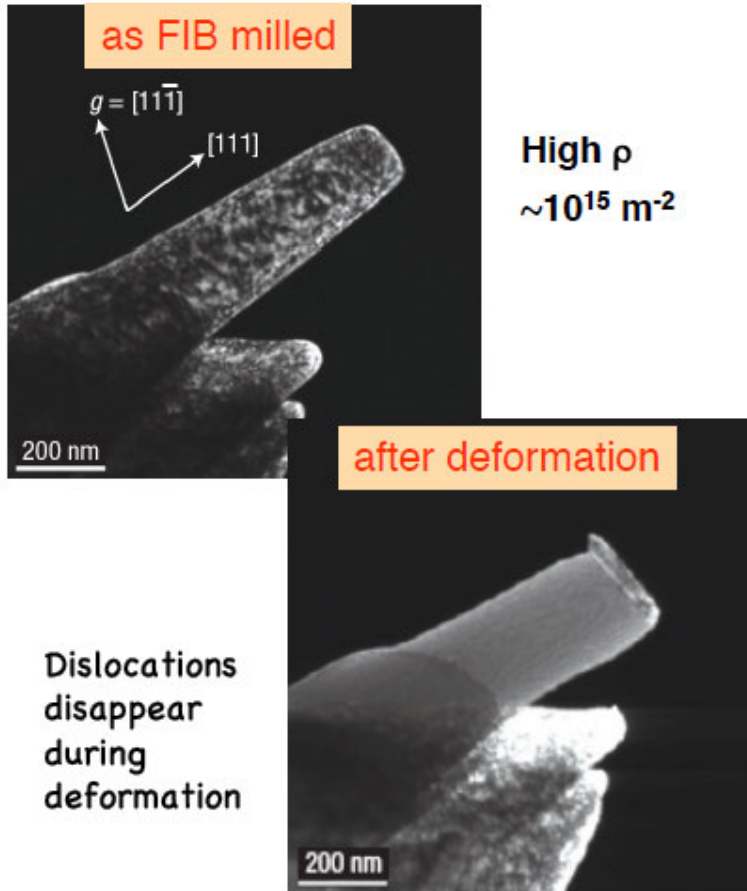
# Extrinsic size effect - source exhaustion

Shan et al, *Nat. Mater.* (2008): dislocation

The second mechanism of hardening occurs when the available mobile dislocations are not adequate to sustain the applied plastic flow.

The loss of mobile dislocation density can occur due to the dislocation escape from the free surfaces, dislocation source shutdown, and mechanical annealing.

Consequently, the applied stress should be increased to activate stronger sources and sustain the required plastic flow, which is termed as exhaustion hardening



G.Z. Voyiadjis and M. Yaghoobi. (2018)

T. A. Parthasarathy et al. / *Scripta Materialia* 56 (2007) 313-316

# In situ tension: single-crystal copper samples

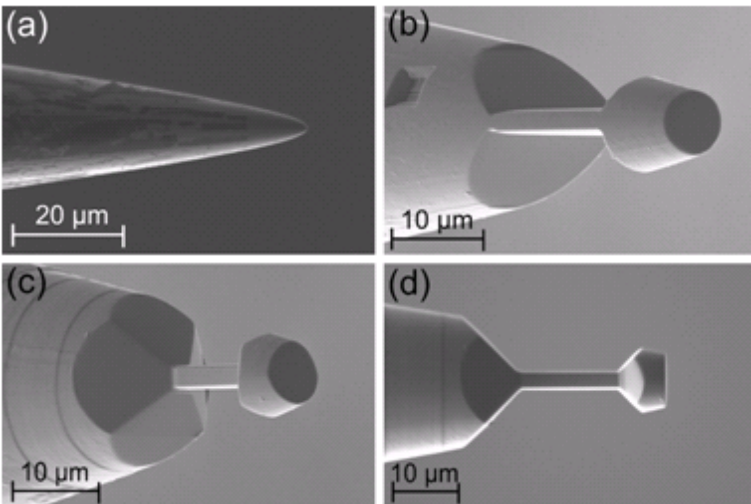


Fig. 1

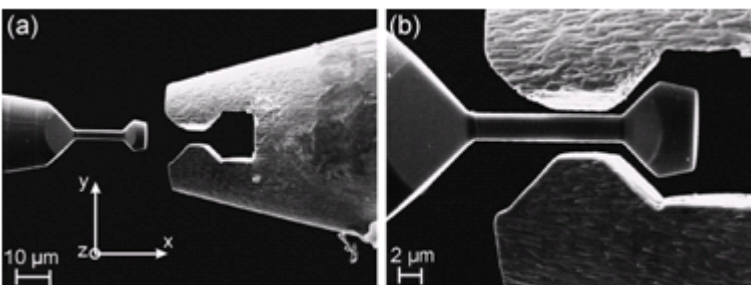


Fig. 2

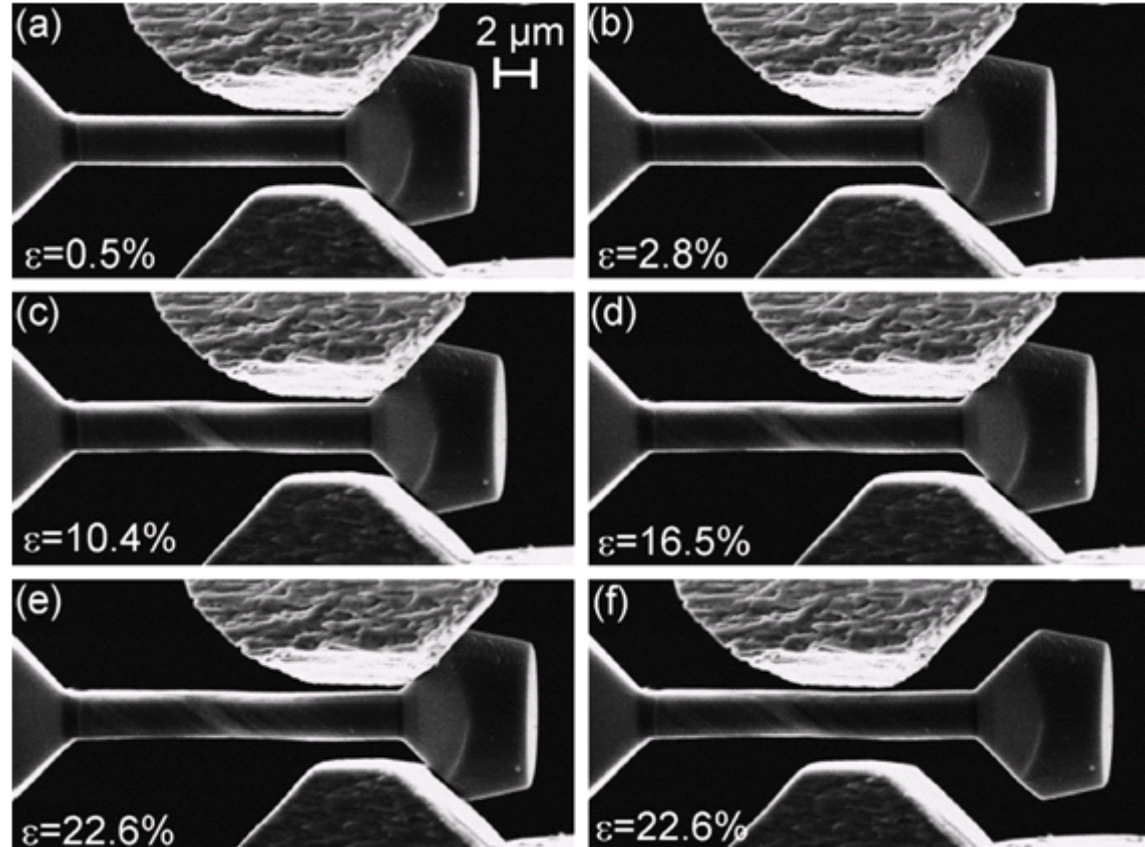
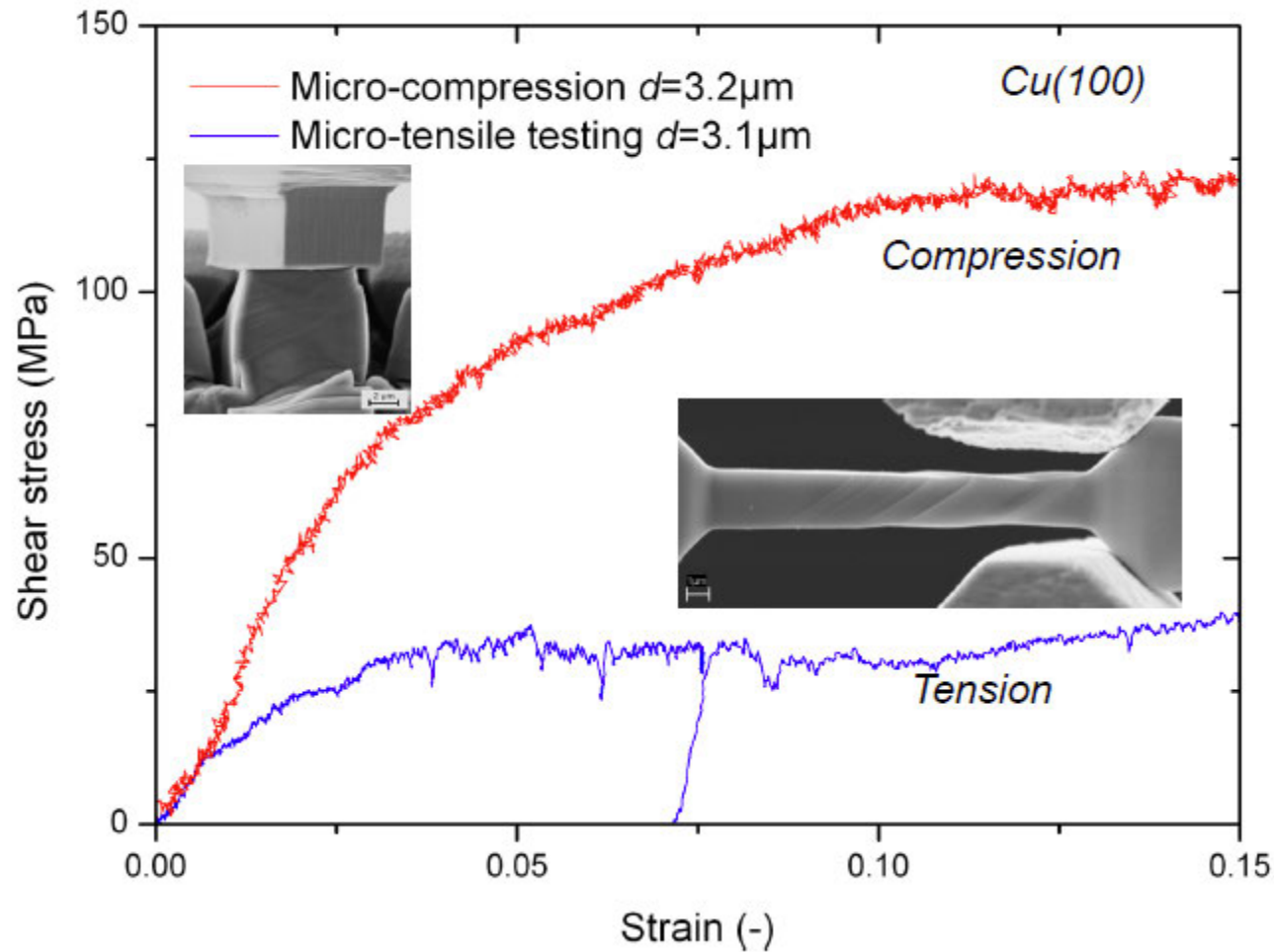


Fig. 3



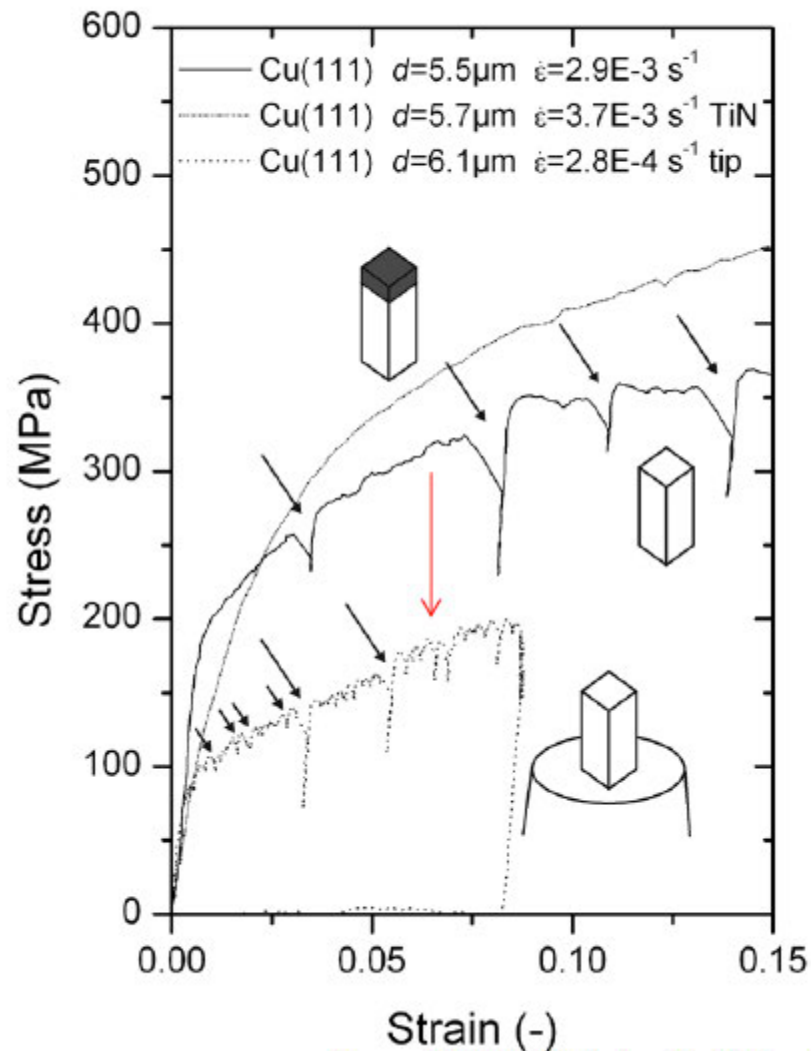
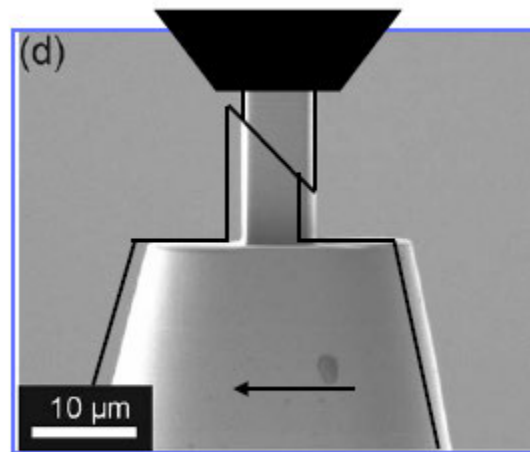
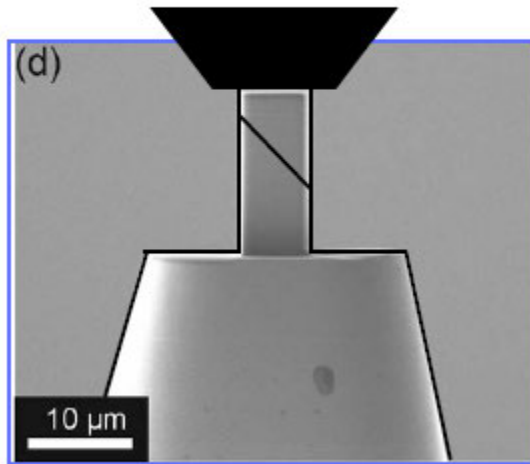
# Compression versus tension

*Cu(100) oriented tensile and compression sample*



# Strength from lateral constraint

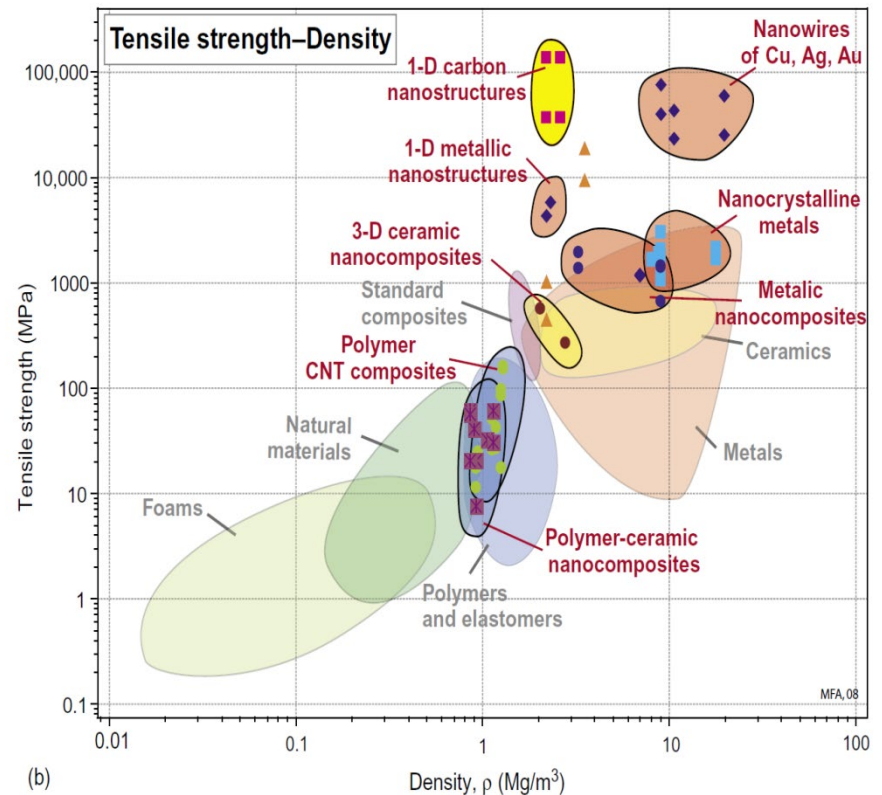
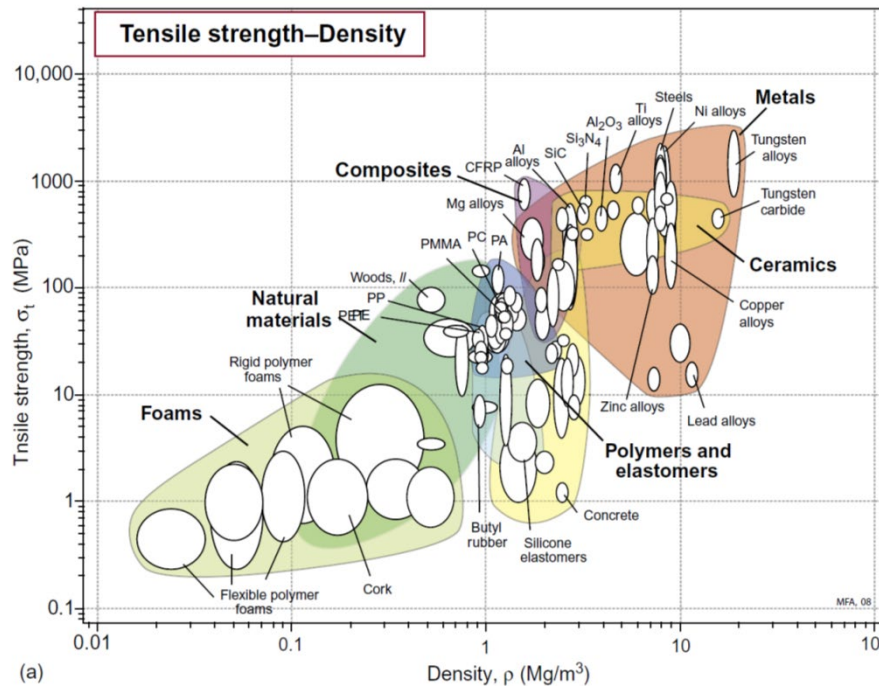
Micro-compression of a **Cu(100)** sample with reduced lateral stiffness



Kiener D, Motz C, Dehm G. Mater. Sci. Eng. A 2009;505:79.



# Internal & external size effects

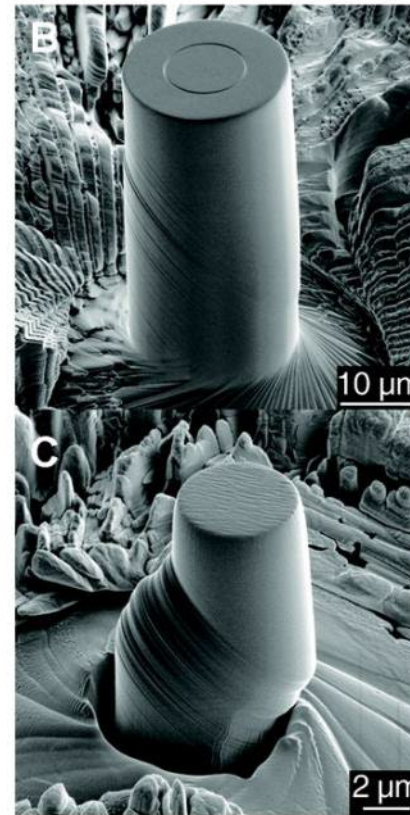
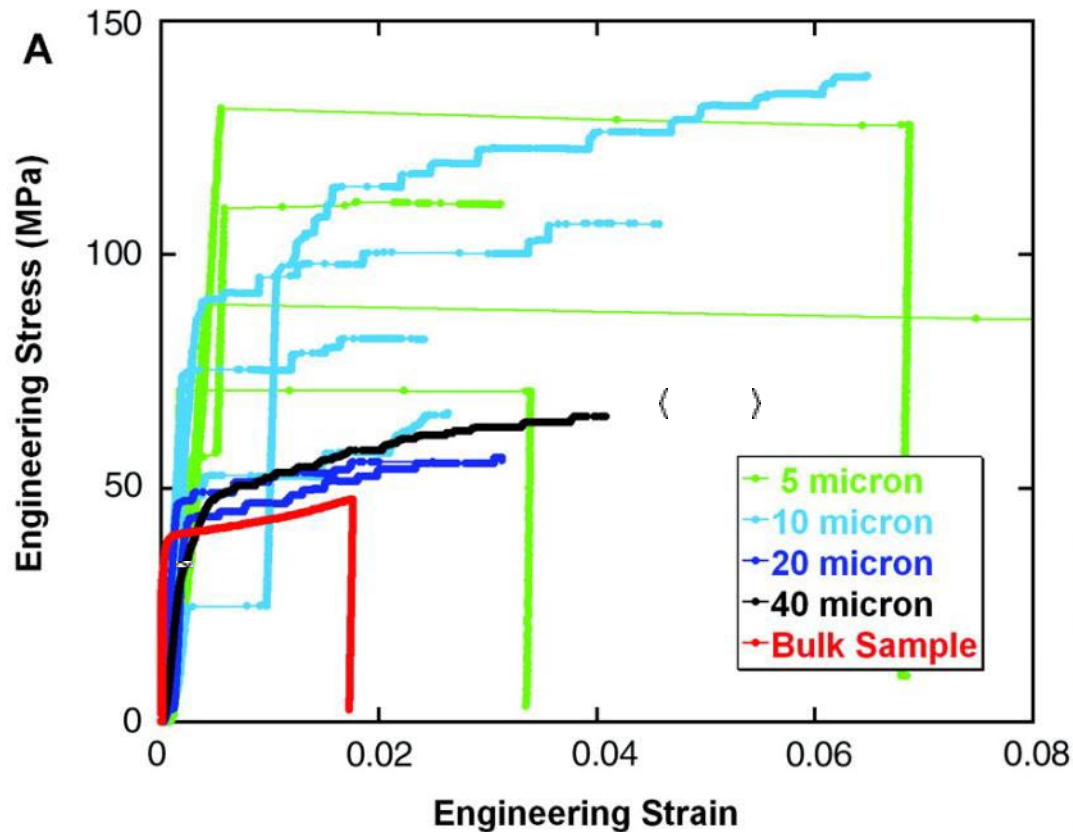


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# Size dependence of mechanical materials properties

## physical size effects

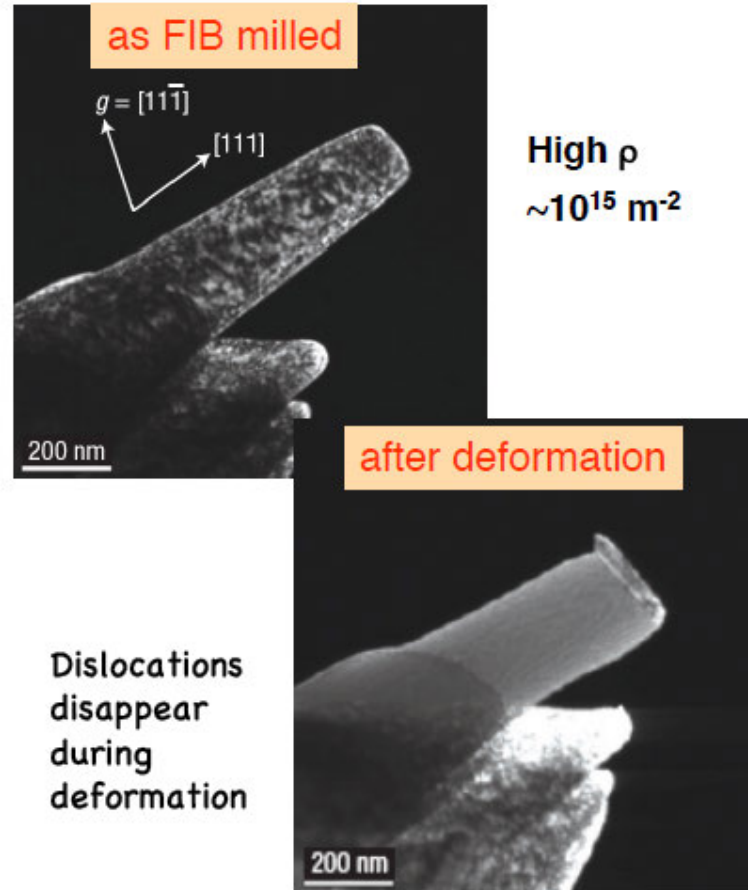
# Micro compression tests



MD Uchic, DM Dimiduk, JN Florando, WD Nix (2004) Sample dimensions influence strength and crystal plasticity, *SCIENCE* 305, 986-989

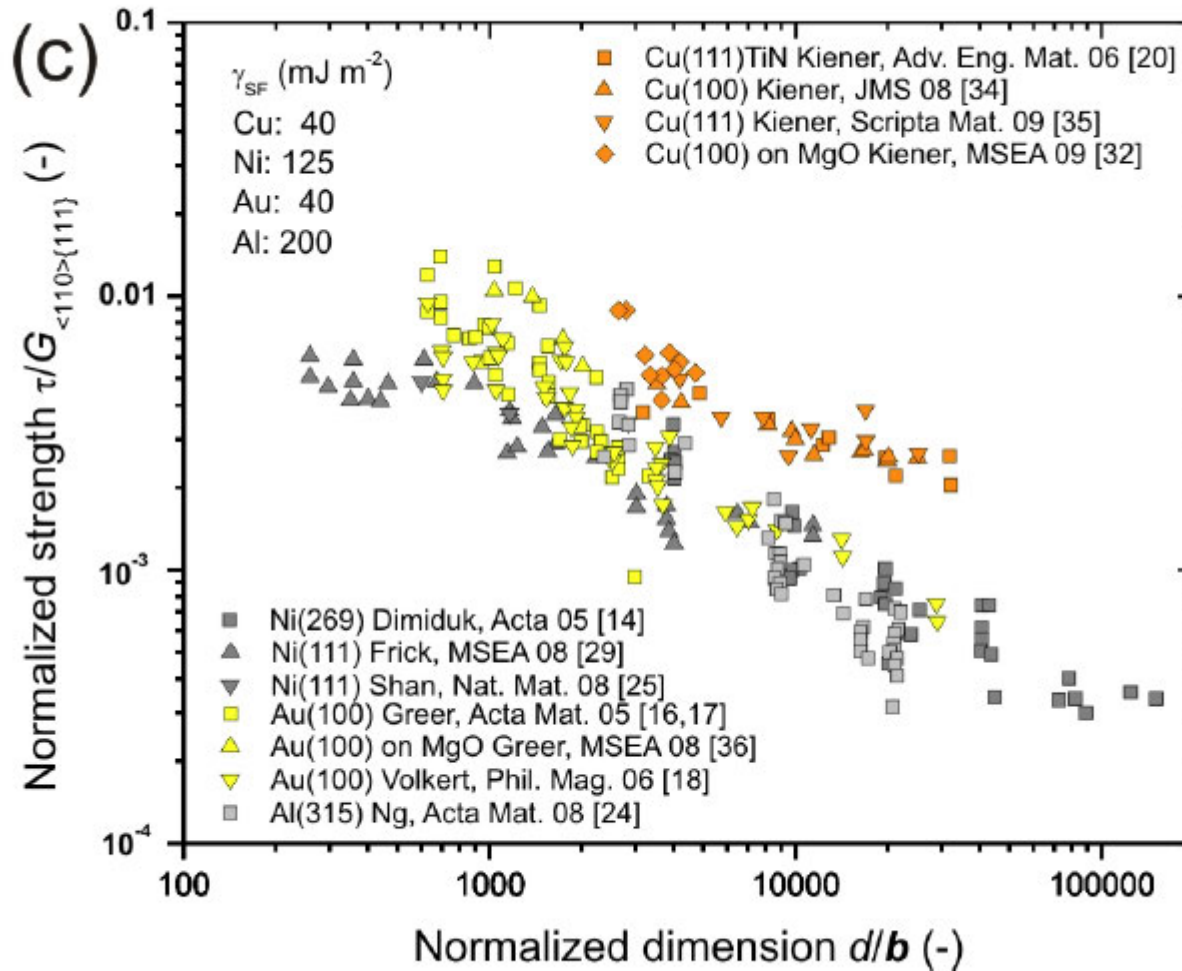
# In-situ TEM compression of nickel micropillars

Shan et al, *Nat. Mater.* (2008): [dislocation](#)



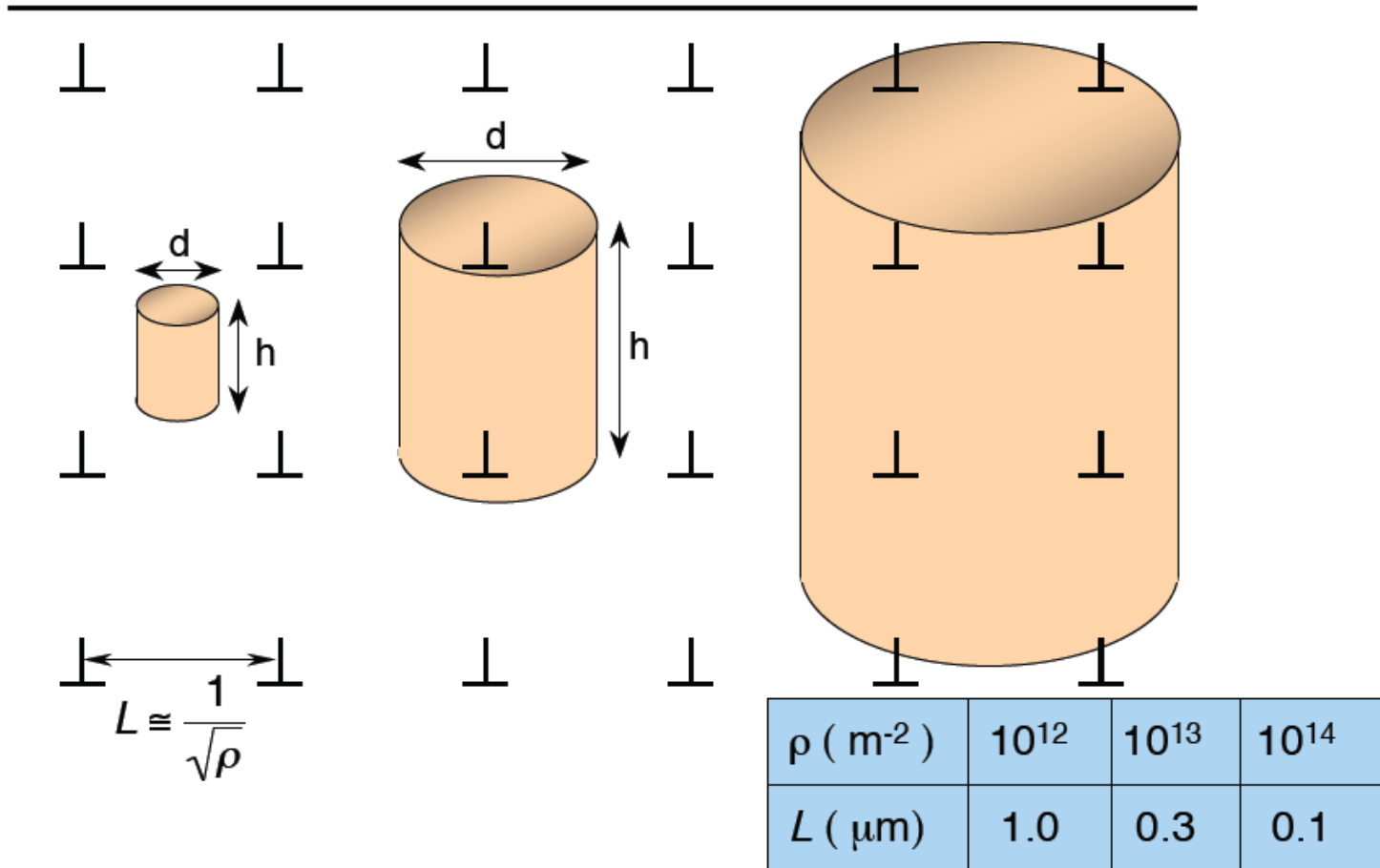
# Smaller is stronger

Smaller is stronger



Kiener D, Motz C, Dehm G, Pippan R. *Int. J. Mat. Res.* 2009;100.

# Micro compression tests

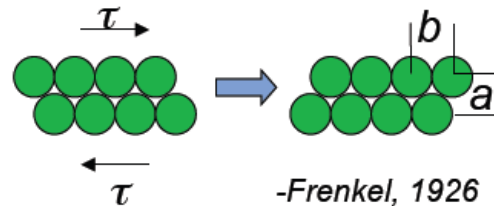


# The ideal strength

- The ideal strength is the stress required to plastically deform a “perfect” (defect-free) infinite crystal.

- $\tau_{\text{ideal}} \gg \tau_{\text{exp}}$

$$\begin{aligned}\tau_{\text{ideal}} &\approx G/2\pi \\ \tau_{\text{exp}} &\approx G/1000\end{aligned}$$

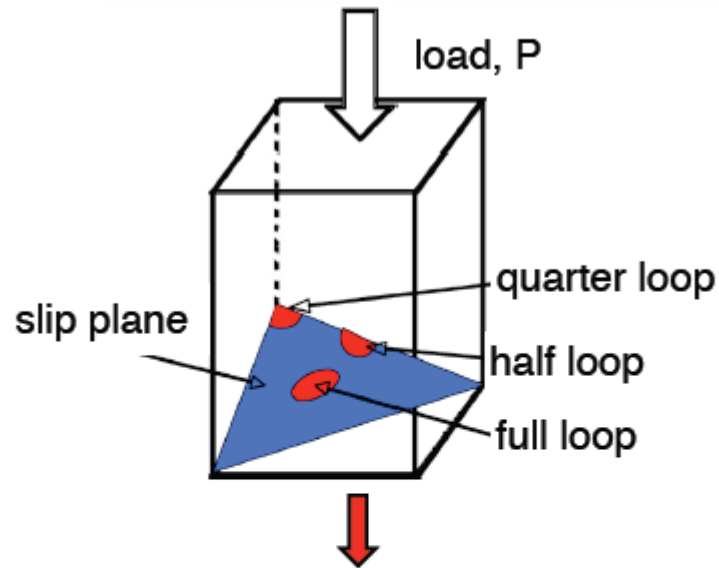


- 1934- Orowan, Taylor and Polanyi independently discovered dislocations and showed that real plastic deformation could be described by their movement.

⇒ Even a simple model of the force required to move a dislocation shows that shear is possible at much lower stresses than in a perfect crystal.

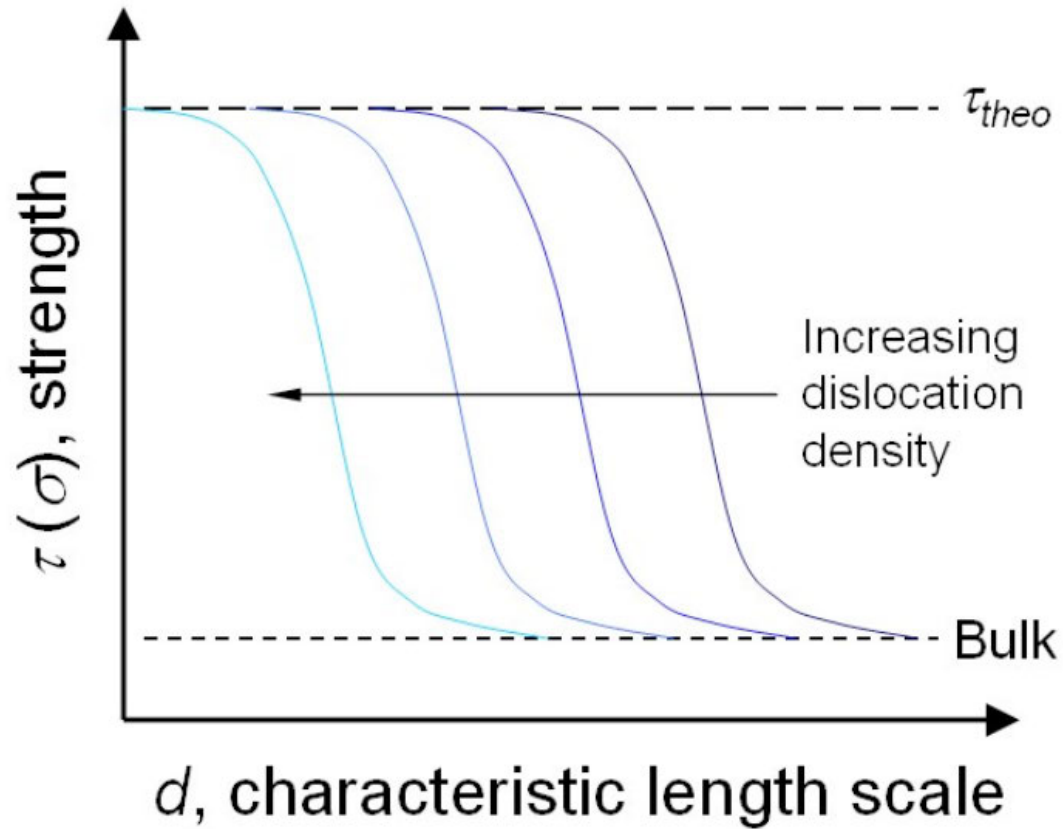


# micro compression tests



$$\tau_{crit} = \frac{Gb}{\pi e^2 r_o} \left( \frac{2-\nu}{1-\nu} \right) m ; m = \begin{cases} 1 & \text{(full loop)} \\ \sim 0.5 & \text{(half loop)} \\ \sim 0.3 & \text{(quarter loop)} \end{cases}$$

# Micro compression tests



---

# fracture and plasticity of GaAs and Si micropillars

$E, \sigma_y, n, \sigma_f$



# room temperature plasticity of brittle materials

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two main types of experiments to prevent brittle fracture:

macroscopic uniaxial loading with confining pressure  
e.g. J. Rabier (2000) Phys. Stat. Sol. (b), 22, 63

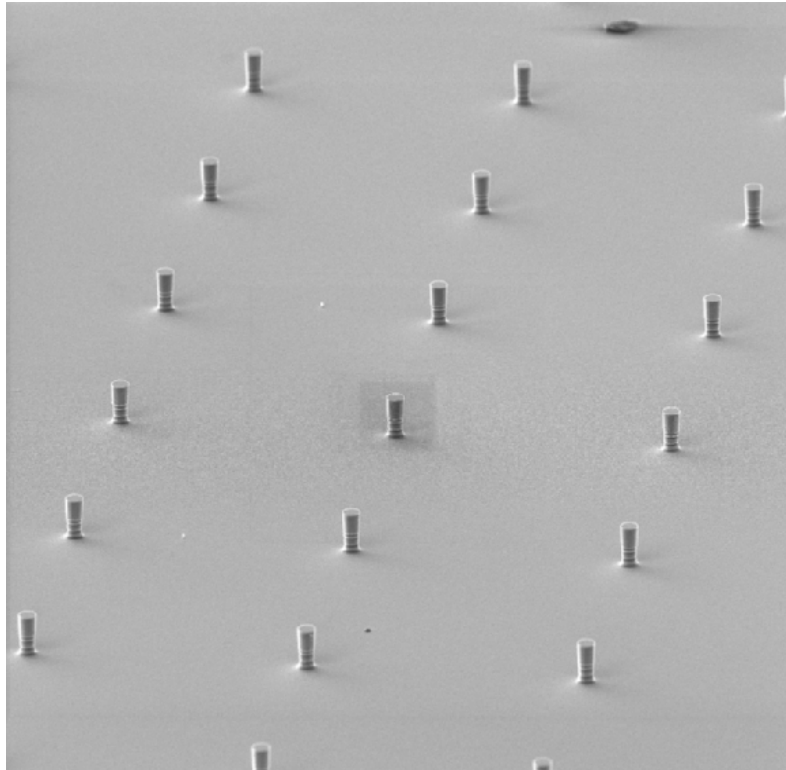
or

macro-, micro- and nanoindentation experiments with "built-in"  
hydrostatic pressure components  
e.g. E. Le Bourhis and G. Patriarche, Prog. Crystal Growth and Charact. 47, 1

What happens if we scale down the uniaxial compression experiment  
to the micro- and nanoscale?

# fracture of silicon and GaAs micropillars

Silicon micropillars (001)

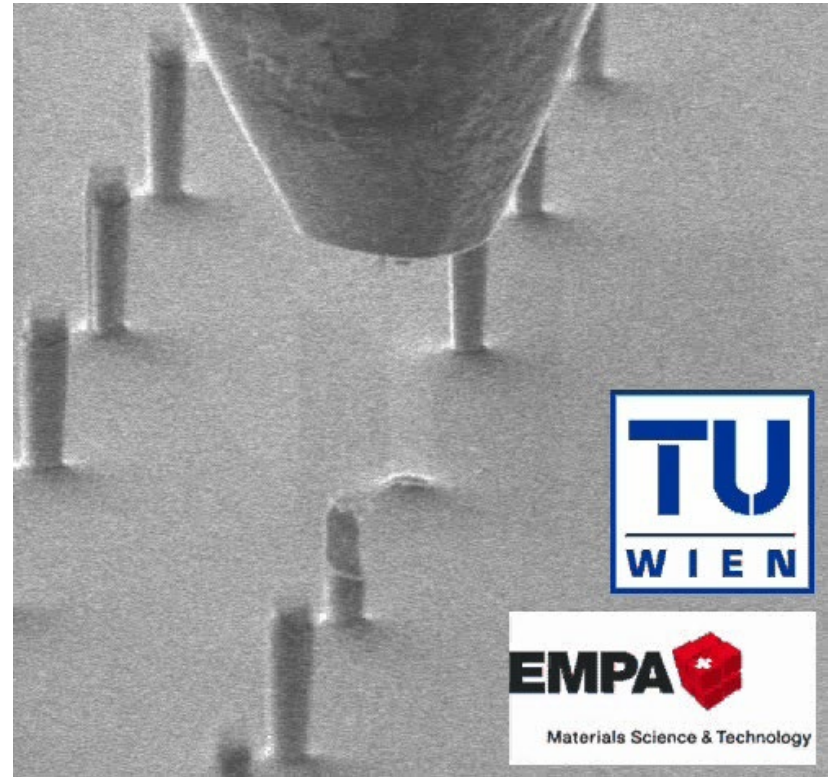


Si pillars EPFL 10kV 18mm 200x

100 μm

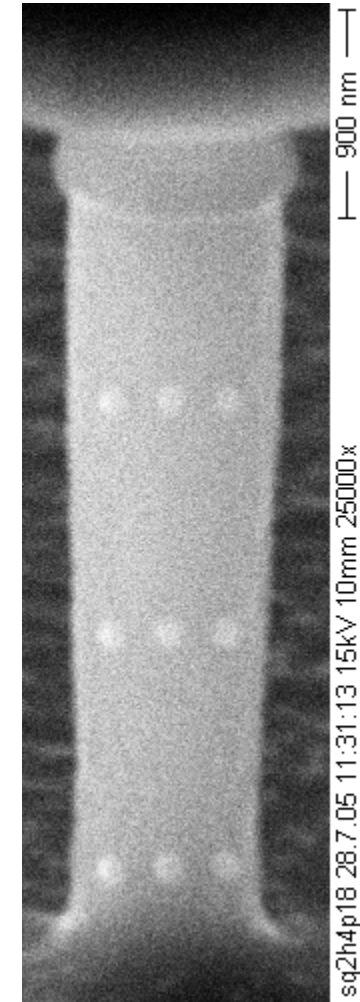
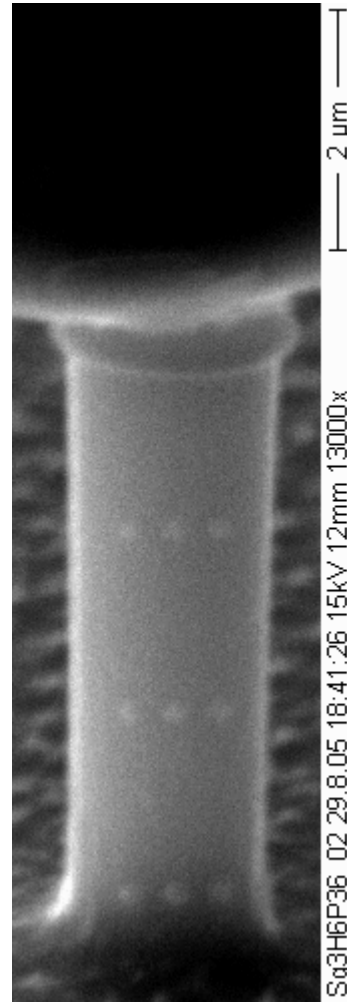
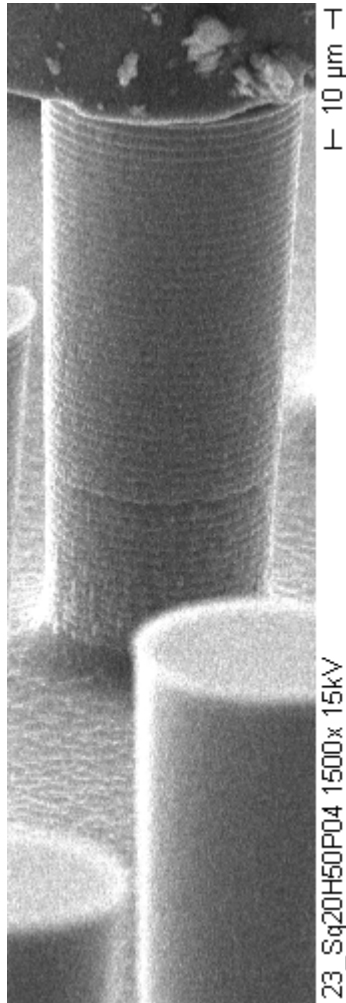
Electron beam lithography & deep reactive ion etching, collaboration with P. Hoffmann, EPFL, Lausanne

GaAs micropillars,  $\langle 001 \rangle$  orientation



UV-lithographie wet chemical etching, collaboration with A. Lugstein, TU Wien

# fracture of silicon micropillars



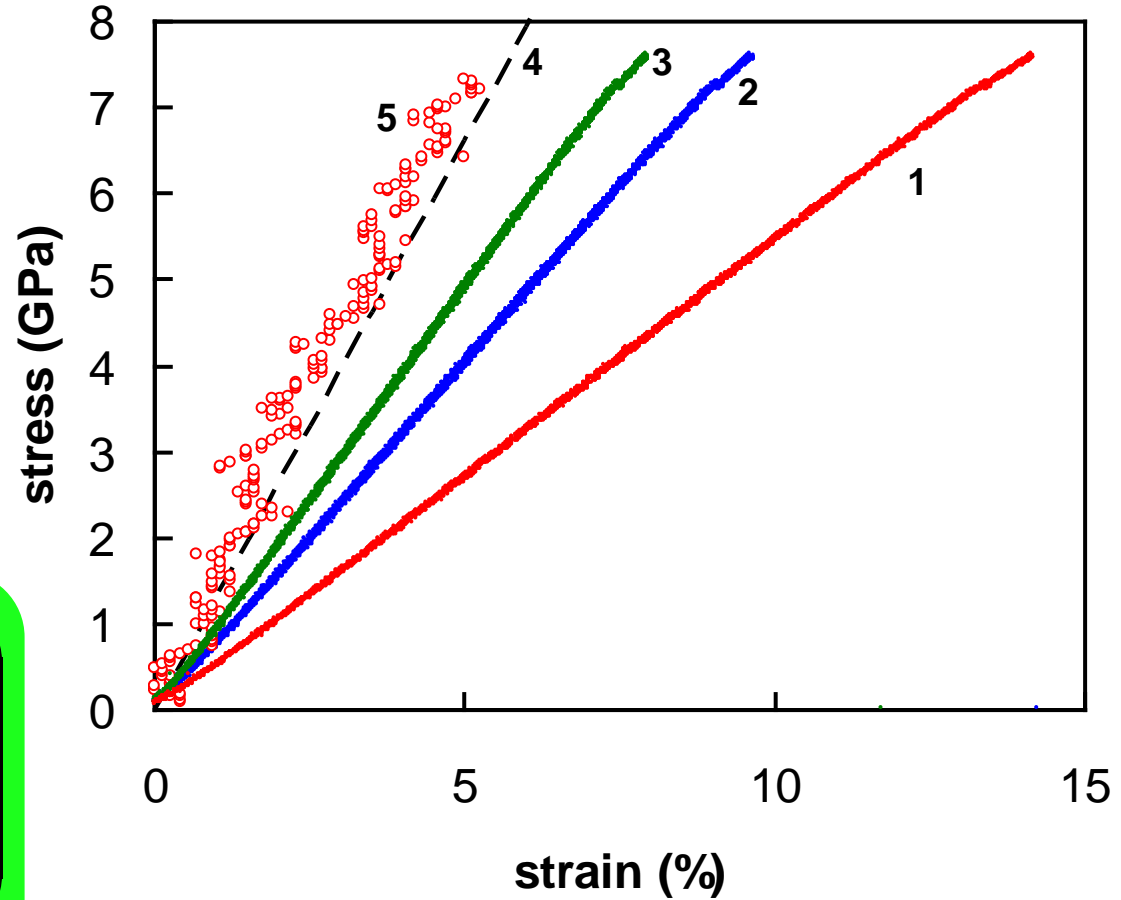
Moser B. et al (2007) J. Mater Res.

# the pain with the strain (-measurement)

$$\varepsilon = \frac{x}{L_0}$$

$$\varepsilon = \frac{x - C \cdot P}{L_0}$$

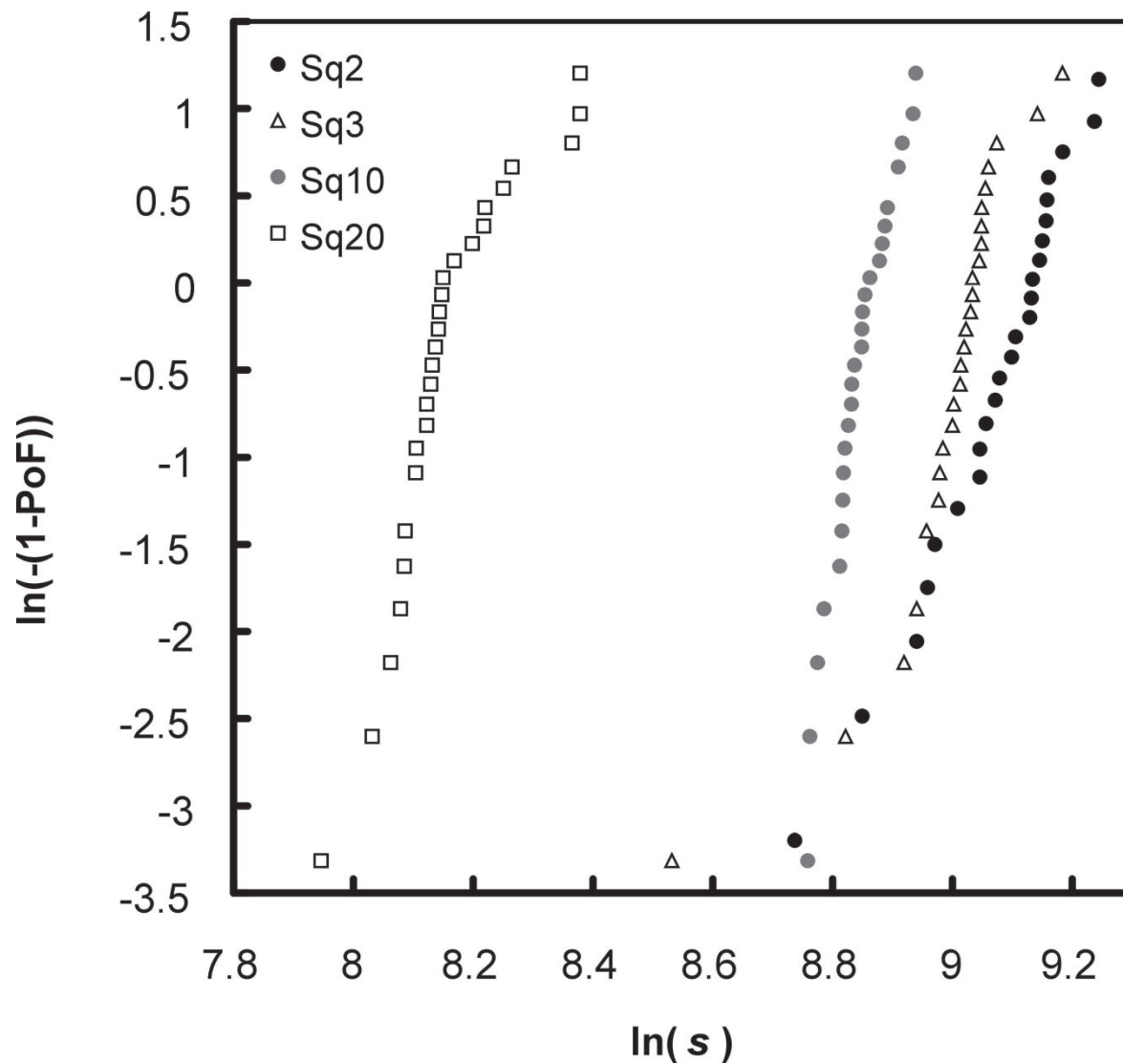
$$\varepsilon = \frac{x - C \cdot P}{L_0} \cdot \left( 1 - \frac{1}{1.43 \cdot \frac{h}{d} + 1} \right)$$



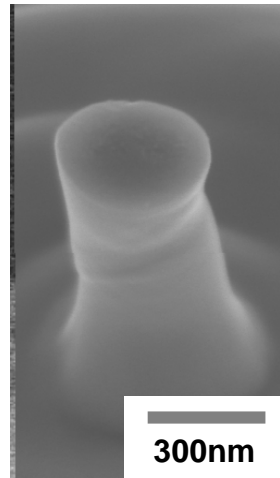
compare also Kiener (2009) Mater. Sc. Eng. A



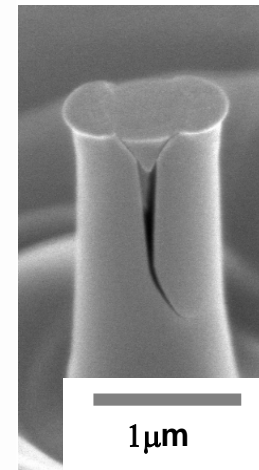
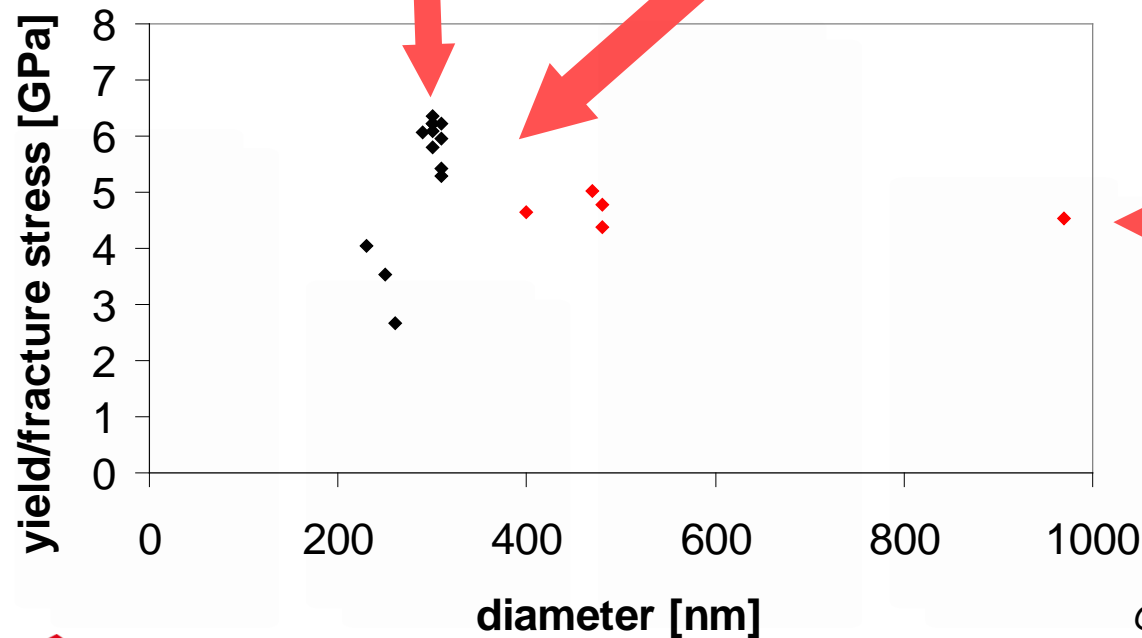
# fracture of silicon micropillars



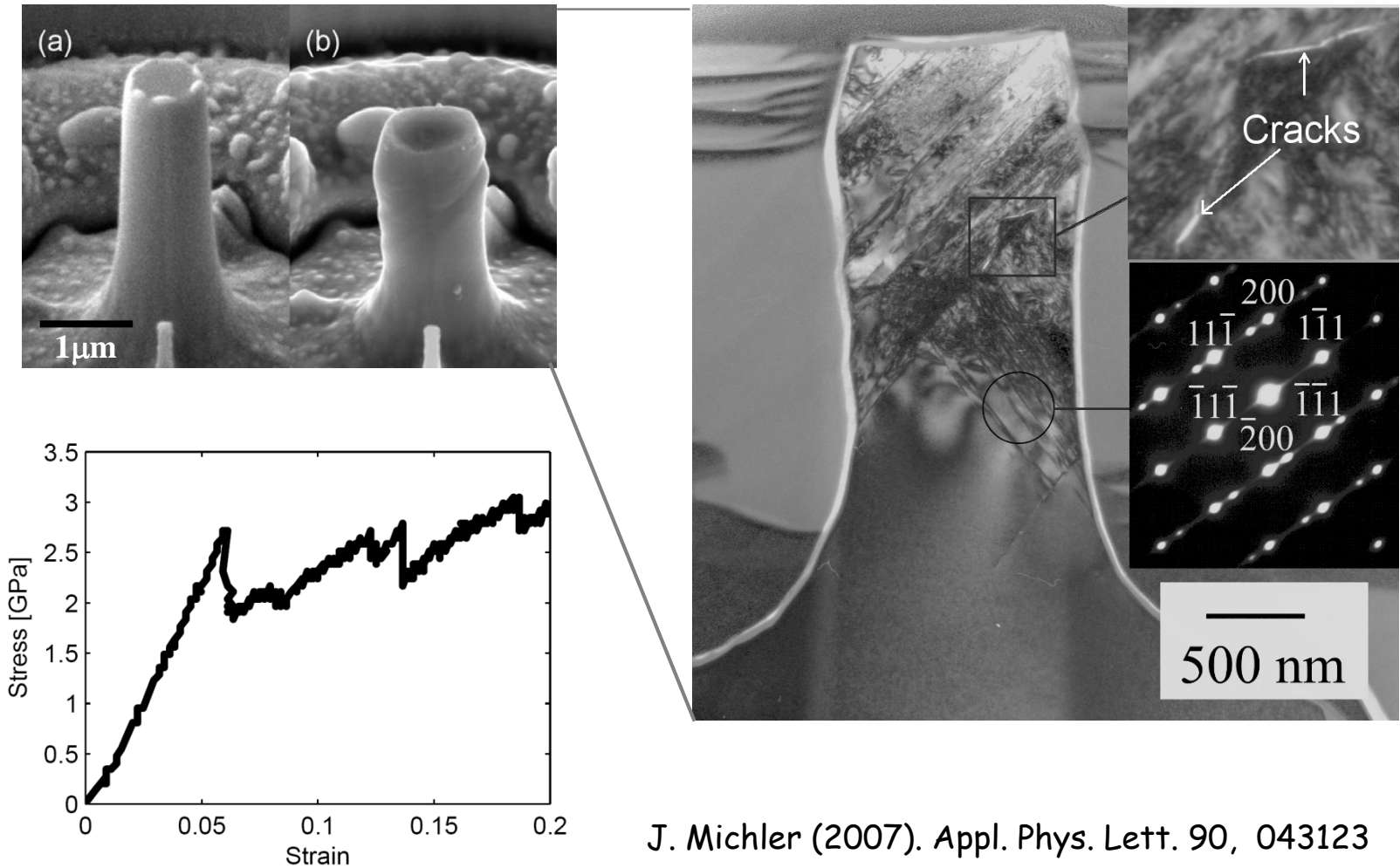
# plasticity of silicon in uniaxial compression



ductile – brittle  
transition



# plastic deformation of GaAs

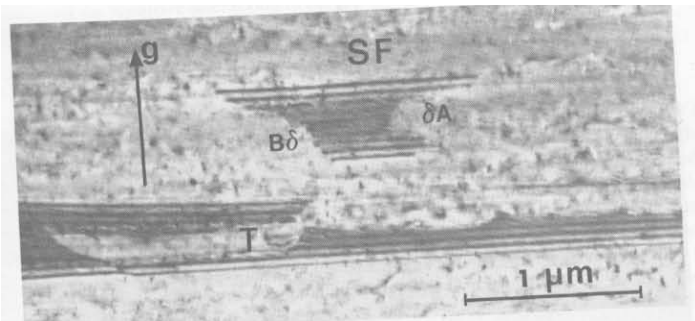


# partial dislocations in GaAs

In Zinc-blende materials dislocations tend to dissociate into two Shockley partials

$$\frac{a}{2}[0\bar{1}1] \rightarrow \frac{a}{6}[\bar{1}\bar{1}2] + \frac{a}{6}[1\bar{2}1]$$

These are separated by a stacking fault



Lefebvre, Androussi, Vanderschaeve. Phil mag 56, 1985

Since the partials have different Burger's vectors, they generally experience different resolved shear stresses

For example, in uniaxial compression along  $\langle 100 \rangle$  directions, their Schmid factors are 0.471 and 0.236 respectively

The mobility of the partial dislocation depends on:

- The character (30/90 degree)
- The core structure
- If it is leading or trailing

Partials experience the following forces

- The repelling force through their strain fields
- The attracting force from the stacking fault
- Force from external loads
- A quasi-viscous drag force

# slip of partial dislocations in GaAs

Wessel and Alexander (1977) balanced the forces on the partials ending up with a formula for the dissociation distance:

$$d = \frac{d_0}{1 + \frac{b\tau}{2\gamma} \left[ f - \frac{1-\alpha}{1+\alpha} \right]}$$

$d_0$  dissociation distance in the absense of external stress

$b$  Burgers vector

$\tau$  Resolved shear stress on the full dislocation

$\gamma$  Stacking fault energy

$f$  A geometrical factor

$\alpha$  The ratio of the mobility of the trailing and leading partial

If the denominator tends to zero a very large splitting of the partials can be expected

For GaAs

$b=4.0 \text{ \AA}$

$\gamma=46 \text{ mJ/m}^2$

$\alpha=1$  (assumption)

$f=-0.3$

$\tau= 0.7\text{GPa}$

$\sigma_{001}=1.7 \text{ GPa}$

which needs to be compared to  $\sigma_{\text{yield}} \sim 2.9\text{GPa}$

# theoretical shear strength of GaAs

---

theoretical shear strength of a material

$$\tau = \frac{b}{a_0} \frac{G}{2\pi} \quad (\text{Hull \& Bacon, "Introduction to dislocations"})$$

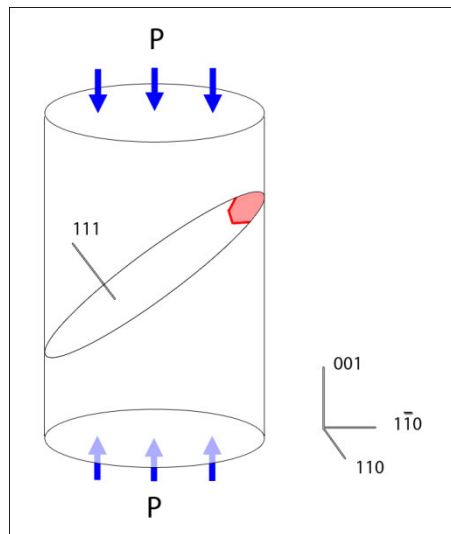
taking the Schmid factor into account this gives roughly

$\sigma_{001}$  = 9.1 GPa for full dislocation

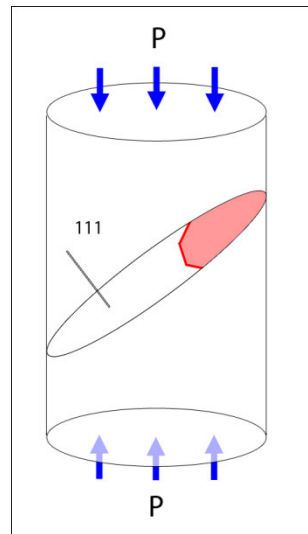
$\sigma_{001}$  = **4.5 GPa** for partial dislocation

which needs to be compared to  $\sigma_{\text{yield}}$  ~ **2.9 GPa**

# slip of partial dislocations

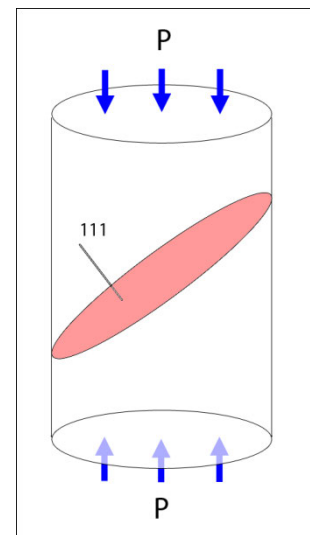


**dislocation nucleation**

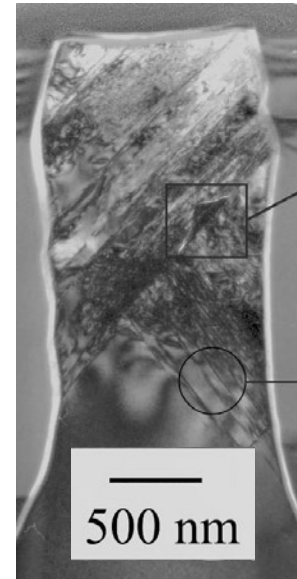


**dislocation propagation  
& creating of SF**

**stress is high enough to nucleate  
a partial dislocation  
and  
pillar diameter smaller as  
equilibrium distance of partial  
dislocations**



**dislocation reaches  
the surface**

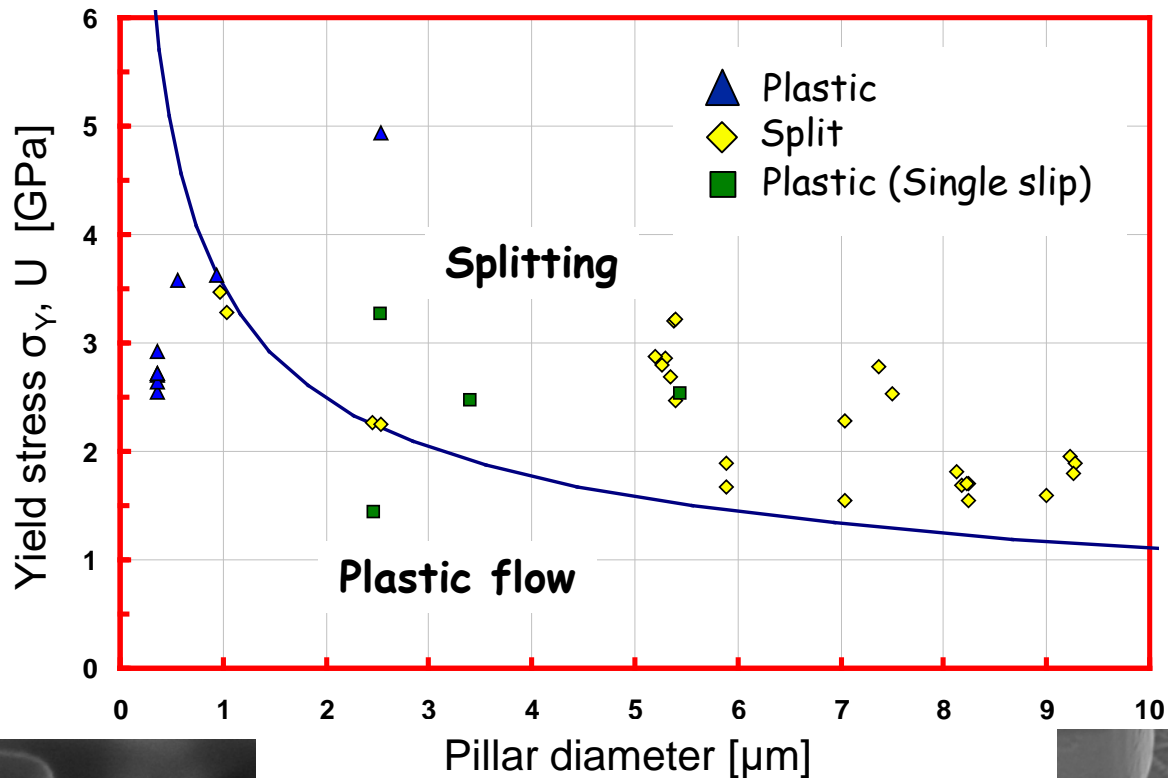


J. Michler, K. Wasmer, S. Meier, F. Oestlund, K. Leifer (2007). Appl. Phys. Lett. 90, 043123

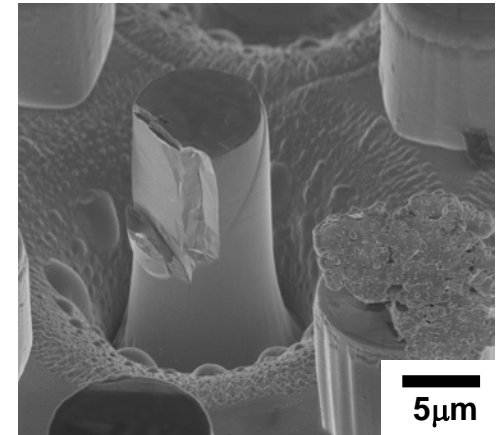
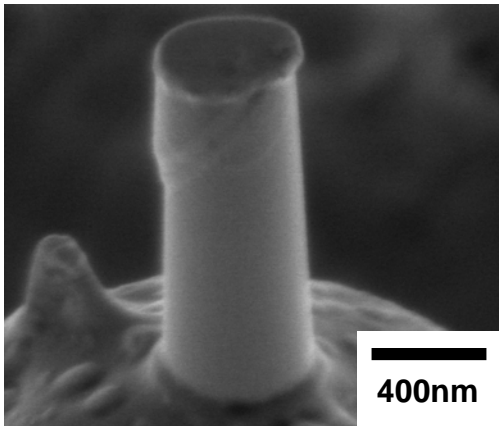
S. Wang, P. Pirouz (2008) Acta Mat. 55, 5500



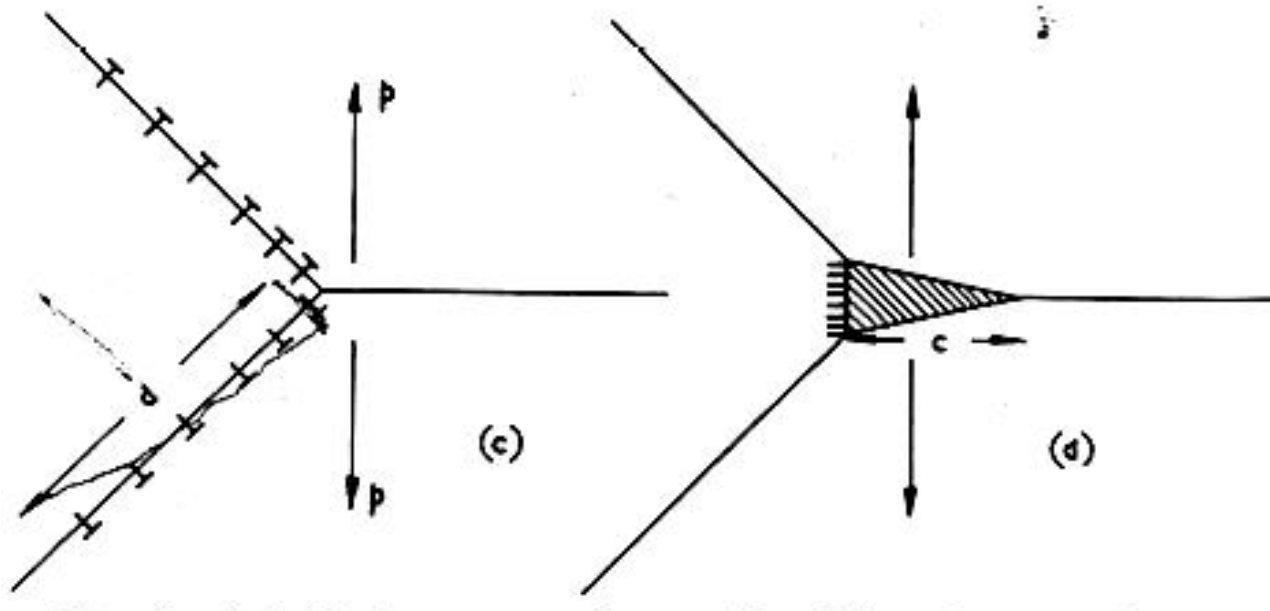
# Plasticity of GaAs in uniaxial compression



pillar orientation  $\langle 001 \rangle$   
aspect ratio 1:3

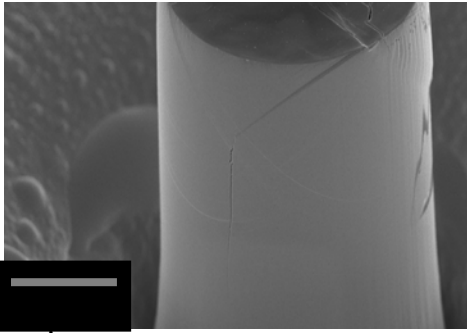


# compression splitting

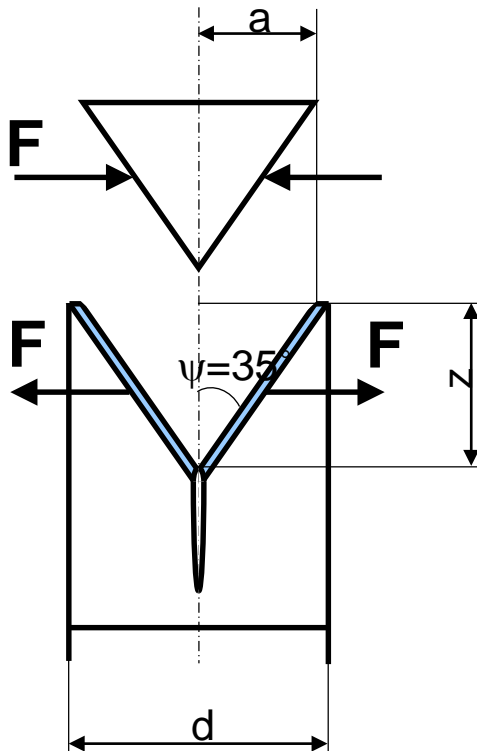


Cottrell, A.H., “Theory of brittle fracture in steel and similar metals”, *Trans. Metall. AIME* , **212** (1958), 192–203

# compression splitting

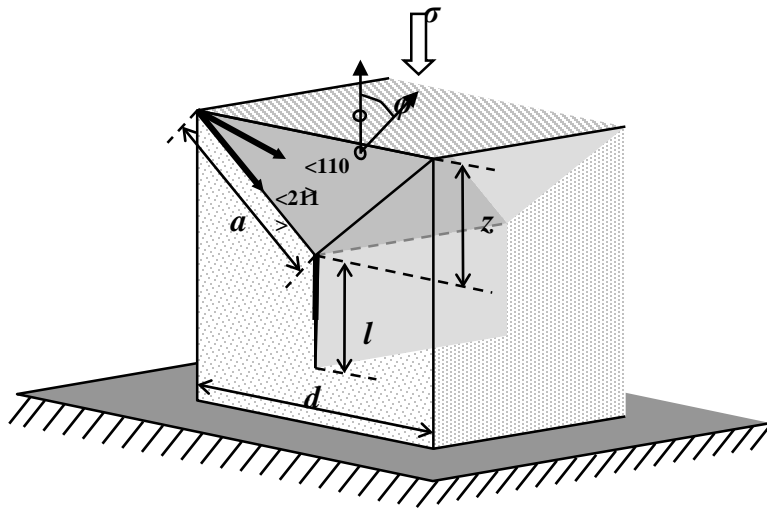


idea: cracking in larger pillars by the growth of a compression split nucleated at the intersection between the two glide bands in a pillar



$$K_I = \beta \frac{F}{[\frac{\pi}{2} (1+z)]^{1/2}}$$

# compression splitting



applied stress needed for splitting

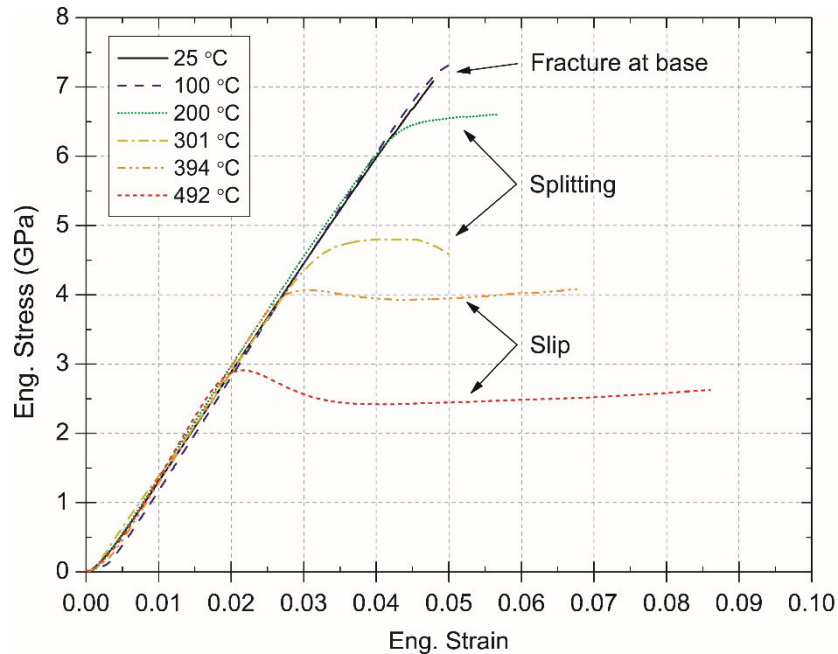
$$\sigma_s = \frac{K_{Ic}}{0.158 \beta \sqrt{d}}$$

critical diameter brittle - ductile transition  
with flow stress

$$d_{crit} = 40 \left[ \frac{K_{Ic}}{\beta \sigma_Y} \right]^2 \quad \sim 1 \mu m$$

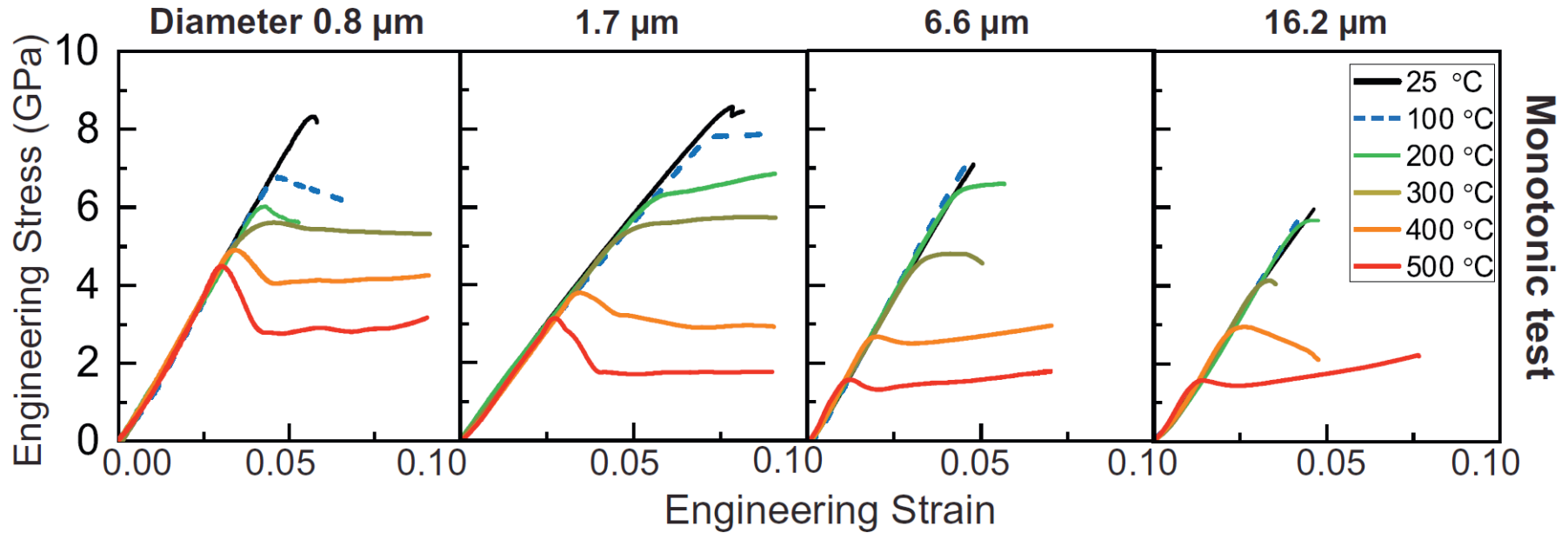
Oestlund et al (2010) Phil. Mag.

# temperature effect - silicon <001>



- Transitions between in deformation mechanisms between fracture, splitting, and plasticity directly observed.
- At a diameter of 6.7  $\mu\text{m}$ , the brittle-ductile transition is seen at  $\sim 400^\circ\text{C}$  – significantly lower than bulk silicon.
- Classic upper yield point consistent with dislocation nucleation observed during plastic deformation due to system's intrinsic displacement control.

# size and temperature effect - silicon <001>



strain rate of  $1 \times 10^{-3} \text{ s}^{-1}$ .

# strain rate effect - silicon <001> at 495°C



0.001/s



0.01/s



0.1/s



1/s



10/s



100/s



200/s

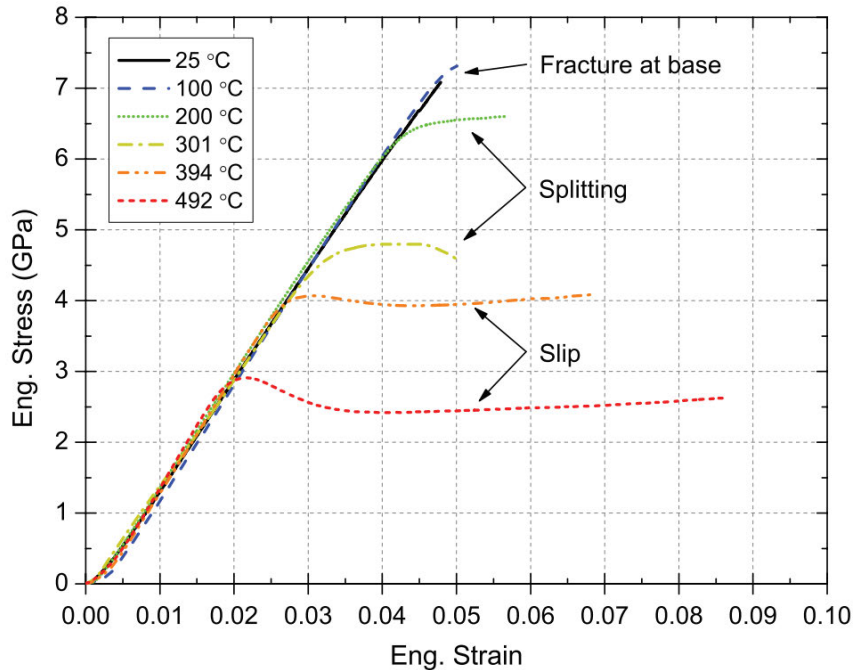


400/s



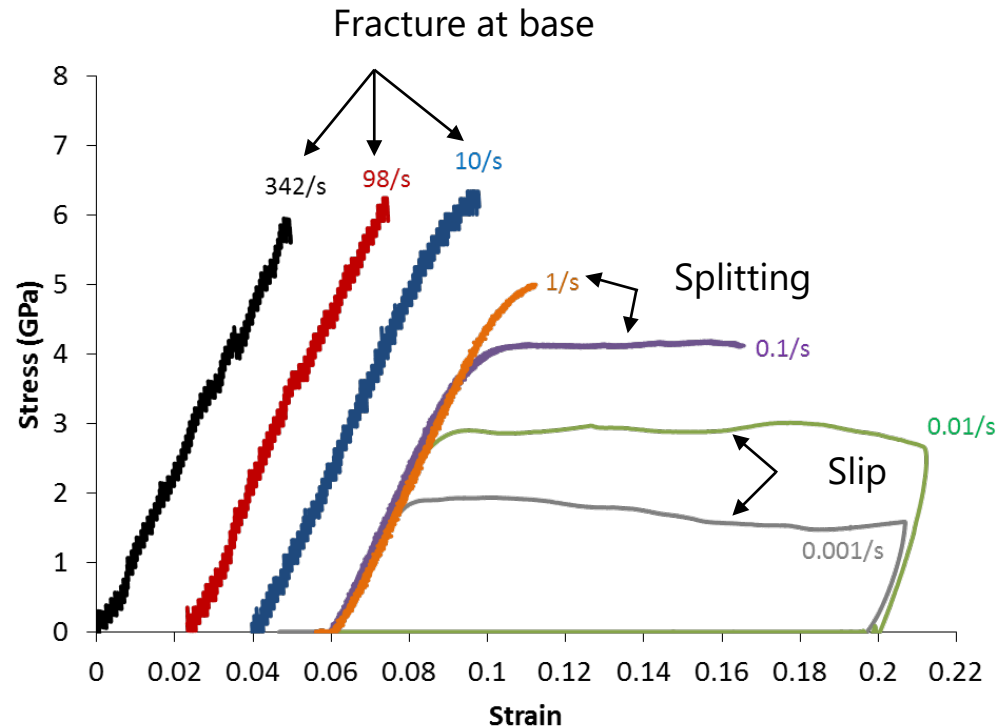
# strain rate vs temperature - silicon <001>

## Constant strain rate – 1e-3/s



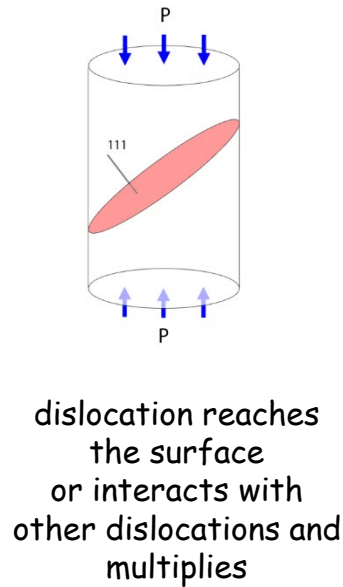
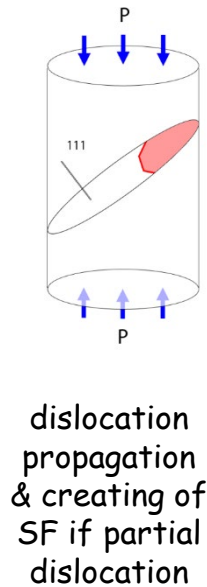
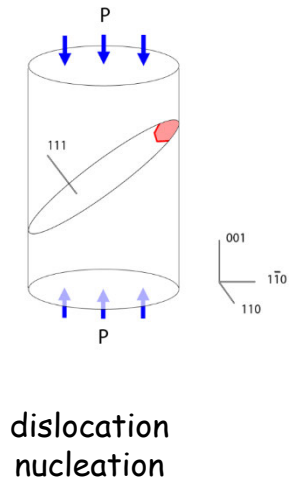
Wheeler et al., Rev. Sci. Ins. 2013.

## Constant Temperature – 495 °C

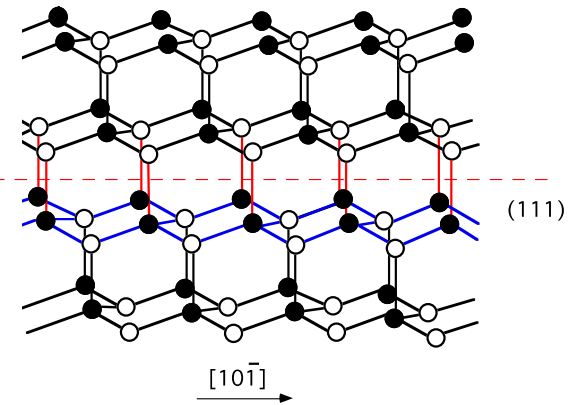


- 6.82 μm diameter

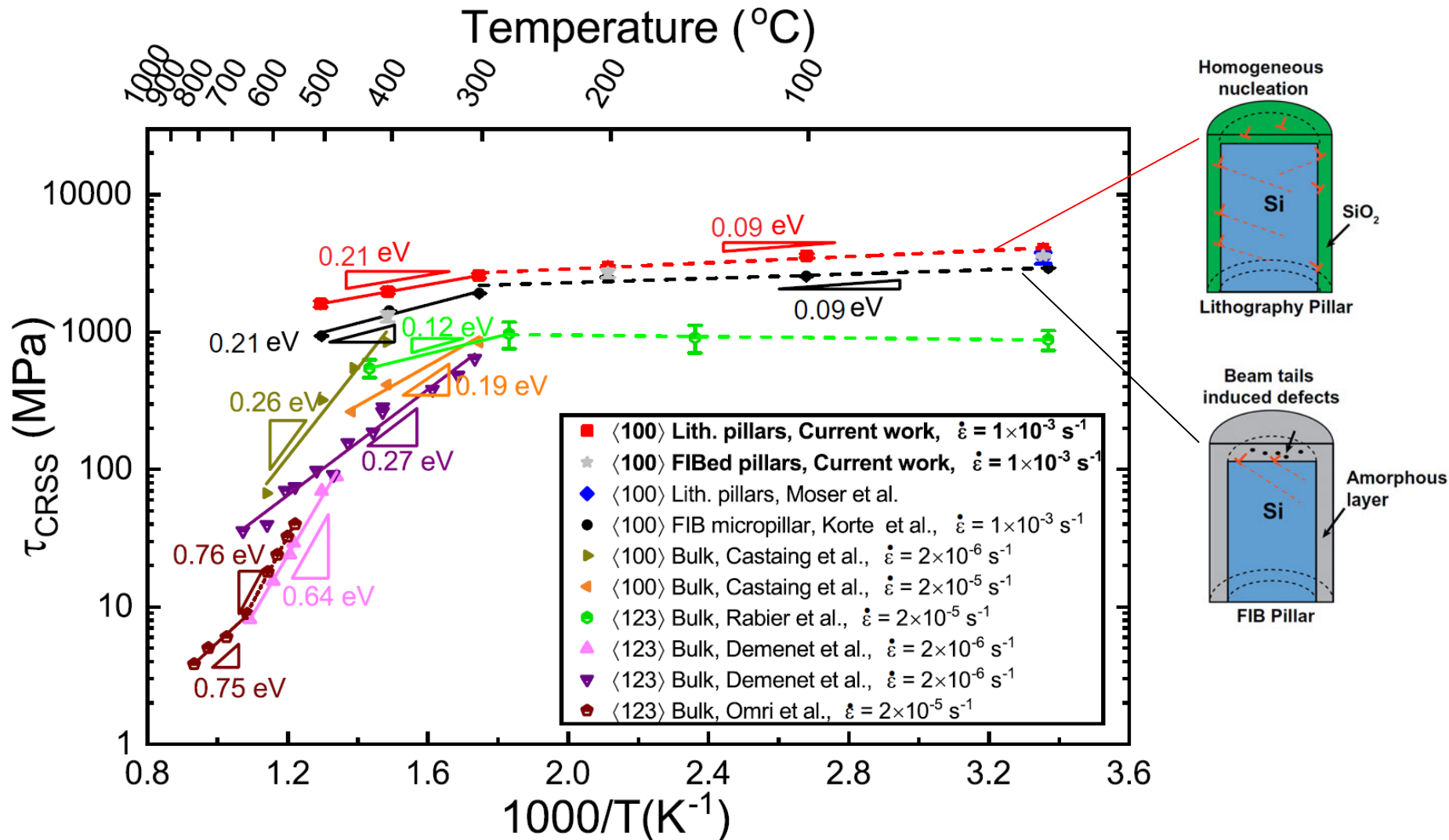
# silicon two types of dislocations



Perfect dislocations  
Dissociated dislocations

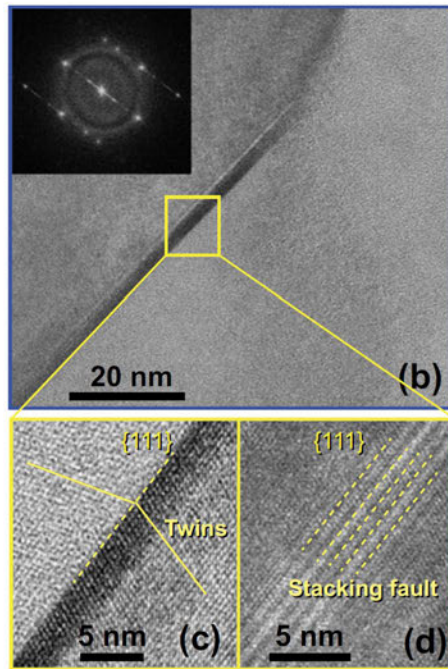


# activation parameters of silicon

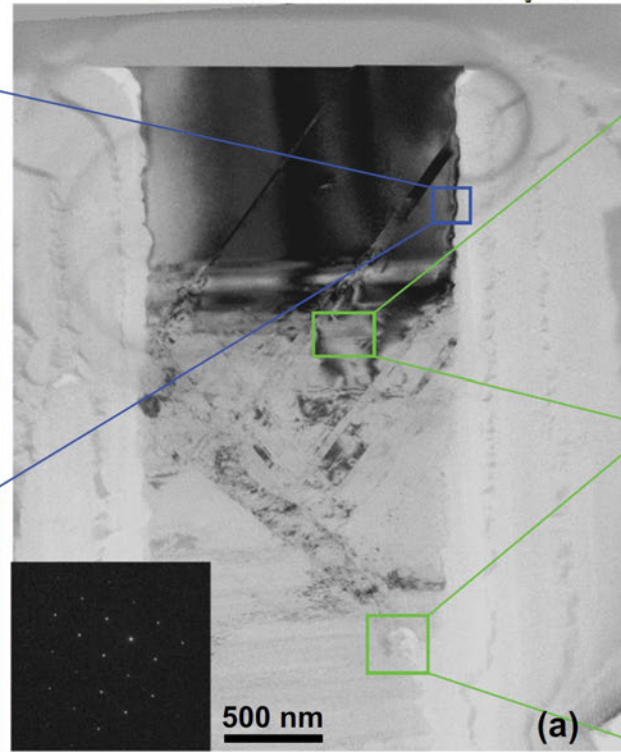


# change in deformation mechanism at 300°C

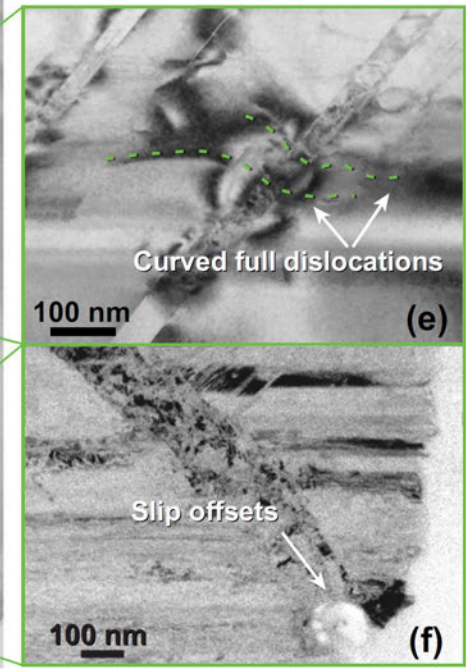
partial dislocations  $T > 300^\circ\text{C}$



Deformed at  $300^\circ\text{C}$   $D = 1.7 \mu\text{m}$

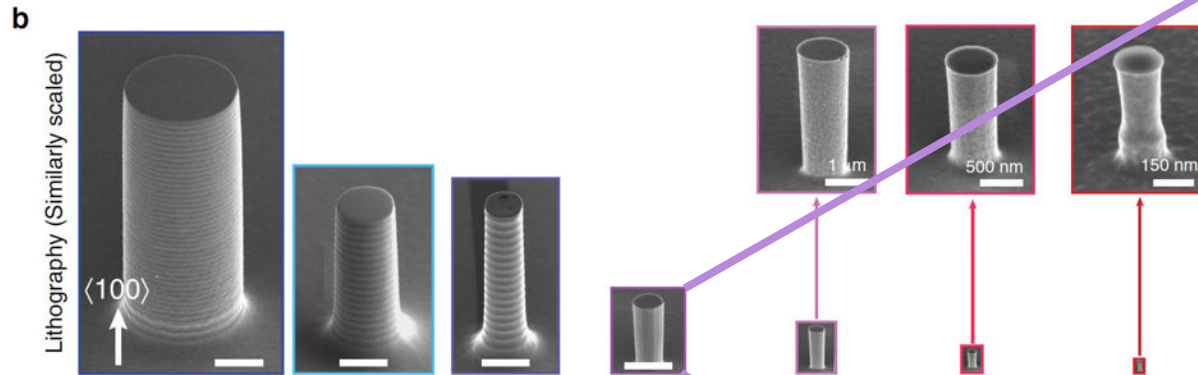
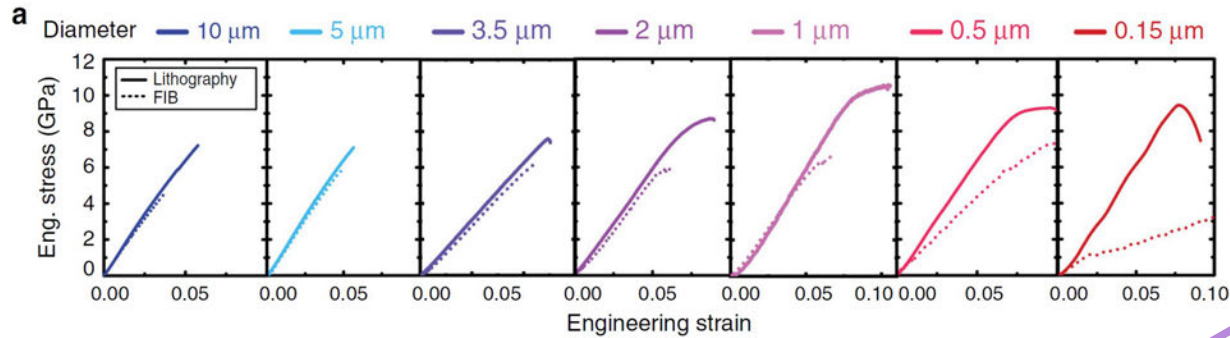


full dislocations  $T < 300^\circ\text{C}$

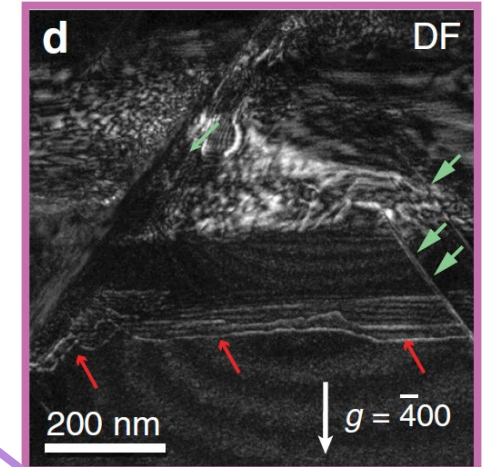
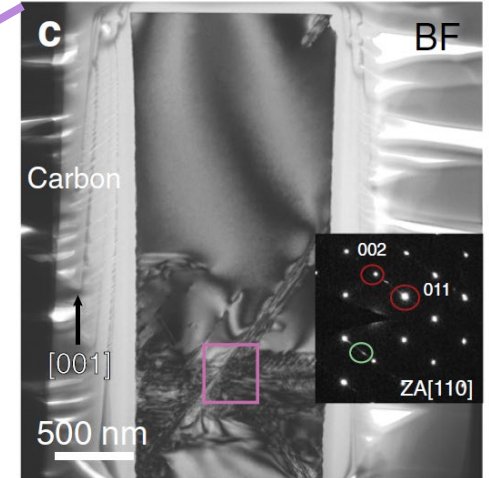


silicon  $\langle 001 \rangle$

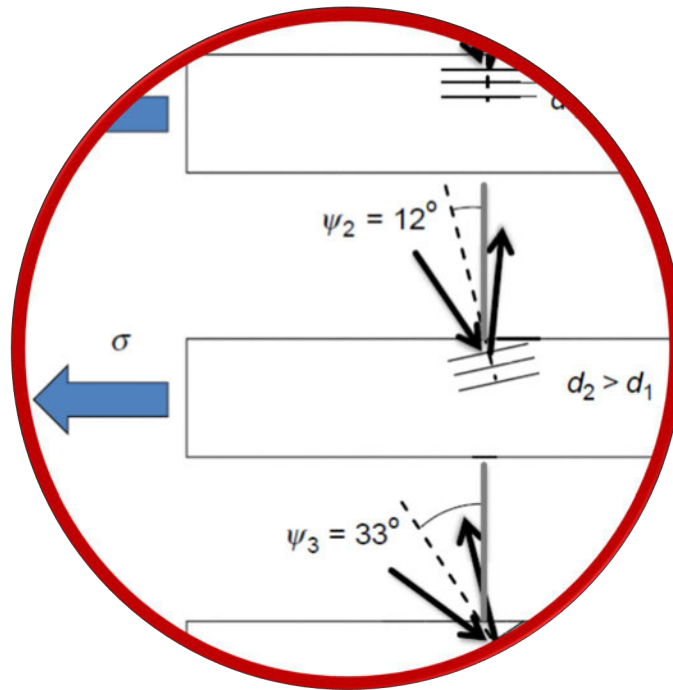
# surface defects - theoretical strength & ductility?



silicon  $\langle 001 \rangle$



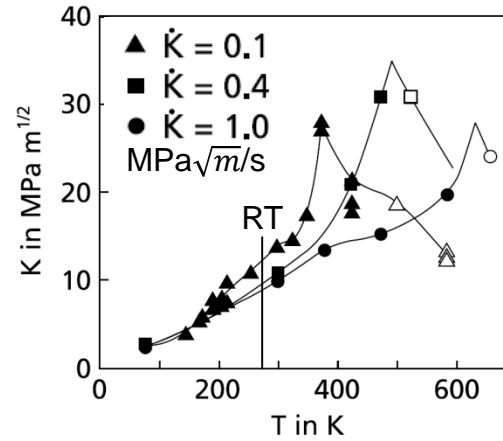
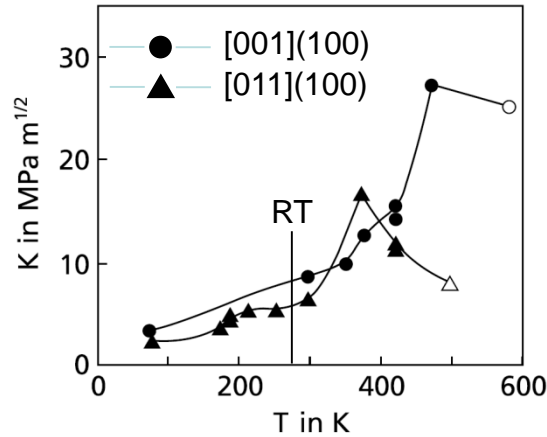
# Size effect in fracture behaviour



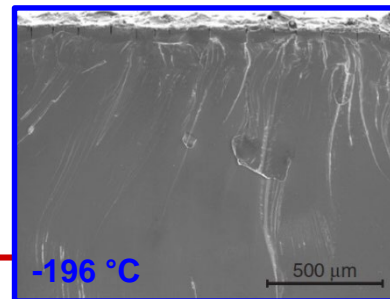
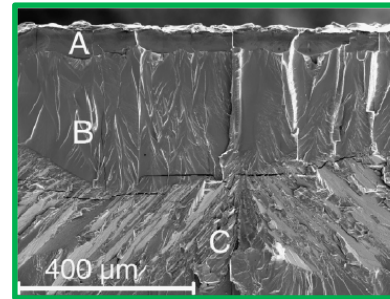
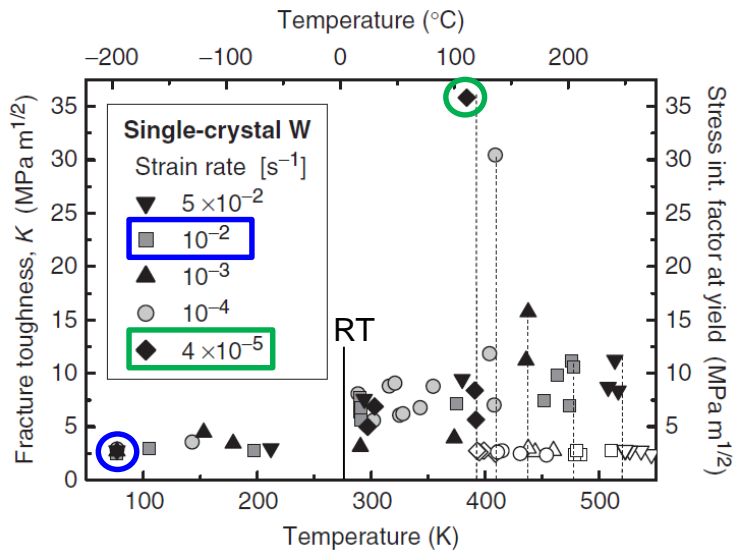


# The brittle-ductile transition (BDT)

BCC W single crystals:



- Continuous increase of  $K_{Ic}$  with  $T$
- BDT well above room temperature
- Fracture anisotropy: fracture plane and direction
- Loading rate dependency  
*Riedle et al., Phys. Rev. Lett., 1996*  
*Gumbsch et al., Science, 1998*

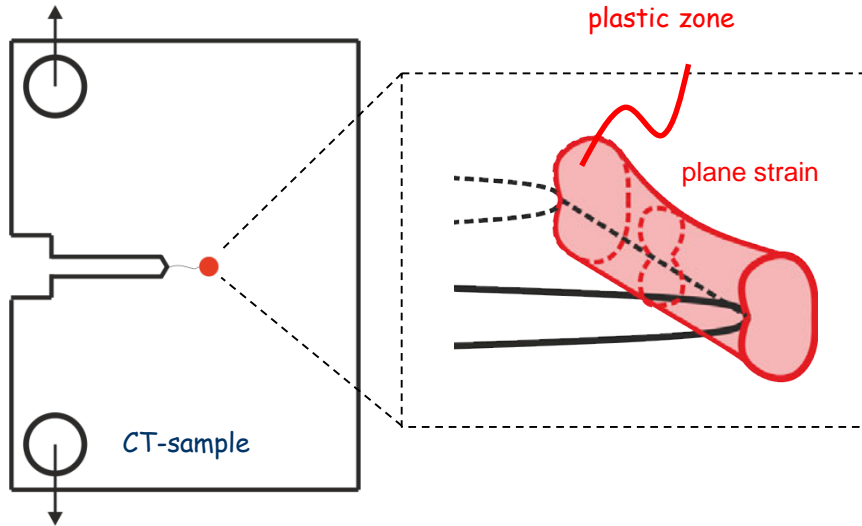


- Continuous increase of  $K_{Ic}$  with  $T$
- BDT well above room temperature
- Loading rate dependency
- Low loading rate (moderate  $T$ ):  
crack growth and final cleavage
- High loading rate (low  $T$ ):  
brittle cleavage

*Giannattasio and Roberts, Phil. Mag., 2007*

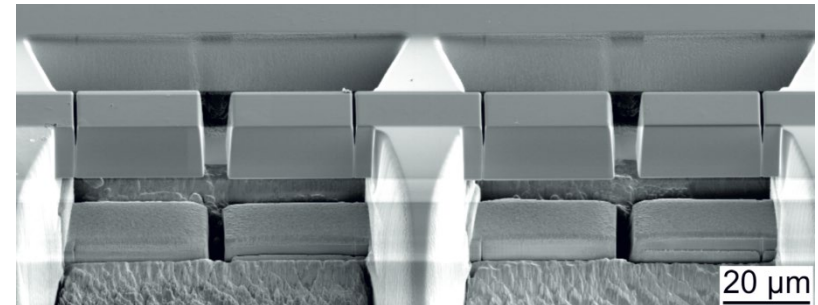
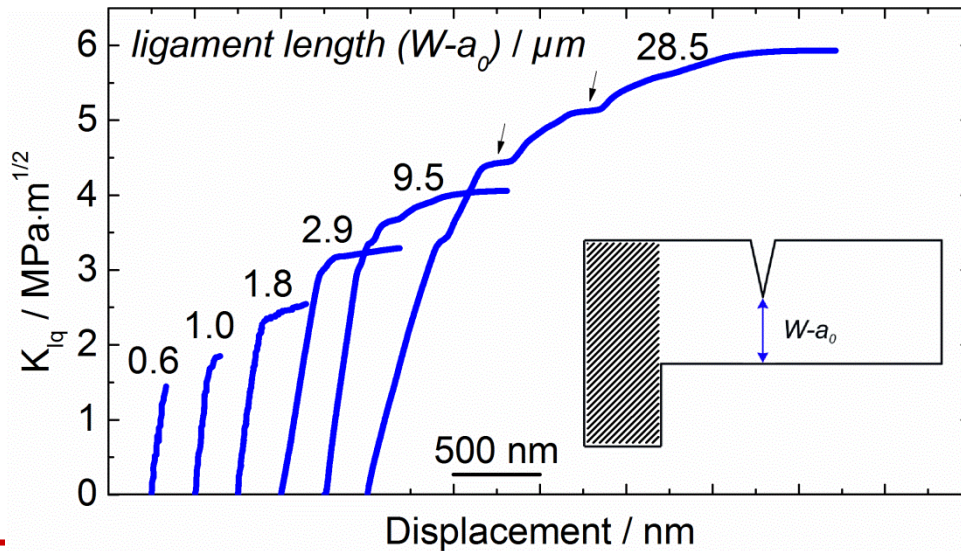


macro-scale



Estimation of the size of the plastic zone  $r_{pl}$  :

$$r_{pl, plane-strain} = \frac{1}{3\pi} \left( \frac{K_{Ic}}{\sigma_y} \right)^2$$

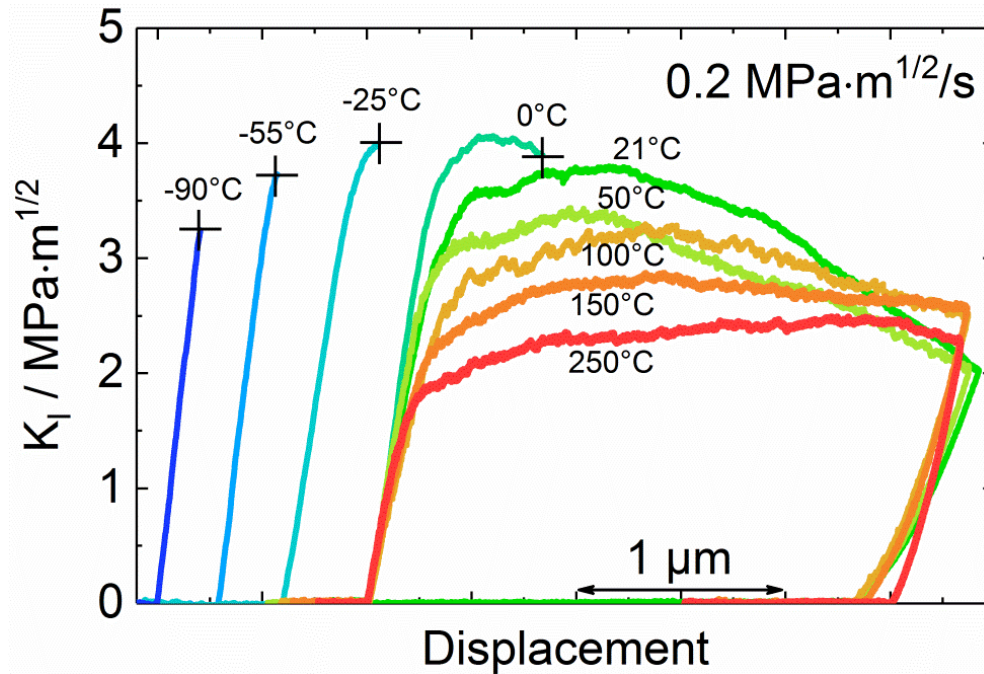


cantilevers in W ,  $\langle 100 \rangle \{100\}$  crack system

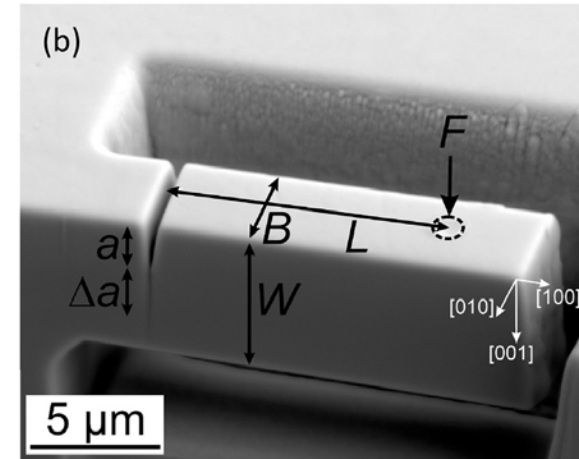
Ast et al., Acta Mater. 138, 2017

# Fracture testing from -90°C to 250°C Empa

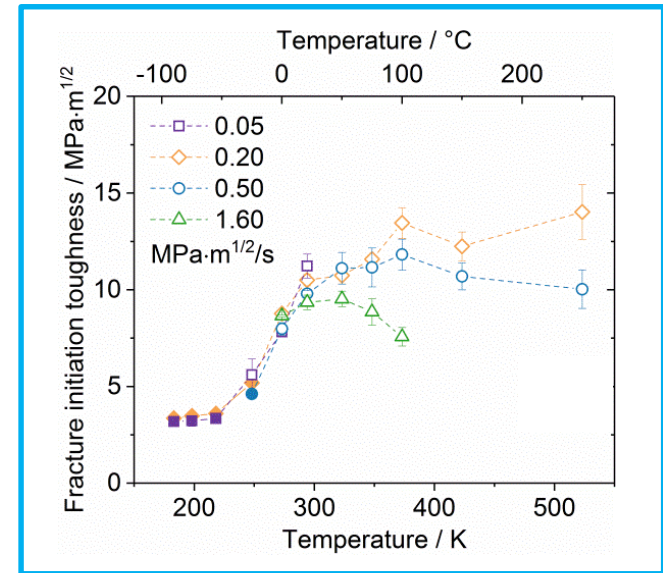
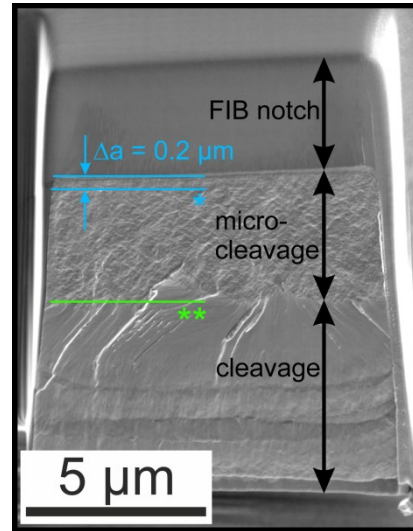
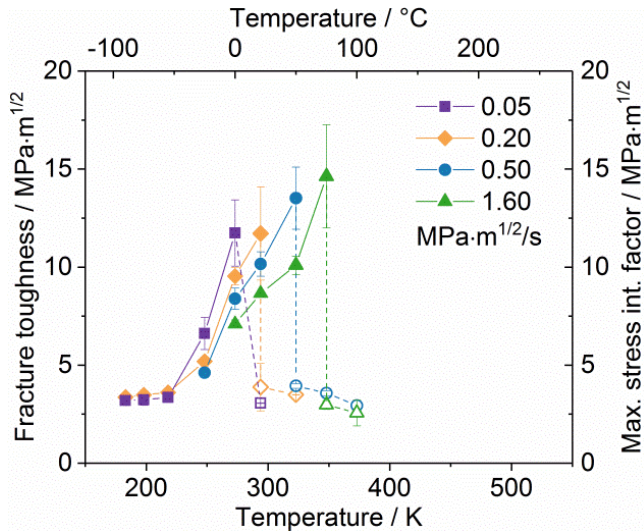
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$$K_I = \frac{F L}{B W^{3/2}} f(a/W)$$



- -90°C: purely brittle, cleavage fracture along {100} planes
- -55°C / -25°C: limited crack tip plasticity prior to cleavage
- 0°C: crack tip plasticity and finite stable crack growth prior to cleavage
- 21°C: crack tip plasticity and stable crack growth
- 150°C: stress intensity factor decreases, stable crack growth
- >250°C: enhanced crack tip plasticity, finite crack growth in final stage



## Cleavage Fracture toughness

- J-Integral determined at onset of cleavage
- Below -50 °C: no loading rate dependency
- Lower loading rate → sharper transition
- BDT is shifted to higher temperatures with higher loading rates

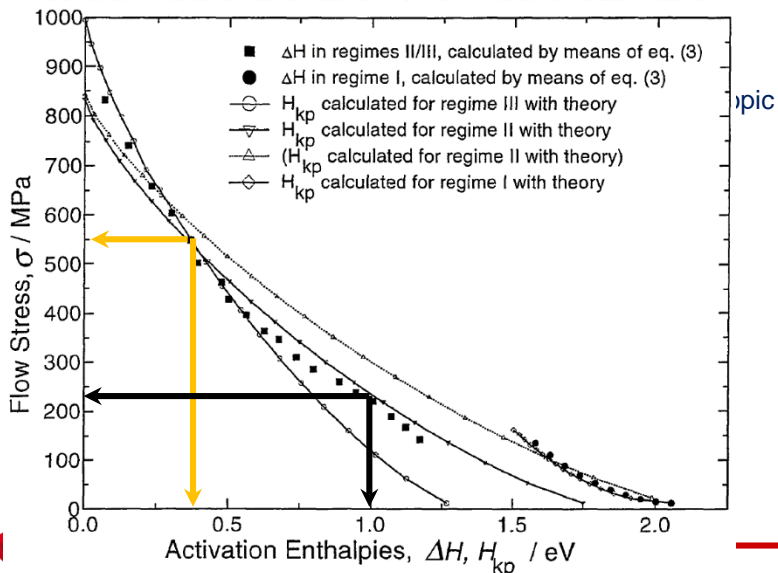
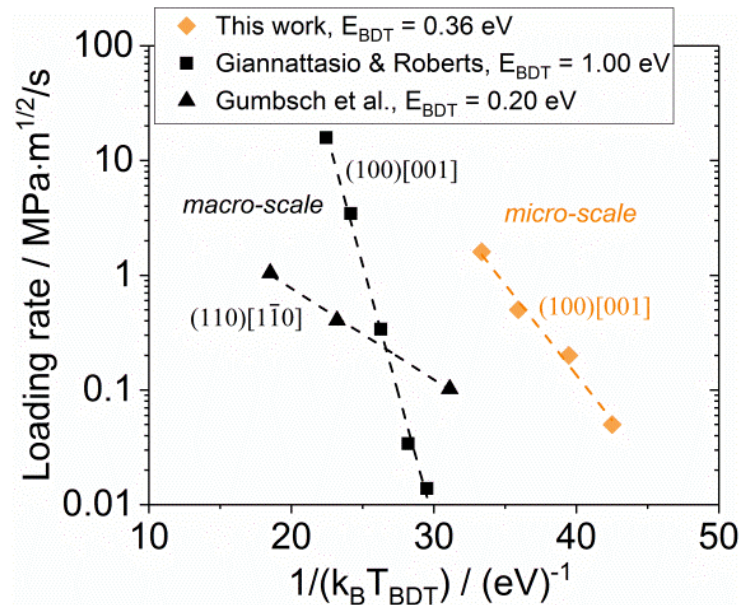
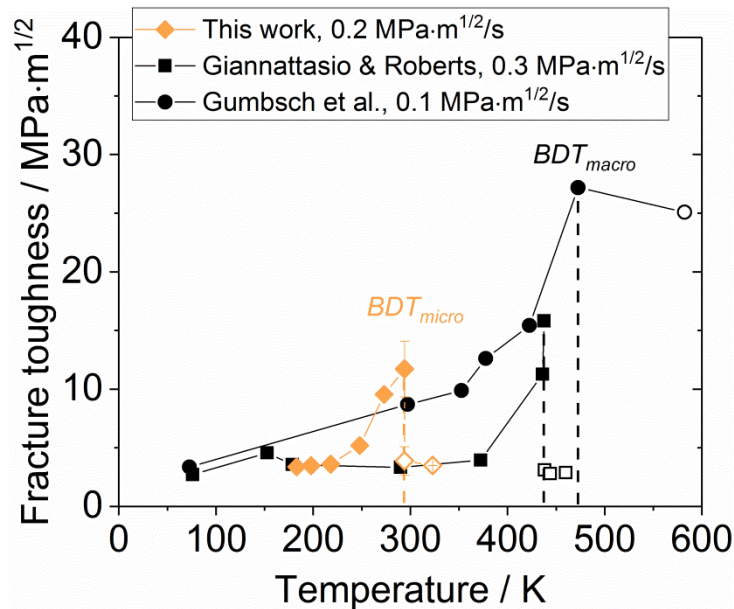
## Fracture initiation toughness

- J-Integral determined at  $\Delta a = 0.2 \mu\text{m}$
- Below room temperature → no loading rate dependency
- Above room temperature → loading rate dependency



# Comparison: micro- vs. macro-scale Empa

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- Arrhenius plot:  $\dot{K} \propto \exp\left(-\frac{E_{BDT}}{k_B T_{BDT}}\right)$
- Different crack systems
- Difference between macro- and micro-scale: 1.00 eV vs. 0.36 eV
- Kink-pair formation in the screw dislocation is **stress-assisted**

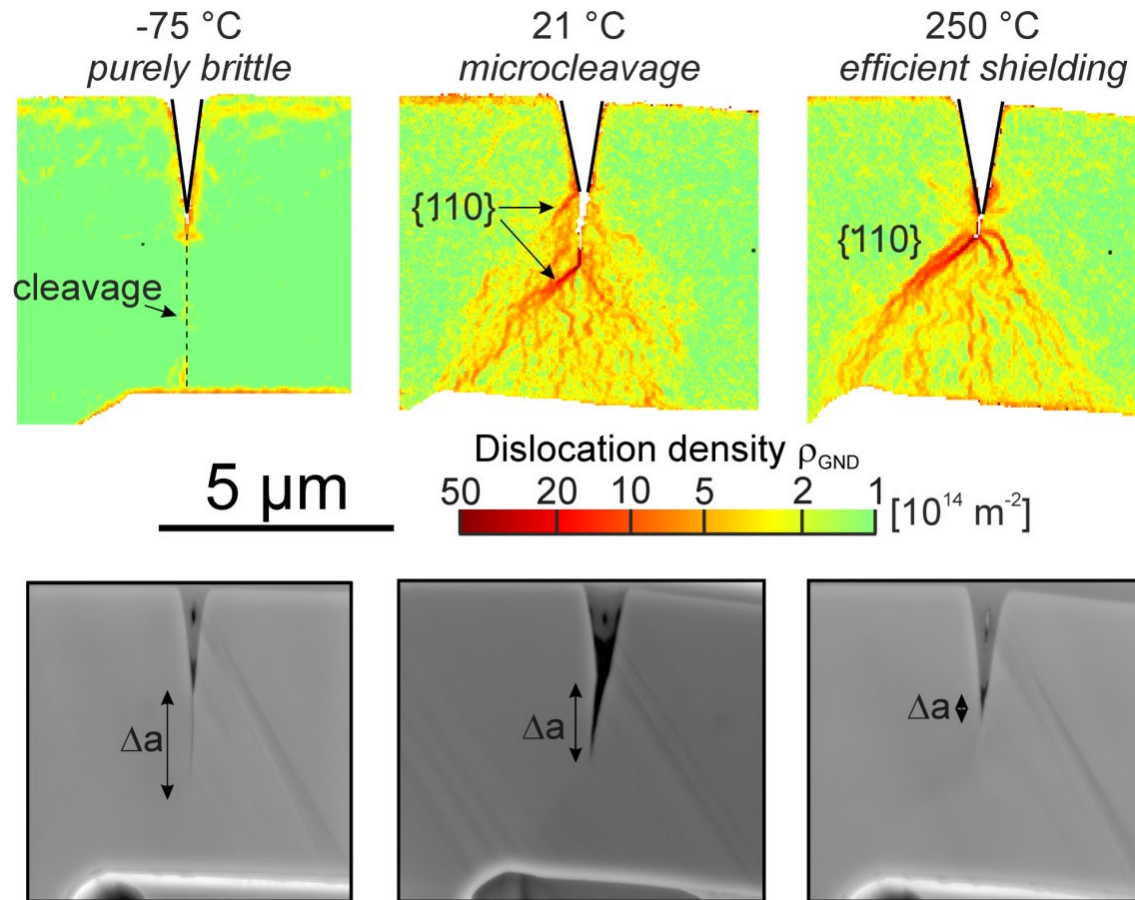
Giannattasio and Roberts, *Phil. Mag.*,  
2007

Gumbsch et al., *Science*, 1998

# HR-EBSD analysis

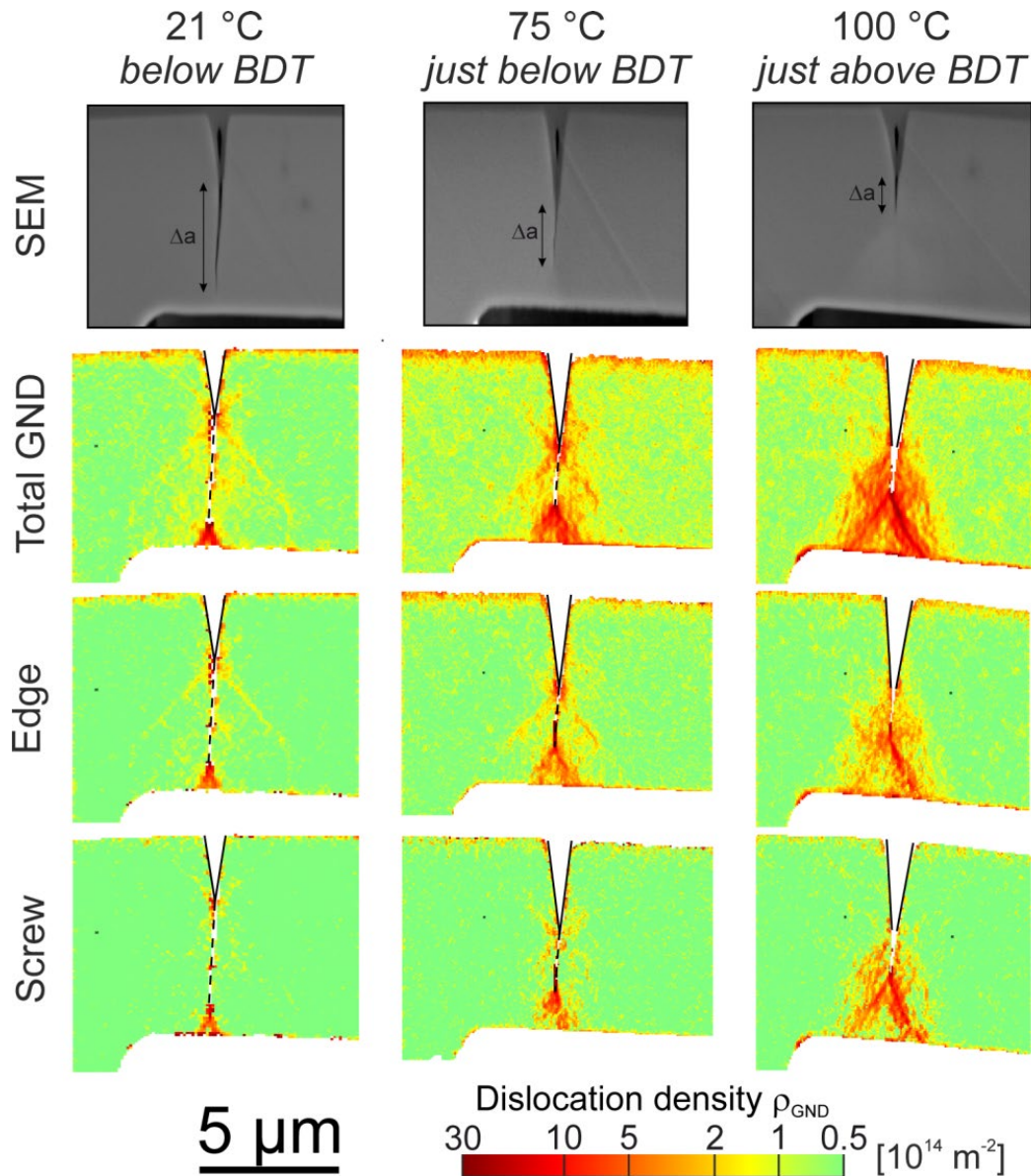
Cross-Correlation  
(CrossCourt4):  
GND density

SEM images:  
Cross-sections



- Total density of geometrically necessary dislocations (GND)
- Brittle cleavage at low, dislocation-controlled microcleavage at intermediate and crack tip shielding at high temperatures

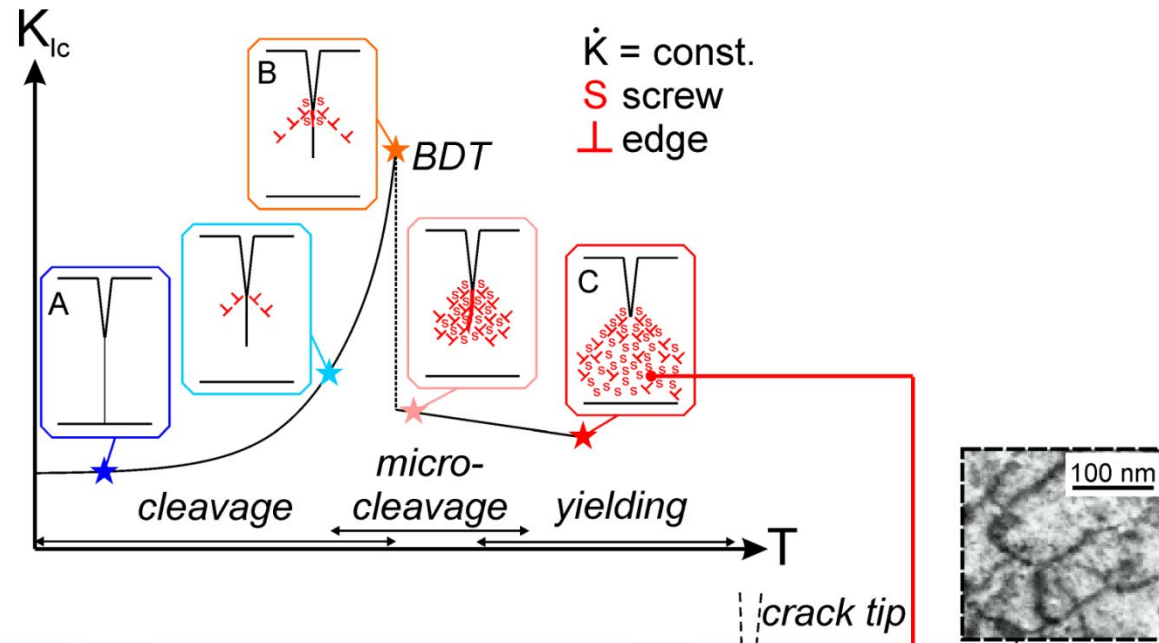
# HR-EBSD analysis at BDT



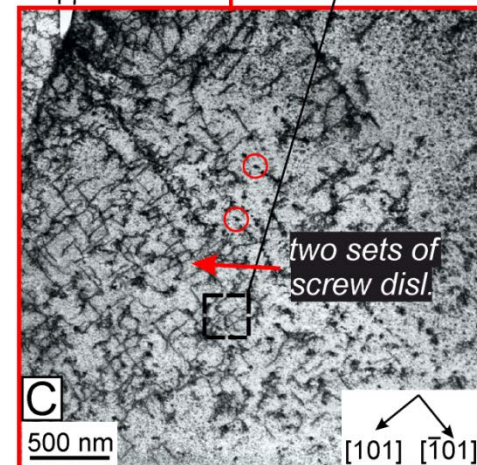
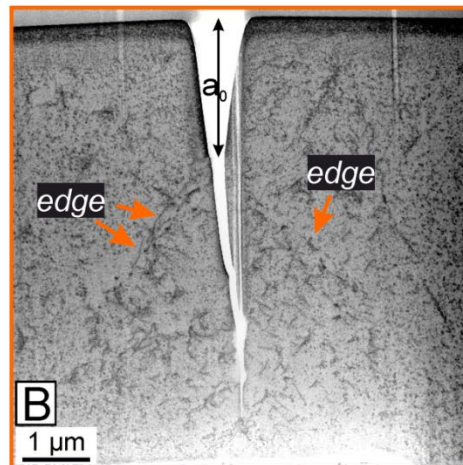
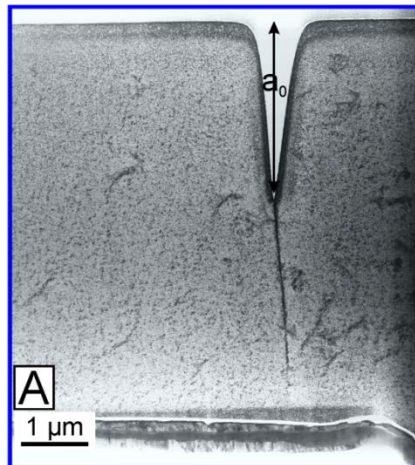
- Reduction of crack growth with temperature
- Increase of total GND density with temperature
- Edge dislocations: increase in  $K_{\text{Ic}}$  mainly below BDT
- Screw dislocation mobility: responsible for BDT transition



# Summary of micro-scale fracture behaviour

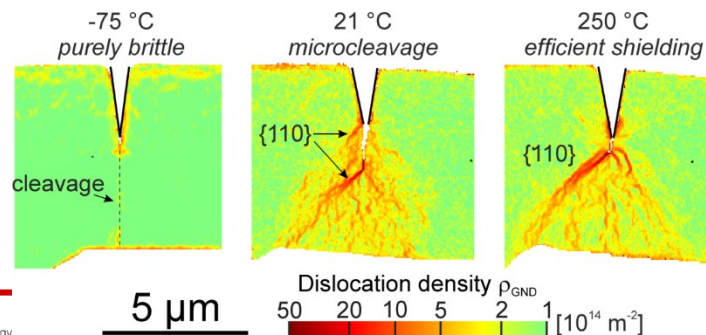
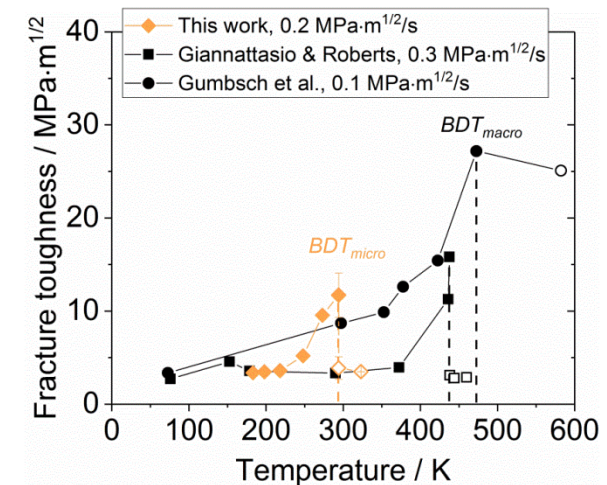
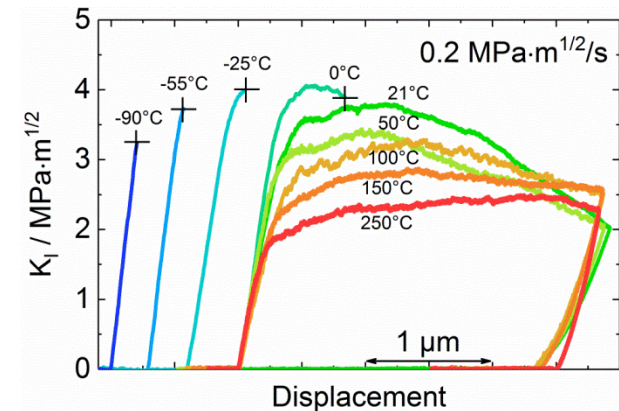


Bright-field STEM





- Fracture behaviour of W single crystals depends on:
  - specimen size
  - temperature and
  - loading rate
- Comparison to macroscopic samples:
  - brittle-ductile transition at lower temperatures
  - lower activation energy  $\rightarrow$  stress-assisted kink-pair formation (screw dislocations)
- HR-EBSD and STEM:
  - Transition: brittle  $\rightarrow$  semi-brittle  $\rightarrow$  plastic

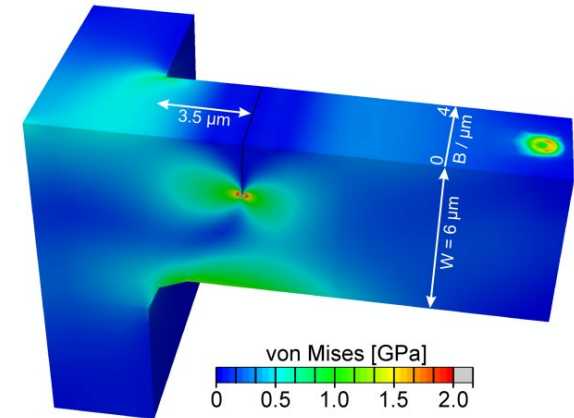
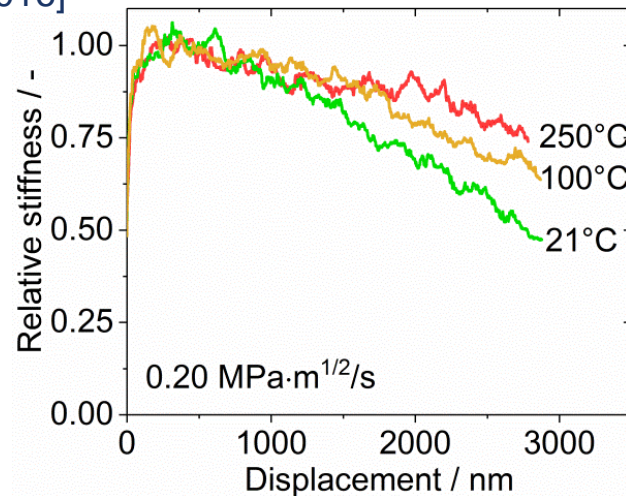
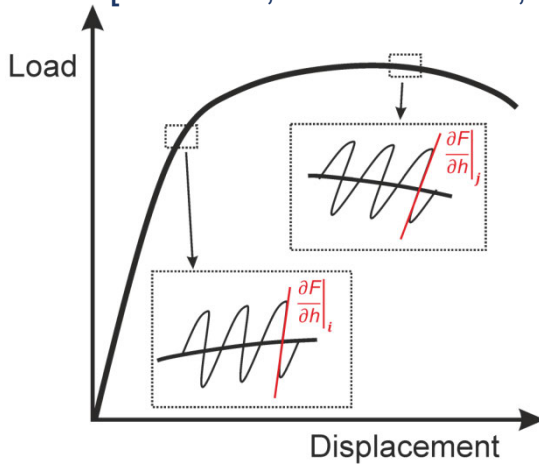


# R-curve behaviour: J-Integral technique



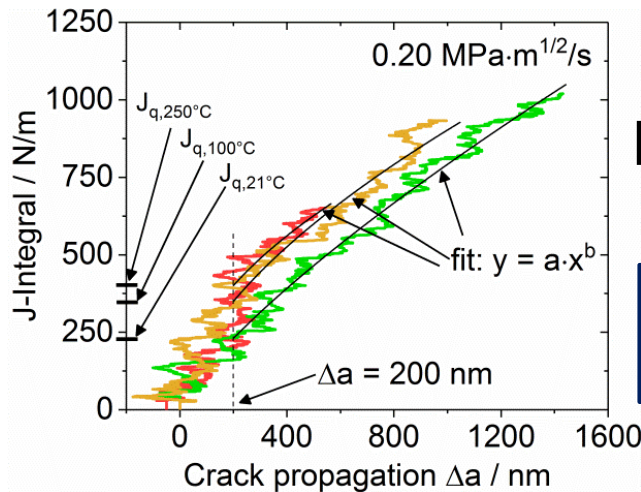
Materials Science and Technology

[Ast et al., *J. Mater. Res.*, 2016]



Continuous recording of specimen stiffness

FE model to correlate stiffness with crack length

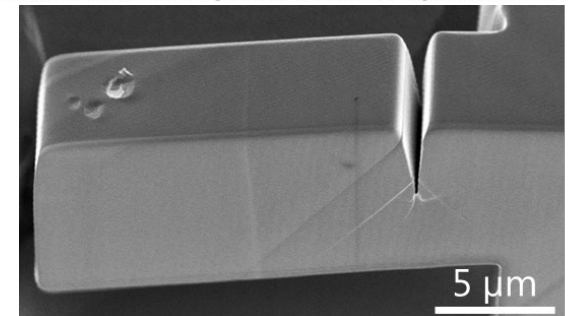
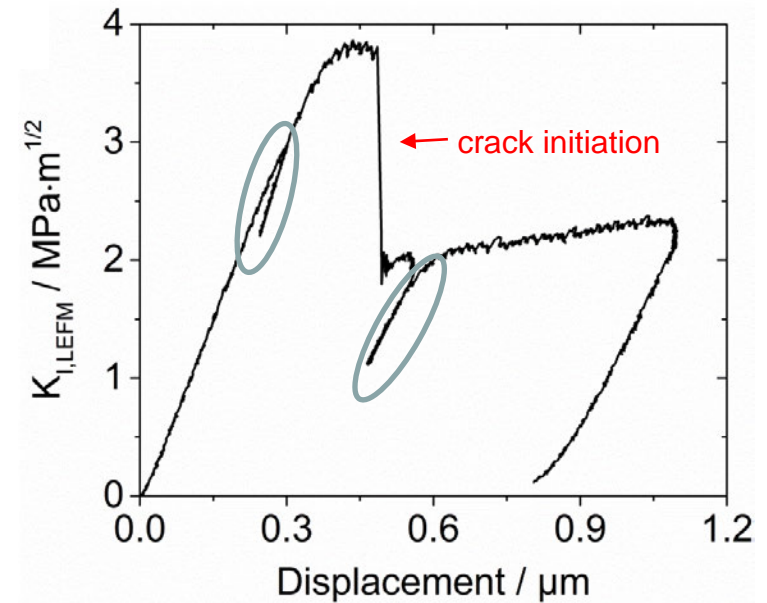
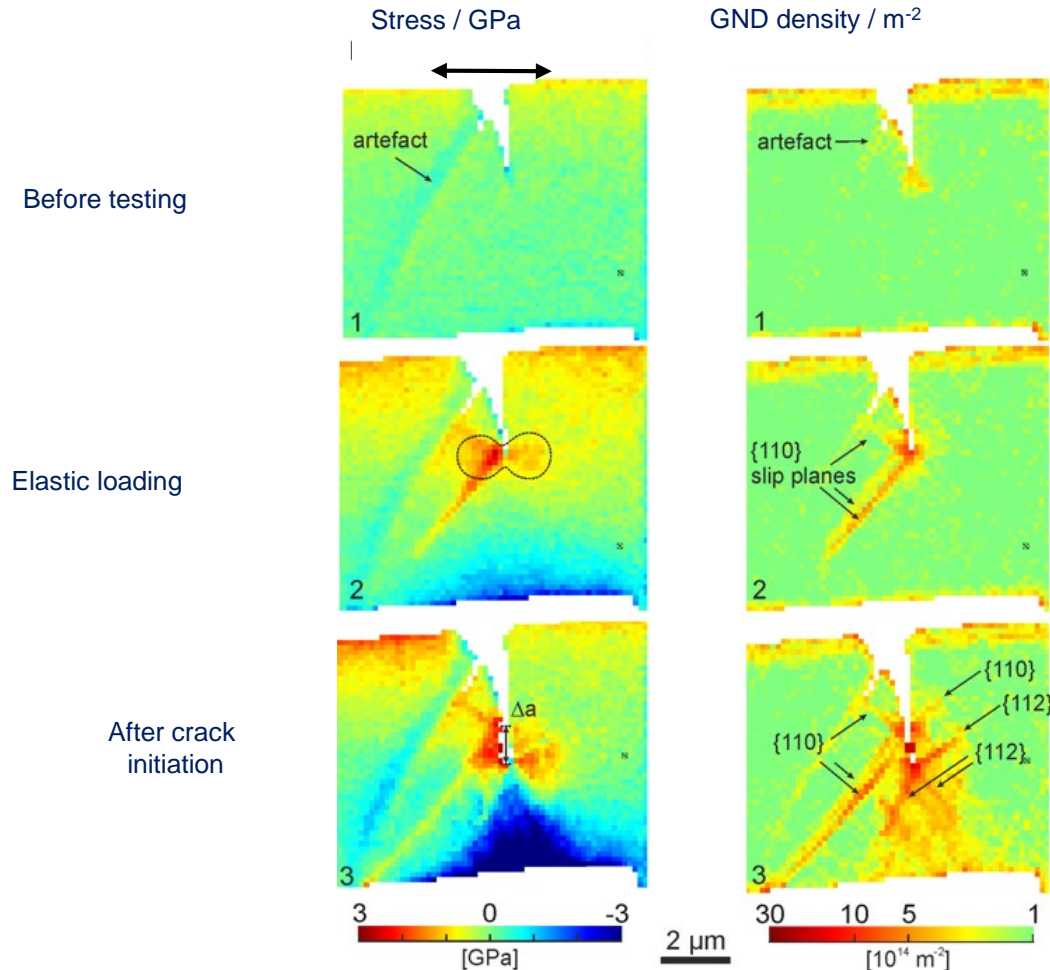


**R-curves:**

- Stable crack growth more significant at lower T
- Crack tip blunting more significant at higher T

$$J_{(i)} = \frac{(K_{Iq,(i)})^2 (1 - \nu^2)}{E} + \left[ J_{pl,(i-1)} + \frac{\eta (A_{pl,(i)} - A_{pl,(i-1)})}{B(W - a_{(i-1)})} \right] \left[ 1 - \frac{a_{(i)} - a_{(i-1)}}{(W - a_{(i-1)})} \right]$$

ASTM standard E 1820

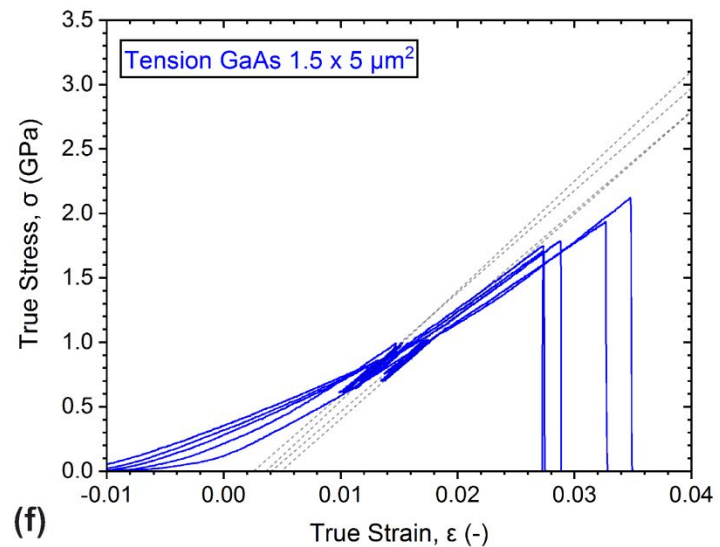
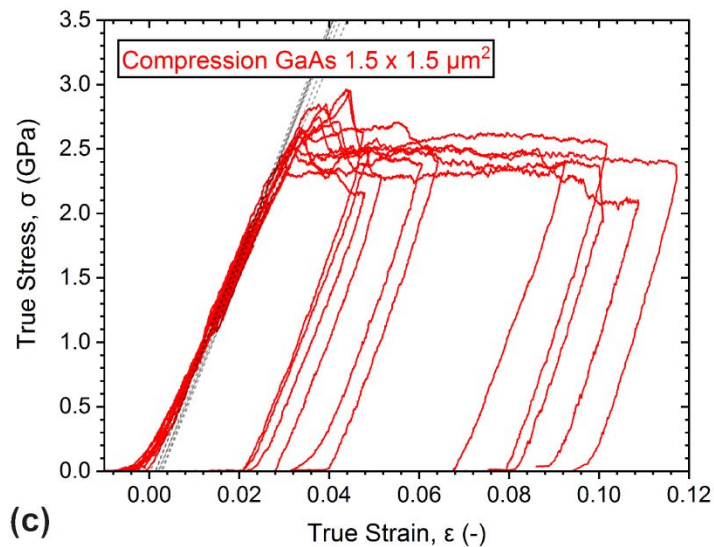
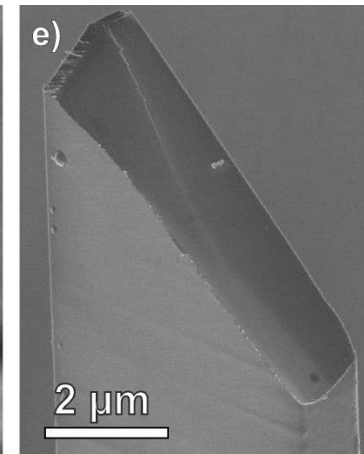
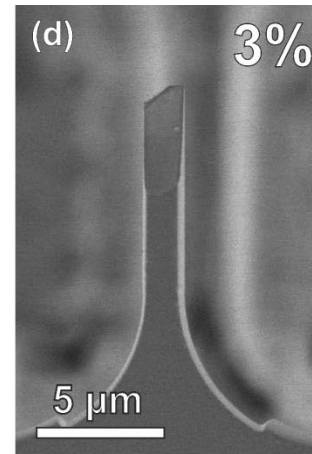
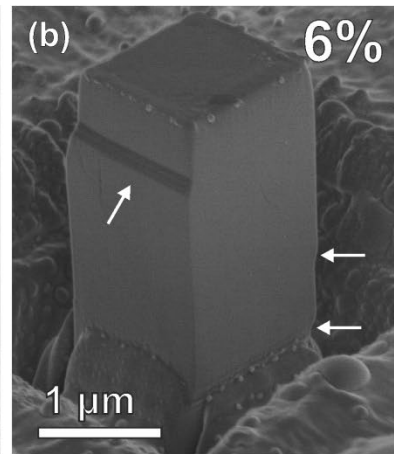
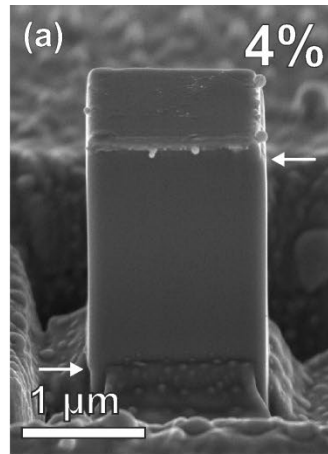


cantilever after testing

- Elastic regime: neutral axis separates tensile stresses at crack tip from compressive stresses at the lower free surface
- "Plastic zone" strongly depending on activated slip systems and not isotropic

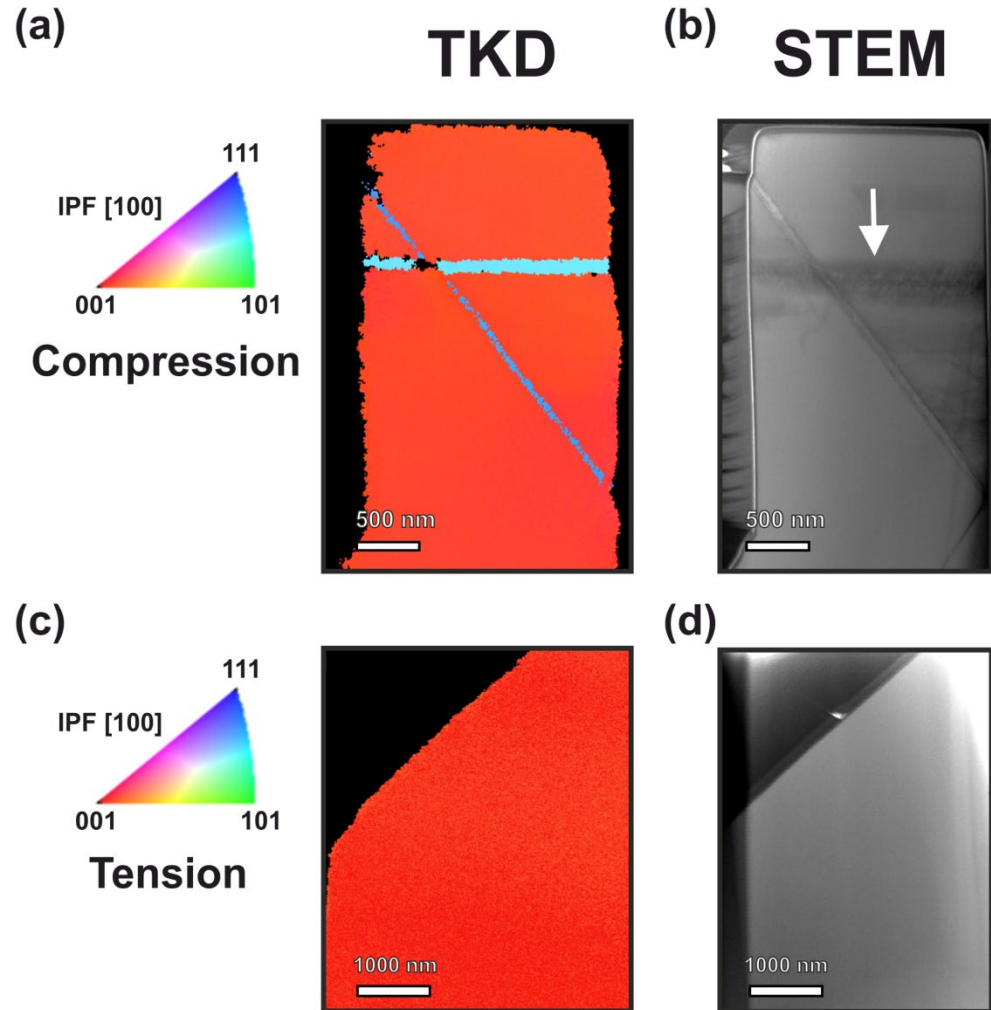


# Plasticity and fracture - loading mode dependence



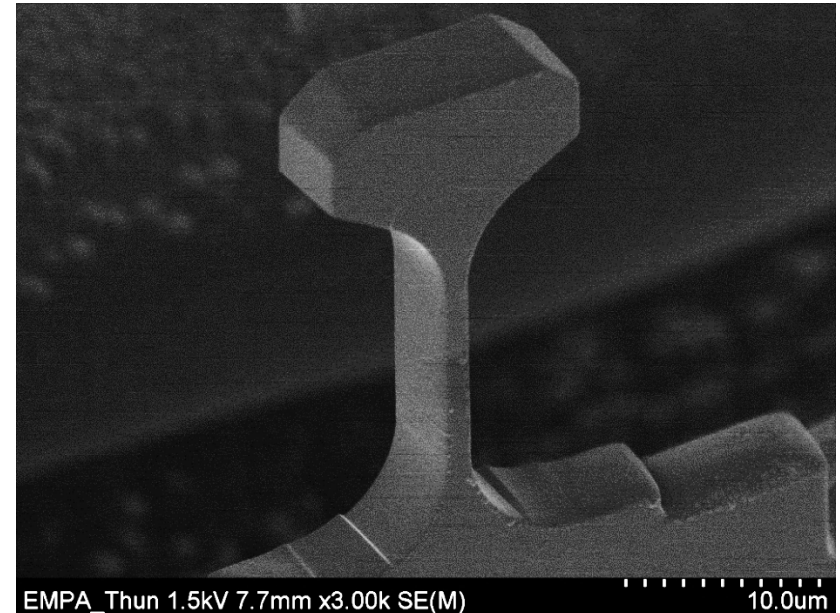
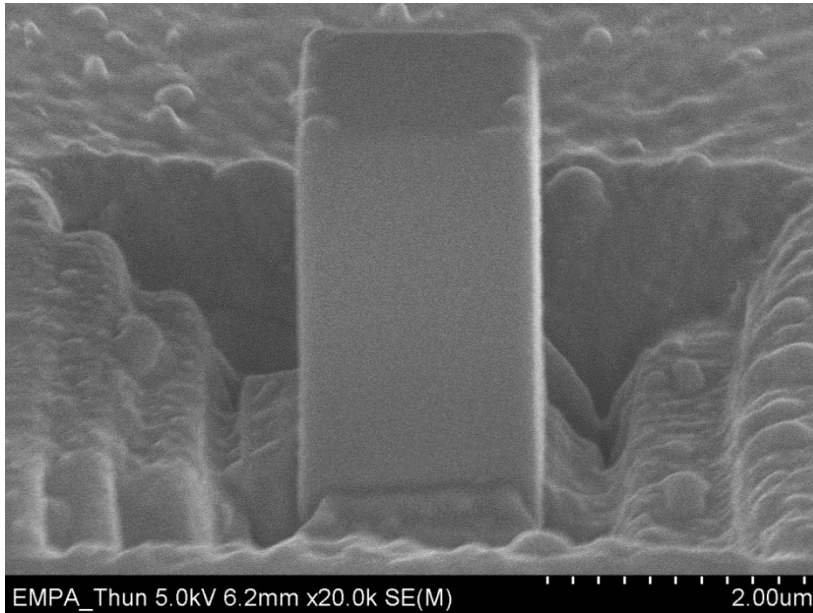
# Plasticity and fracture - loading mode dependence

- Specimen sharing a common thinnest dimension of  $1.70 \pm 0.19 \mu\text{m}$ .
- GaAs tested along the [001] crystallographic orientation.
- Brittle-to-ductile transition under uniaxial compression (between  $1.7 \mu\text{m}$  and  $2.3 \mu\text{m}$ ).
- Brittle failure in tension (no dislocations activity).
- Twin formation in compression.



# GaAs micropillar dimensions

- **Square pillars**  $1.5 \times 1.5 \mu\text{m}$  ( $N = 11$ )
  - **Side** =  $1.72 \pm 0.18 \mu\text{m}$
  - **Height** =  $3.49 \pm 0.18 \mu\text{m}$
  - **Geometry factor** =  $2.05 \pm 0.28$
- **Rectangular** tensile samples  $1.5 \times 5 \mu\text{m}$  ( $N = 6$ )
  - **Width** =  $1.67 \pm 0.23 \mu\text{m}$
  - **Thickness** =  $5.34 \pm 0.23 \mu\text{m}$



**Thinness effect:** thin structures exhibit the same enhanced yield strength regardless of total size volume or surface to volume ratio

N.M. Jennet et al. *Appl Phys Lett* 20098

# Mechanical data

- Compression-tension strength asymmetry by a factor of 1.4.
- Same elastic modulus for the [001] crystallographic orientation.
- Plasticity in compression while brittle failure in tension.

Test	Strength, $\sigma^{\max}$ (GPa)	Elastic modulus, E (GPa)	Post-yield
Compression	$2.61 \pm 0.14$ (N=11)	$86.5 \pm 3.1$ (N=4)	Plasticity
Tension	$1.86 \pm 0.17$ (N=6)	$81.4 \pm 4.6$ (N=6)	Fragile
Factor	1.4	1.06	NA